



# THE DATASHEET OF LTC2949HLXE#3ZZPBF

# Current, Voltage, and Charge Monitor for High Voltage Battery Packs

## FEATURES

- Measures Battery Stack Voltage, Current and Power
- Indicates Accumulated Battery Charge and Energy
- 20-Bit Current Measurement with  $<1\mu\text{V}$  Offset
- Built-In Isolated isoSPI™ or SPI Interface
- LTC68xx/ADBMS68xx Compatible, Supports Synchronous Measurements with Cell Monitors
- Up to 12 Buffered Voltage Measurement Inputs
- Up to 5 GPIOs, Configurable to Drive Ground, Supply or Toggling at 400kHz
- High or Low Side Current Sense
- 0.3% Current and Voltage Accuracy
- 1% Energy and Charge Accuracy
- True Average ADCs
- I<sup>2</sup>C EEPROM Interface to Store Board Calibration Factors
- Threshold Registers for all Measured Quantities
- Engineered for ISO26262 Compliant Systems
- Open Wire Detection on Input Pins
- Available in 48-Lead LQFP Package
- AEC-Q100 Qualified for Automotive Applications

## APPLICATIONS

- Electric and Hybrid Vehicles
- Isolated Current Sensing
- Backup Battery Systems
- High Power Portable Equipment

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## DESCRIPTION

The **LTC®2949** is a high precision current, voltage, temperature, charge and energy meter for electrical and hybrid vehicles and other isolated current sense applications. It infers charge and energy flowing in and out of the battery pack by monitoring simultaneously the voltage drop over up to two sense resistors and the battery pack voltage.

Low offset  $\Delta\Sigma$  ADCs ensure accurate measurement of voltage and current with insignificant power loss. Continuous integration of current and power ensures lossless tracking of charge and energy delivered or received by the battery pack.

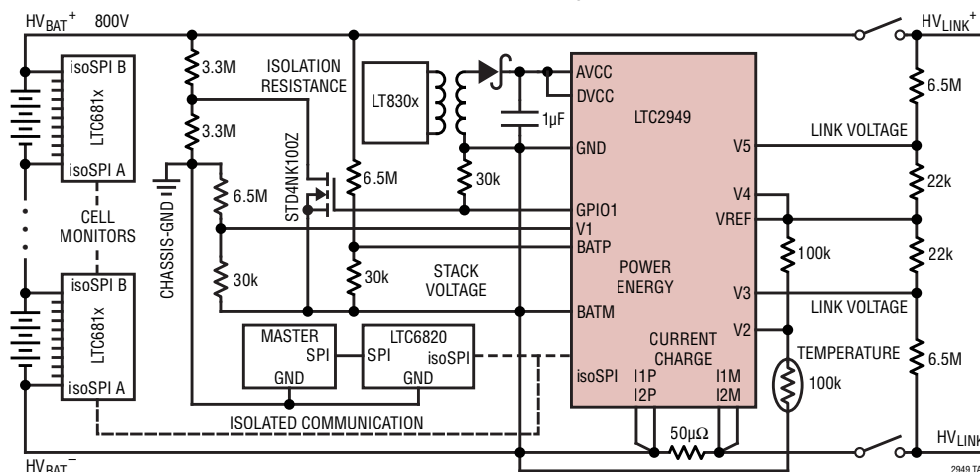
The built-in serial interface can be configured to support isolated isoSPI communication to the host or as SPI interface.

The LTC2949 features 12 internally buffered high impedance inputs (V1 to V12) for measuring voltages from external sensors or resistor dividers allowing to measure temperatures, HV-Link voltages, chassis isolation and supervise contactor states. LTC2949 has up to five programmable digital outputs which can be set to ground, supply or toggling at 400kHz.

Programmable threshold and tracking registers reduce digital traffic to the host.

## TYPICAL APPLICATION

**Electric Vehicle Battery Meter**



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## ABSOLUTE MAXIMUM RATINGS

(Notes 1, 2)

### Supply Pins

|              |                |
|--------------|----------------|
| AVCC to AGND | –0.3V to 14.5V |
| DVCC to DGND | –0.3V to 14.5V |
| AVCC to DVCC | –0.1V to 0.1V  |
| DGND to AGND | –0.1V to 0.1V  |

### Analog Pins

|                        |                            |
|------------------------|----------------------------|
| I1P, I1M, I2P, I2M     | –0.3V to $V_{AVCC} + 0.3V$ |
| I1P to I1M, I2P to I2M | $\pm 1V$                   |
| VBATP, VBATM           | –0.3V to $V_{AVCC} + 0.3V$ |
| V1-V12                 | –0.3V to $V_{AVCC} + 0.3V$ |
| CLKO, DNC              | (Note 3)                   |

### Digital Input/Output Pins

|                               |                |
|-------------------------------|----------------|
| IOVCC, CLKI, CSB(IM), SCK(IP) | –0.3V to 5V    |
| SDI (ICMP), SDO (IBIAS)       | –0.3V to 5V    |
| SDA, SCL                      | –0.3V to 2.75V |

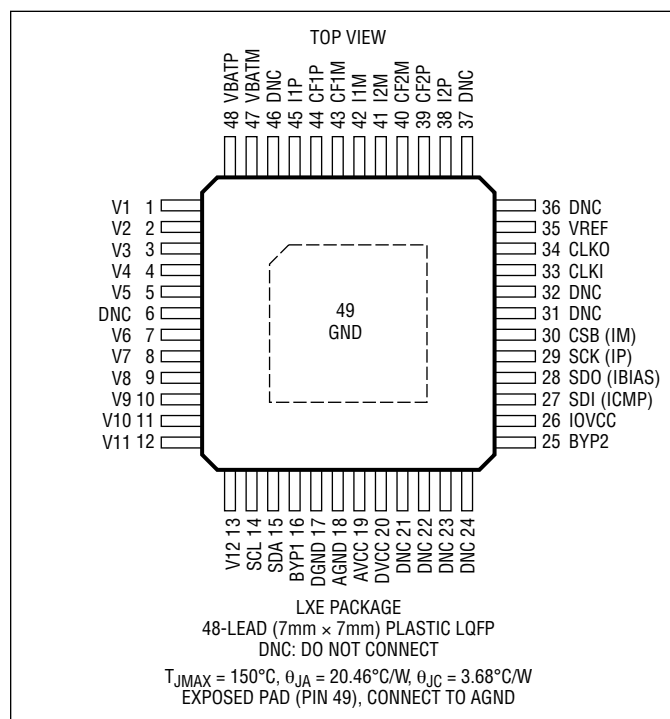
### Current In/Out of Pins

|               |              |
|---------------|--------------|
| IP, IM        | $\pm 30mA$   |
| SDO (IBIAS)   | –1mA to 9mA  |
| V8-V12        | $\pm 2mA$    |
| VREF (Note 4) | $\pm 2mA$    |
| BYP1 (Note 4) | –10mA to 0mA |
| BYP2 (Note 4) | –10mA to 0mA |

### Operating Ambient Temperature Range

|                           |                |
|---------------------------|----------------|
| LTC2949I                  | –40°C to 85°C  |
| LTC2949H                  | –40°C to 125°C |
| Storage Temperature Range | –65°C to 150°C |

## PIN CONFIGURATION



## ORDER INFORMATION

### AUTOMOTIVE PRODUCTS\*\*

| TRAY (250PC)       | TAPE AND REEL (2000PC) | PART MARKING* | PACKAGE DESCRIPTION   | MSL RATING | TEMPERATURE RANGE |
|--------------------|------------------------|---------------|-----------------------|------------|-------------------|
| LTC2949ILXE#3ZZPBF | LTC2949ILXE#3ZZTRPBF   | LTC2949LXE    | 48-LEAD PLASTIC eLQFP | 3          | –40°C to 85°C     |
| LTC2949HLXE#3ZZPBF | LTC2949HLXE#3ZZTRPBF   | LTC2949LXE    | 48-LEAD PLASTIC eLQFP | 3          | –40°C to 125°C    |

Contact the factory for parts specified with wider operating temperature ranges. \*The temperature grade is identified by a label on the shipping container.

**Tape and reel specifications.** Some packages are available in 500 unit reels through designated sales channels with #TRMPBF suffix.

\*\*Versions of this part are available with controlled manufacturing to support the quality and reliability requirements of automotive applications. These models are designated with a #3ZZ suffix. Only the automotive grade products shown are available for use in automotive applications. Contact your local Analog Devices account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.

# ELECTRICAL CHARACTERISTICS

The ● denotes the specifications which apply over the full operating temperature range, otherwise specifications are at  $T_A = 25^\circ\text{C}$ .

| SYMBOL                   | PARAMETER                                                                                                                                 | CONDITIONS                                                                                                                                   |           | MIN   | TYP                        | MAX             | UNITS               |
|--------------------------|-------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------|-----------|-------|----------------------------|-----------------|---------------------|
| <b>Power Supply</b>      |                                                                                                                                           |                                                                                                                                              |           |       |                            |                 |                     |
| $V_{AVCC}$               | Analog Supply Voltage                                                                                                                     |                                                                                                                                              | ●         | 4.5   |                            | 14              | V                   |
| $V_{DVCC}$               | Digital Supply Voltage                                                                                                                    |                                                                                                                                              | ●         | 4.5   |                            | 14              | V                   |
| $V_{UVLO}$               | Supply Undervoltage Lockout Threshold                                                                                                     | $V_{AVCC}, V_{DVCC}$ Falling                                                                                                                 | ●         |       |                            | 4.5             | V                   |
| $I_{CC}$                 | Average Supply Current into AVCC and DVCC                                                                                                 | Core State: STANDBY or MEASURE                                                                                                               | ●         |       | 16                         | 20              | mA                  |
|                          |                                                                                                                                           | Core State: SLEEP                                                                                                                            |           |       | 9                          | 15              | $\mu\text{A}$       |
|                          |                                                                                                                                           | Core State: SLEEP                                                                                                                            | ●         |       |                            | 150             | $\mu\text{A}$       |
|                          |                                                                                                                                           |                                                                                                                                              |           |       |                            |                 |                     |
|                          | Additional DVCC Supply Current if isoSPI in READY/ACTIVE States<br>Note: ACTIVE State Current Assumes $t_{CLK} = 1\mu\text{s}$ , (Note 5) | $R_{B1} + R_{B2} = 2\text{k}$                                                                                                                | READY     | ●     | 4.8                        | 5.8             | mA                  |
|                          |                                                                                                                                           |                                                                                                                                              | ACTIVE    | ●     | 6.1                        | 7.8             | mA                  |
|                          |                                                                                                                                           | $R_{B1} + R_{B2} = 20\text{k}$                                                                                                               | READY     | ●     | 2.1                        | 3               | mA                  |
|                          |                                                                                                                                           |                                                                                                                                              | ACTIVE    | ●     | 2.5                        | 3.5             | mA                  |
| $V_{BYP1}$               | BYP1 Regulated Output Voltage                                                                                                             |                                                                                                                                              | ●         | 2.25  | 2.5                        | 2.75            | V                   |
|                          | BYP1 Load Current                                                                                                                         |                                                                                                                                              | ●         | -10   |                            | 0               | mA                  |
|                          | BYP1 Load Regulation Error                                                                                                                | $I_{LOAD} = -10\text{mA}$                                                                                                                    | ●         | -15   |                            | 0               | mV                  |
|                          | BYP1 Undervoltage Lockout Threshold                                                                                                       |                                                                                                                                              | ●         |       |                            | 2.25            | V                   |
| $V_{BYP2}$               | BYP2 Regulation Output Voltage                                                                                                            |                                                                                                                                              | ●         | 3     | 3.25                       | 3.6             | V                   |
|                          | BYP2 Load Current                                                                                                                         |                                                                                                                                              | ●         | -10   |                            | 0               | mA                  |
|                          | BYP2 Load Regulation Error                                                                                                                | $I_{LOAD} = -10\text{mA}$                                                                                                                    | ●         | -60   |                            |                 | mV                  |
|                          | Thermal Shutdown Temperature                                                                                                              |                                                                                                                                              |           |       | 170                        |                 | $^\circ\text{C}$    |
| <b>Current Sense ADC</b> |                                                                                                                                           |                                                                                                                                              |           |       |                            |                 |                     |
|                          | Resolution (No Missing Codes)                                                                                                             | Slow Mode Filtered (Note 7)                                                                                                                  | ●         | 20    |                            |                 | Bit                 |
|                          |                                                                                                                                           | Slow Mode (Note 7)                                                                                                                           | ●         | 18    |                            |                 | Bit                 |
|                          |                                                                                                                                           | Fast Mode (Note 7)                                                                                                                           | ●         | 15    |                            |                 | Bit                 |
|                          | Full-Scale Differential Input Voltage                                                                                                     | $V_{I1P}-V_{I1M}, V_{I2P}-V_{I2M}$                                                                                                           |           |       | $\pm 124$                  |                 | mV                  |
| $VDIF_I$                 | Differential Input Voltage Range                                                                                                          | $V_{I1P}-V_{I1M}, V_{I2P}-V_{I2M}$                                                                                                           | ●         |       |                            | $\pm 110$       | mV                  |
|                          | Pin Voltage of I1P, I1M, I2P, I2M                                                                                                         |                                                                                                                                              | ●         | -0.11 |                            | $V_{AVCC}+0.11$ | V                   |
|                          | Current Sense Quantization Step                                                                                                           | Slow Mode Filtered                                                                                                                           |           |       | 237.5                      |                 | nV                  |
|                          |                                                                                                                                           | Slow Mode                                                                                                                                    |           |       | 950                        |                 | nV                  |
|                          |                                                                                                                                           | Fast Mode                                                                                                                                    |           |       | 7.60371                    |                 | $\mu\text{V}$       |
| $CFP_x$                  | Input Leakage Current at CF1P, CF1M, I1P, I1M, CF2P, CF2M, I2P, I2M                                                                       | Core State = SLEEP/STANDBY                                                                                                                   | ●         |       |                            | 60              | nA                  |
|                          | Differential Input Current from CF1P to CF1M, CF2P to CF2M                                                                                | Core State: MEASURE; Pin Voltages: $0\text{V} \leq V_{CF1P}, V_{CF1M}, V_{I1P}, V_{I1M}, V_{CF2P}, V_{CF2M}, V_{I2P}, V_{I2M} \leq V_{AVCC}$ |           |       | $VDIF_I/100\text{k}\Omega$ |                 | $\mu\text{A}$       |
|                          | Noise                                                                                                                                     | Slow Mode Filtered                                                                                                                           |           |       | 160                        |                 | $\text{nV}_{RMS}$   |
|                          |                                                                                                                                           | Slow Mode                                                                                                                                    |           |       | 320                        |                 | $\text{nV}_{RMS}$   |
|                          |                                                                                                                                           | Fast Mode                                                                                                                                    |           |       | 3                          |                 | $\mu\text{V}_{RMS}$ |
|                          | Gain Error                                                                                                                                | $ VDIF_I  \leq 110\text{mV}$                                                                                                                 |           |       |                            | 0.15            | %                   |
|                          |                                                                                                                                           |                                                                                                                                              | ●         |       |                            | 0.3             | %                   |
|                          | Offset Voltage                                                                                                                            | $I_{ADCx}, I_{xP}, I_{xM} = 0\text{V}$                                                                                                       | Slow Mode | ●     | 0                          | $\pm 1$         | $\mu\text{V}$       |
|                          |                                                                                                                                           | $V_{AVCC} = V_{DVCC} = 5\text{V}$                                                                                                            | Fast Mode | ●     | 0                          | $\pm 2$         | $\mu\text{V}$       |
|                          | Total Unadjusted Error                                                                                                                    | $ VDIF_I  \geq 25\text{mV}$                                                                                                                  | ●         |       |                            | 0.3             | %                   |

# ELECTRICAL CHARACTERISTICS

The ● denotes the specifications which apply over the full operating temperature range, otherwise specifications are at  $T_A = 25^\circ\text{C}$ .

| SYMBOL | PARAMETER                                 | CONDITIONS         | MIN | TYP   | MAX    | UNITS |
|--------|-------------------------------------------|--------------------|-----|-------|--------|-------|
|        | Input Voltage Common Mode Rejection at DC | ●                  | 100 |       |        | dB    |
|        | Input Sampling Frequency                  |                    |     | 10.48 |        | MHz   |
|        | Conversion Time                           | Slow Mode Filtered |     | 400   |        | ms    |
|        |                                           | Slow Mode          |     | 100   |        | ms    |
|        |                                           | Fast Mode          | ●   | 0.782 | 0.8211 | ms    |

## Voltage Measurement by Power ADC

|                   |                                              |                                                                                 |   |         |                |                   |
|-------------------|----------------------------------------------|---------------------------------------------------------------------------------|---|---------|----------------|-------------------|
|                   | Resolution (No Missing Codes)                | Slow Mode (Note 7)                                                              | ● | 18      |                | Bit               |
|                   |                                              | Fast Mode (Note 7)                                                              | ● | 15      |                | Bit               |
| VFS <sub>V</sub>  | Full-Scale Differential Input Voltage        | $V_{VBATP} - V_{VBATM}$                                                         |   | ±6.14   |                | V                 |
| VDIF <sub>V</sub> | Differential Input Voltage Range             | $V_{VBATP} - V_{VBATM}$                                                         | ● |         | ±4.8           | V                 |
|                   | Pin Voltage of VBATP, VBATM                  | $V_{AVCC} \geq 5V$                                                              | ● | -0.1    | $V_{AVCC}+0.1$ | V                 |
|                   |                                              | $V_{AVCC} < 5V$                                                                 | ● | -0.1    | $V_{AVCC}-1.5$ | V                 |
| LSB <sub>V</sub>  | Differential Input Voltage Quantization Step | Slow Mode                                                                       |   | 46.875  |                | μV                |
|                   |                                              | Fast Mode                                                                       |   | 375.183 |                | μV                |
|                   | Input Leakage Current                        | Core State: SLEEP/STANDBY                                                       | ● |         | 60             | nA                |
|                   | Differential Input Resistance                | Core State: MEASURE; Pin Voltages 0V<br>$\leq V_{BATP}, V_{BATM} \leq V_{AVCC}$ |   | 50      |                | MΩ                |
|                   |                                              |                                                                                 | ● | 20      |                | MΩ                |
|                   | Gain Error                                   |                                                                                 | ● |         | 0.3            | %                 |
|                   | Offset                                       | $V_{BATP} = V_{BATM} = 0V$                                                      | ● | 0       | ±3             | LSB <sub>V</sub>  |
|                   | Voltage Total Unadjusted Error               | $1V \leq  VDIF_V  \leq 4.8V$                                                    | ● |         | 0.4            | %                 |
|                   | Input Voltage Common Mode Rejection at DC    |                                                                                 | ● | 80      |                | dB                |
|                   | Noise                                        | Slow Mode (Note 7)                                                              |   | 3       |                | μV <sub>RMS</sub> |
|                   |                                              | Fast Mode (Note 7)                                                              |   | 30      |                | μV <sub>RMS</sub> |
|                   | Input Sampling Rate                          |                                                                                 |   | 5.24    |                | MHz               |
|                   | Conversion Time                              | Slow Mode                                                                       |   | 100     |                | ms                |
|                   |                                              | Fast Mode                                                                       | ● | 0.782   | 0.8211         | ms                |

## Power Measurement by Power ADC

|                  |                               |                                                             |   |          |        |                      |
|------------------|-------------------------------|-------------------------------------------------------------|---|----------|--------|----------------------|
|                  | Resolution (No Missing Codes) | Slow Mode (Note 7)                                          | ● | 18       |        | Bit                  |
|                  |                               | Fast Mode (Note 7)                                          | ● | 11       |        | Bit                  |
| FS <sub>P</sub>  | Full-Scale Power              | $FS_P = VFS_V \cdot VFS_I / R_{ISENSE} / VDIF_V$            |   | ±0.76504 |        | [V <sup>2</sup> /Ω]  |
| LSB <sub>P</sub> | Power Quantization Step       | $LSB_P = FS_P / 2^{17}$                                     |   | 5.8368   |        | μ[V <sup>2</sup> /Ω] |
| POS              | Power Offset                  | $VDIF_I = 0$                                                |   | 1        |        | LSB <sub>P</sub>     |
| TUE <sub>P</sub> | Power Total Unadjusted Error  | $1V \leq  VDIF_V  \leq 4.8V, 25mV \leq  VDIF_I  \leq 110mV$ | ● |          | 0.9    | %                    |
|                  | RMS Noise                     | Slow Mode; $V_{BATP} - V_{BATM} = 4.8V$ (Note 7)            |   | 0.3      |        | LSB <sub>P</sub>     |
|                  |                               | Slow Mode; $V_{BATP} - V_{BATM} = 0V$ (Note 7)              |   | 0.03     |        | LSB <sub>P</sub>     |
|                  | Input Sampling Frequency      |                                                             |   | 5.24     |        | MHz                  |
|                  | Power Modulation Frequency    |                                                             |   | 5.24     |        | MHz                  |
|                  | Conversion Time               | Slow Mode                                                   |   | 100      |        | ms                   |
|                  |                               | Fast Mode                                                   | ● | 0.782    | 0.8211 | ms                   |

# ELECTRICAL CHARACTERISTICS

The ● denotes the specifications which apply over the full operating temperature range, otherwise specifications are at  $T_A = 25^\circ\text{C}$ .

| SYMBOL                                          | PARAMETER                                                     | CONDITIONS                                                                                                  |   | MIN  | TYP     | MAX                    | UNITS            |
|-------------------------------------------------|---------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------|---|------|---------|------------------------|------------------|
| Energy Measurement                              |                                                               |                                                                                                             |   |      |         |                        |                  |
| TUE <sub>E</sub>                                | Energy Total Unadjusted Error                                 | 1V ≤  VDIF <sub>V</sub>   ≤ 4.8V, 25mV ≤  VDIF <sub>I</sub>   ≤ 110mV, Ideal External Clock or 4MHz Crystal | ● |      |         | 0.9                    | %                |
|                                                 |                                                               | 1V ≤  VDIF <sub>V</sub>   ≤ 4.8V, 25mV ≤  VDIF <sub>I</sub>   ≤ 110mV, Internal Clock                       | ● |      |         | 1.9                    | %                |
| Charge Measurement                              |                                                               |                                                                                                             |   |      |         |                        |                  |
| TUE <sub>C</sub>                                | Charge Total Unadjusted Error                                 | 1V ≤  VDIF <sub>V</sub>   ≤ 4.8V, 25mV ≤  VDIF <sub>I</sub>   ≤ 110mV, Ideal External Clock or 4MHz Crystal | ● |      |         | 0.4                    | %                |
|                                                 |                                                               | 1V ≤  VDIF <sub>V</sub>   ≤ 4.8V, 25mV ≤  VDIF <sub>I</sub>   ≤ 110mV, Internal Clock                       | ● |      |         | 1.4                    | %                |
| Voltage Measurement by AUXILIARY ADC            |                                                               |                                                                                                             |   |      |         |                        |                  |
|                                                 | Resolution (No Missing Codes)                                 | (Note 7)                                                                                                    | ● | 15   |         |                        | Bit              |
| VFS <sub>AUX</sub>                              | Full-Scale Differential Input Voltage                         | V <sub>VBATP</sub> – V <sub>VBATM</sub> , V <sub>MUXP</sub> – V <sub>MUXN</sub>                             |   |      | ±6.14   |                        | V                |
| VDIF <sub>AUX</sub>                             | Differential Input Voltage Range                              | V <sub>VBATP</sub> – V <sub>VBATM</sub> , V <sub>MUXP</sub> – V <sub>MUXN</sub>                             | ● |      |         | ±4.8                   | V                |
|                                                 | Pin Voltage of VBATP, VBATM, V1 – V12, CF1P, CF1M, CF2P, CF2M | V <sub>AVCC</sub> ≥ 5V                                                                                      | ● | –0.1 |         | V <sub>AVCC</sub> +0.1 | V                |
|                                                 |                                                               | V <sub>AVCC</sub> < 5V                                                                                      | ● | –0.1 |         | V <sub>AVCC</sub> –1.5 | V                |
| LSB <sub>AUX</sub>                              | Differential Voltage Quantization Step                        | Slow Mode                                                                                                   |   |      | 375     |                        | μV               |
|                                                 |                                                               | Fast Mode                                                                                                   |   |      | 375.183 |                        | μV               |
|                                                 | Input Leakage Current                                         |                                                                                                             | ● |      | 1       | 60                     | nA               |
|                                                 | Differential Input Resistance                                 |                                                                                                             | ● | 40   |         |                        | MΩ               |
|                                                 | Gain Error                                                    | VDIF <sub>AUX</sub>   ≤ 4.8V                                                                                | ● |      |         | 0.3                    | %                |
|                                                 | Offset                                                        | V <sub>BATP</sub> = V <sub>BATM</sub> = 0V                                                                  | ● |      | 0       | ±1                     | LSB <sub>V</sub> |
|                                                 | Total Unadjusted Error                                        | 1V ≤  VDIF <sub>V</sub>   ≤ 4.8V                                                                            | ● |      |         | 0.4                    | %                |
|                                                 | Input Voltage Common Mode Rejection at DC                     |                                                                                                             | ● | 80   |         |                        | dB               |
|                                                 | Sampling Rate                                                 |                                                                                                             |   |      | 5.24    |                        | MHz              |
|                                                 | Conversion Time                                               |                                                                                                             | ● |      | 0.782   | 0.8211                 | ms               |
| On-Die Temperature Measurement by AUXILIARY ADC |                                                               |                                                                                                             |   |      |         |                        |                  |
|                                                 | Resolution (No Missing Codes)                                 | (Note 7)                                                                                                    | ● | 13   |         |                        | Bit              |
|                                                 | Full-Scale Temperature                                        |                                                                                                             |   |      | 819.2   |                        | K                |
| ΔT <sub>LSB</sub>                               | Temperature Quantization Step                                 |                                                                                                             |   |      | 0.2     |                        | K                |
|                                                 | Total Unadjusted Error                                        |                                                                                                             |   |      | ±3      |                        | K                |
|                                                 | Conversion Time                                               |                                                                                                             |   |      | 13.1    |                        | ms               |
|                                                 | Self-Heating                                                  |                                                                                                             |   |      | 20      |                        | K/W              |
| Supply Voltage Measurement by AUXILIARY ADC     |                                                               |                                                                                                             |   |      |         |                        |                  |
|                                                 | Resolution (No Missing Codes)                                 | (Note 7)                                                                                                    | ● | 14   |         |                        | Bit              |
|                                                 | Full-Scale Differential Input Voltage                         |                                                                                                             |   |      | 18.43   |                        | V                |
|                                                 | A/DVCC Measurement Quantization Step                          |                                                                                                             |   |      | 2.2583  |                        | mV               |
|                                                 | Total Unadjusted Error                                        |                                                                                                             | ● |      | 2       | ±5                     | %                |
|                                                 | Conversion Time                                               |                                                                                                             |   |      | 6.55    |                        | ms               |
| AUX MUX                                         |                                                               |                                                                                                             |   |      |         |                        |                  |
|                                                 | Signal Range                                                  |                                                                                                             | ● | –0.1 |         | V <sub>AVCC</sub> +0.1 | V                |

# ELECTRICAL CHARACTERISTICS

The ● denotes the specifications which apply over the full operating temperature range, otherwise specifications are at  $T_A = 25^\circ\text{C}$ .

| SYMBOL | PARAMETER                | CONDITIONS                             | MIN | TYP  | MAX  | UNITS         |
|--------|--------------------------|----------------------------------------|-----|------|------|---------------|
|        | Pull-Up Current Source   | Pin Voltage < $V_{AVCC} - 3.0\text{V}$ | ●   | -250 | -150 | $\mu\text{A}$ |
|        | Pull-Down Current Source | Pin Voltage > 2.5V                     | ●   | 200  | 250  | $\mu\text{A}$ |

## Reference Voltages

|       |                                      |                                                        |   |      |            |                          |
|-------|--------------------------------------|--------------------------------------------------------|---|------|------------|--------------------------|
| VREF  | Reference Pin Voltage                |                                                        |   | 3    |            | V                        |
|       | VREF Error                           |                                                        | ● |      | $\pm 1$    | %                        |
|       | VREF Temperature Coefficient         |                                                        |   | 7    |            | ppm/K                    |
|       | VREF Long Term Drift                 |                                                        |   | 80   |            | ppm/ $\sqrt{\text{kHr}}$ |
|       | VREF Load Regulation Error           | $-0.5\text{mA} \leq I_{\text{LOAD}} \leq 0.5\text{mA}$ | ● | -5   | 0          | mV                       |
| VREF2 | Internal Redundant Reference Voltage |                                                        |   | 2.39 |            | V                        |
|       | VREF2 Error                          |                                                        | ● |      | $\pm 0.85$ | %                        |
|       | VREF2 Temperature Coefficient        |                                                        |   | 10   |            | ppm/K                    |
|       | VREF2 Long Term Drift                |                                                        |   | 80   |            | ppm/ $\sqrt{\text{kHr}}$ |

## Overcurrent Comparator

|  |                                  |                                          |   |                       |                       |               |
|--|----------------------------------|------------------------------------------|---|-----------------------|-----------------------|---------------|
|  | Pin Voltages I1P, I1M I2P, I2M   |                                          | ● | -0.11                 | $V_{AVCC} + 0.11$     | V             |
|  | Total Unadjusted Error           | $ V_{\text{thr}}  \leq 103\text{mV}$     | ● |                       | $\pm 5$               | mV            |
|  |                                  | $ V_{\text{thr}}  > 103\text{mV}$        | ● |                       | $\pm 10$              | mV            |
|  |                                  | $ V_{\text{thr}}  = 310\text{mV}$        | ● |                       | $\pm 20$              | mV            |
|  | Programmable Deglitch Time Delay | $T_{\text{degl}} 20, 80, 320\mu\text{s}$ | ● | $T_{\text{degl}} -10$ | $T_{\text{degl}} +37$ | $\mu\text{s}$ |
|  |                                  | $T_{\text{degl}} 1280\mu\text{s}$        | ● | $T_{\text{degl}} -26$ | $T_{\text{degl}} +56$ | $\mu\text{s}$ |

## Digital Input CLKI

|  |                          |          |   |     |         |               |
|--|--------------------------|----------|---|-----|---------|---------------|
|  | Logic Input Threshold    |          | ● | 0.4 | 2       | V             |
|  | Input Current DC Current |          | ● |     | $\pm 1$ | $\mu\text{A}$ |
|  | Input Capacitance        | (Note 7) | ● |     | 10      | pF            |
|  | External Clock Frequency |          | ● | 0.1 | 25      | MHz           |

## General Purpose Outputs GPIOx

|  |                                    |                              |   |                        |     |     |     |
|--|------------------------------------|------------------------------|---|------------------------|-----|-----|-----|
|  | Low Level Output Voltage at GPIOx  | I <sub>GPIOx</sub> = 0.5mA   | ● | 0.4                    |     |     | V   |
|  | High Level Output Voltage at GPIOx | I <sub>GPIOx</sub> = −0.25mA | ● | V <sub>DVCC</sub> −0.5 |     |     | V   |
|  | GPIOx Toggling Frequency           |                              | ● | 370                    | 400 | 430 | kHz |

## SPI Interface DC Specification IOVCC, CSB, SCK, SDI, SDO

|                    |                                       |                                                                                                                                                   |   |                              |                              |               |
|--------------------|---------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------|---|------------------------------|------------------------------|---------------|
| $V_{\text{IOVCC}}$ | SPI Mode IOVCC Operating Voltage      |                                                                                                                                                   | ● | 1.8                          | 4.5                          | V             |
|                    | Pin Voltages CSB, SCK, SDI, SDO       |                                                                                                                                                   | ● |                              | $V_{\text{IOVCC}}$           | V             |
|                    | Logic Input Threshold (CSB, SCK, SDI) |                                                                                                                                                   | ● | $0.3 \cdot V_{\text{IOVCC}}$ | $0.7 \cdot V_{\text{IOVCC}}$ | V             |
|                    | DC Input Current (CSB, SCK, SDI)      |                                                                                                                                                   | ● |                              | $\pm 1$                      | $\mu\text{A}$ |
|                    | Input Capacitance (CSB, SCK, SDI)     | (Note 7)                                                                                                                                          | ● |                              | 10                           | pF            |
|                    | Low Level Output Voltage at SDO       | $V_{\text{IOVCC}} \geq 3.3\text{V}, I_{\text{SDO}} = 3\text{mA}, 1.8\text{V} \leq V_{\text{IOVCC}} \leq 3.3\text{V}, I_{\text{SDO}} = 1\text{mA}$ | ● |                              | 0.4                          | V             |

## SPI Timing Requirements (See Figure 7)

|                  |                                       |          |   |    |  |               |
|------------------|---------------------------------------|----------|---|----|--|---------------|
| $t_{\text{CLK}}$ | SCK Period                            | (Note 6) | ● | 1  |  | $\mu\text{s}$ |
| $t_1$            | SDI Setup Time Before SCK Rising Edge |          | ● | 25 |  | ns            |
| $t_2$            | SDI Hold Time After SCK Rising Edge   |          | ● | 25 |  | ns            |

# ELECTRICAL CHARACTERISTICS

The ● denotes the specifications which apply over the full operating temperature range, otherwise specifications are at  $T_A = 25^\circ\text{C}$ .

| SYMBOL | PARAMETER                           | CONDITIONS                              | MIN | TYP  | MAX | UNITS         |
|--------|-------------------------------------|-----------------------------------------|-----|------|-----|---------------|
| $t_3$  | SCK Low                             | $t_{CLK} = t_3 + t_4 \geq 1\mu\text{s}$ | ●   | 200  |     | ns            |
| $t_4$  | SCK High                            | $t_{CLK} = t_3 + t_4 \geq 1\mu\text{s}$ | ●   | 200  |     | ns            |
| $t_5$  | CSB Rising Edge to CSB Falling Edge |                                         | ●   | 0.65 |     | $\mu\text{s}$ |
| $t_6$  | SCK Rising Edge to CSB Rising Edge  | (Note 6)                                | ●   | 0.8  |     | $\mu\text{s}$ |
| $t_7$  | CSB Falling Edge to SCK Rising Edge | (Note 6)                                | ●   | 1    |     | $\mu\text{s}$ |
| $t_8$  | SCK Falling Edge to SDO Valid       | (Note 9), $V_{IOVCC} \geq 3.3\text{V}$  | ●   |      | 60  | ns            |
|        |                                     | (Note 9), $V_{IOVCC} < 3.3\text{V}$     | ●   |      | 150 | ns            |

## isoSPI DC Specifications (See Figure 10)

|             |                                            |                                                                                                  |   |     |     |                                        |                  |
|-------------|--------------------------------------------|--------------------------------------------------------------------------------------------------|---|-----|-----|----------------------------------------|------------------|
|             | Voltage at IOVCC to Select isoSPI          |                                                                                                  | ● |     |     | 0.5                                    | V                |
| $V_{IBIAS}$ | Voltage on IBIAS Pin                       | READY/ACTIVE State                                                                               | ● | 1.9 | 2   | 2.1                                    | V                |
|             |                                            | IDLE                                                                                             |   |     | 0   |                                        | V                |
| $I_B$       | Isolated Interface Bias Current            | $R_{BIAS} = 2\text{k}\Omega$ to $20\text{k}\Omega$                                               | ● | 0.1 |     | 1                                      | mA               |
| $A_{IB}$    | Isolated Interface Current Gain            | $V_A \leq 1\text{V}$ , $I_B = 1\text{mA}$                                                        | ● | 18  | 20  | 22                                     | mA/mA            |
|             |                                            | $I_B = 0.1\text{mA}$                                                                             | ● | 17  | 20  | 24.5                                   | mA/mA            |
| $V_A$       | Transmitter Pulse Amplitude                | $V_A =  V_{IP} - V_{IM} $                                                                        | ● |     |     | 1.4                                    | V                |
| $V_{ICMP}$  | Threshold-Setting Voltage on ICMP Pin      | $V_{TCMP} = A_{TCMP} \cdot V_{ICMP}$                                                             | ● | 0.2 |     | 1.5                                    | V                |
|             | Input Leakage Current on ICMP Pin          | $V_{ICMP} = 0\text{V}$ to $V_{BYP2}$                                                             | ● |     |     | $\pm 1$                                | $\mu\text{A}$    |
|             | Leakage Current on IP and IM Pins          | IDLE State, $V_{IP}$ or $V_{IM} = 0\text{V}$ to $V_{BYP2}$                                       | ● |     |     | $\pm 1$                                | $\mu\text{A}$    |
| $A_{TCMP}$  | Receiver Comparator Threshold Voltage Gain | $V_{CM} = V_{BYP2}/2$ to $V_{BYP2} - 0.2\text{V}$ ,<br>$V_{ICMP} = 0.2\text{V}$ to $1.5\text{V}$ | ● | 0.4 | 0.5 | 0.6                                    | V/V              |
| $V_{CM}$    | Receiver Common Mode Bias                  | IP, IM Not Driving                                                                               |   |     |     | $V_{BYP2} - V_{ICMP}/3 - 167\text{mV}$ | V                |
|             | Receiver Input Resistance                  | Single-Ended to IP, IM                                                                           | ● | 27  | 35  | 43                                     | $\text{k}\Omega$ |

## isoSPI IDLE/WAKE-UP Specifications (See Figure 3)

|             |                                                |                            |   |     |     |    |               |
|-------------|------------------------------------------------|----------------------------|---|-----|-----|----|---------------|
| $V_{WAKE}$  | Differential Wake-Up Voltage                   | $t_{DWELL} = 240\text{ns}$ | ● | 200 |     |    | mV            |
| $t_{DWELL}$ | Dwell Time at $V_{WAKE}$ Before Wake Detection | $V_{WAKE} = 200\text{mV}$  | ● | 240 |     |    | ns            |
| $t_{READY}$ | Start-Up Time After Wake Detection             |                            | ● |     |     | 10 | $\mu\text{s}$ |
| $t_{IDLE}$  | Idle Timeout Duration                          |                            | ● | 4.3 | 6.4 | 8  | ms            |

## isoSPI Pulse Timing Specifications (See Figures 10,11)

|                |                                |             |   |     |     |     |    |
|----------------|--------------------------------|-------------|---|-----|-----|-----|----|
| $t_{FILT(CS)}$ | Chip-Select Signal Filter      | Receiver    | ● | 70  | 90  | 115 | ns |
| $t_{WNDW(CS)}$ | Chip-Select Valid Pulse Window | Receiver    | ● | 220 | 270 | 330 | ns |
| $t_{1/2PW(D)}$ | Data Half-Pulse Width          | Transmitter | ● | 40  | 50  | 60  | ns |
| $t_{FILT(D)}$  | Data Signal Filter             | Receiver    | ● | 10  | 25  | 35  | ns |
| $t_{INV(D)}$   | Data Pulse Inversion Delay     | Transmitter | ● | 40  | 55  | 69  | ns |
| $t_{WNDW(D)}$  | Data Valid Pulses Window       | Receiver    | ● | 70  | 90  | 110 | ns |
| $t_{RTN}$      | Data Return Delay              |             | ● |     | 485 | 625 | ns |

## I<sup>2</sup>C Interface DC Specification (SCL, SDA)

|  |                                      |                    |   |     |  |         |               |
|--|--------------------------------------|--------------------|---|-----|--|---------|---------------|
|  | Logic Input Threshold (SDA)          |                    | ● | 0.9 |  | 1.6     | V             |
|  | DC Input Current (SDA)               |                    | ● |     |  | $\pm 1$ | $\mu\text{A}$ |
|  | Input Capacitance (SDA)              | (Note 7)           | ● |     |  | 10      | pF            |
|  | Low Level Output Voltage at SDA, SCL | $I = 0.5\text{mA}$ | ● |     |  | 0.4     | V             |

# ELECTRICAL CHARACTERISTICS

The ● denotes the specifications which apply over the full operating temperature range, otherwise specifications are at  $T_A = 25^\circ\text{C}$ .

| SYMBOL                                                          | PARAMETER                                                                         | CONDITIONS                                                      |   | MIN                  | TYP | MAX | UNITS         |
|-----------------------------------------------------------------|-----------------------------------------------------------------------------------|-----------------------------------------------------------------|---|----------------------|-----|-----|---------------|
| <b>I<sup>2</sup>C Interface Timing Specification (SCL, SDA)</b> |                                                                                   |                                                                 |   |                      |     |     |               |
| $f_{\text{SCL(MAX)}}$                                           | Maximum SCL Clock Frequency                                                       |                                                                 | ● |                      | 8   | 10  | kHz           |
| $t_{\text{SCLLO}}$                                              | SCL Low Period                                                                    |                                                                 | ● | 80                   |     |     | $\mu\text{s}$ |
| $t_{\text{SDALO}}$                                              | SDA Low Period                                                                    |                                                                 | ● | 80                   |     |     | $\mu\text{s}$ |
| $t_{\text{BUF(MIN)}}$                                           | Bus Free Time Between STOP/START                                                  |                                                                 | ● | 30                   |     |     | $\mu\text{s}$ |
| $t_{\text{SU,STA(MIN)}}$                                        | Minimum Repeated START Setup Time                                                 |                                                                 | ● | 30                   |     |     | $\mu\text{s}$ |
| $t_{\text{HD,STA(MIN)}}$                                        | Minimum Hold Time (Repeated) START Condition                                      |                                                                 | ● | 30                   |     |     | $\mu\text{s}$ |
| $t_{\text{SU,STO(MIN)}}$                                        | Minimum Setup Time for STOP Condition                                             |                                                                 | ● | 30                   |     |     | $\mu\text{s}$ |
| $t_{\text{SU,DAT(MIN)}}$                                        | Minimum Data Setup Time Input                                                     |                                                                 | ● | 30                   |     |     | $\mu\text{s}$ |
| $t_{\text{HD,DAT(MIN)}}$                                        | Minimum Data Hold Time Input                                                      |                                                                 | ● |                      |     | 0   | ns            |
| $t_{\text{HD,DATO}}$                                            | Minimum Data Hold Time Output                                                     |                                                                 | ● | 30                   |     |     | $\mu\text{s}$ |
| $t_{\text{OF}}$                                                 | Data Output Fall Time                                                             | (Notes 7, 8)                                                    | ● | $20 + 0.1 \cdot C_B$ |     |     | ns            |
| <b>Digital Core Timings (See Figure 3)</b>                      |                                                                                   |                                                                 |   |                      |     |     |               |
| $t_{\text{BOOT}}$                                               | Core Boot-Up Time from SLEEP or POWER-OFF to STANDBY                              | AVCC/DVCC Pins at Minimum Operating Voltage                     | ● |                      |     | 100 | ms            |
| $t_{\text{IDLE\_CORE}}$                                         | Core STANDBY Cycle Time                                                           | (Note 10)                                                       | ● | 17                   | 20  |     | ms            |
| $t_{\text{CONT}}$                                               | Core MEASURE Cycle Time                                                           | (Note 11)                                                       | ● | 90                   | 100 | 110 | ms            |
| $t_{\text{MLCK,M}}$                                             | Memory Lock Request to Acknowledge Time                                           | Core Status MEASURE                                             | ● |                      |     | 130 | ms            |
| $t_{\text{MLCK,S}}$                                             | Memory Lock Request to Acknowledge Time                                           | Core Status STANDBY                                             | ● |                      |     | 40  | ms            |
| $t_{\text{ACKN}}$                                               | Time from Core Entering STANDBY to Return to SLEEP, When Wake-Up is not Confirmed | No Write of 0x0 to Reg. WKUPACK, No Write of 0x8 to Reg. OPCTRL | ● | 0.6                  |     | 1.5 | s             |
| <b>Time Base</b>                                                |                                                                                   |                                                                 |   |                      |     |     |               |
| $TUE_{\text{TB}}$                                               | TUE Time Base                                                                     | Internal Clock                                                  |   |                      |     | 0.5 | %             |
|                                                                 |                                                                                   |                                                                 | ● |                      |     | 1   | %             |

**Note 1:** Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect the device reliability and lifetime.

**Note 2:** Positive currents flow into pins, negative currents flow out of pins. Minimum and maximum values refer to absolute values.

**Note 3:** Do not apply a voltage or current source to these pins. They must be unconnected, connected to capacitive loads or connected to a crystal according to their pin description. Otherwise permanent damage may occur.

**Note 4:** Do not apply a voltage source to these pins. Overloading these pins might disrupt operation.

**Note 5:** Active supply current ( $I_{\text{CC}}$ ) is dependent on the amount of time that the output drivers are active on IP and IM. During those times  $I_{\text{CC}}$  will increase by the  $20 \cdot I_B$  drive current. For the maximum data rate 1MHz, the drivers are active approximately 5% of the time.

**Note 6:** These timing specifications are dependent on the delay through the cable, and include allowances for 50ns of delay each direction. 50ns corresponds to 10m of CAT-5 cable (which has a velocity of propagation of 66% the speed of light). Use of longer cables would require derating these specs by the amount of additional delay.

**Note 7:** Guaranteed by design and characterization, not subject to production test.

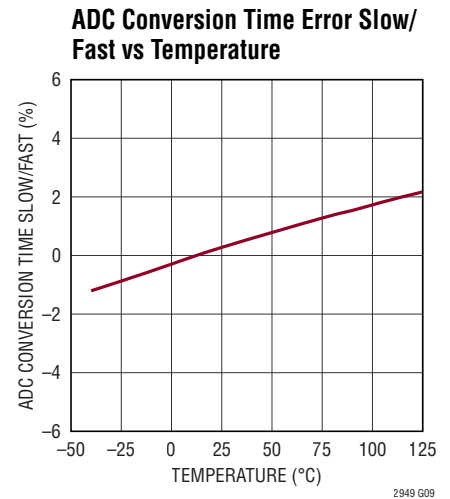
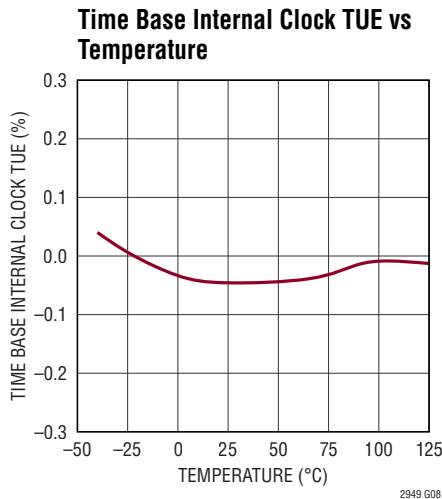
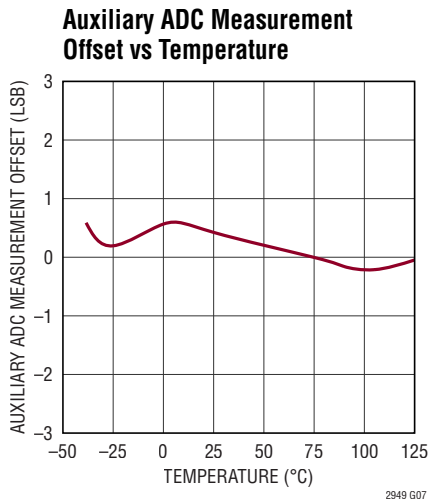
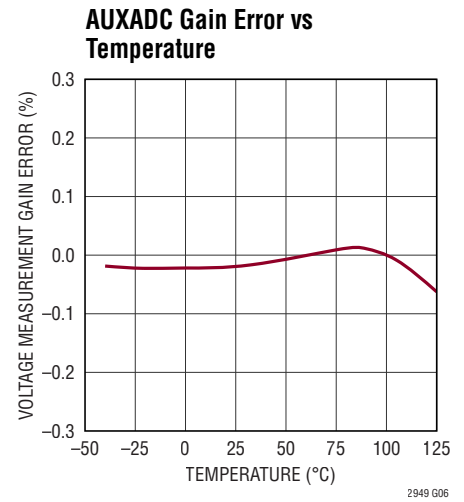
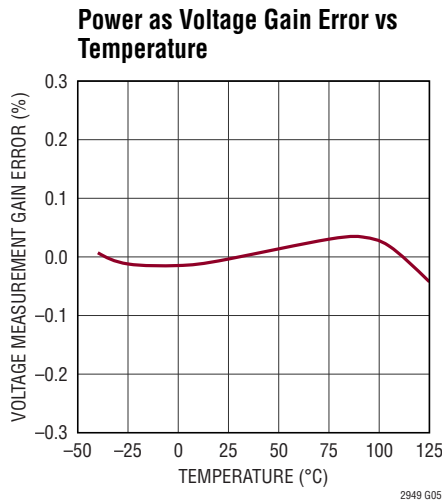
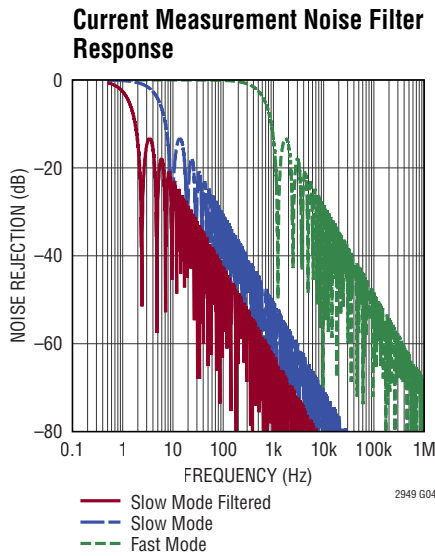
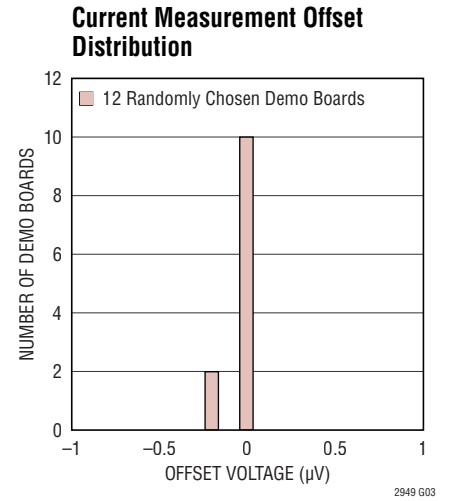
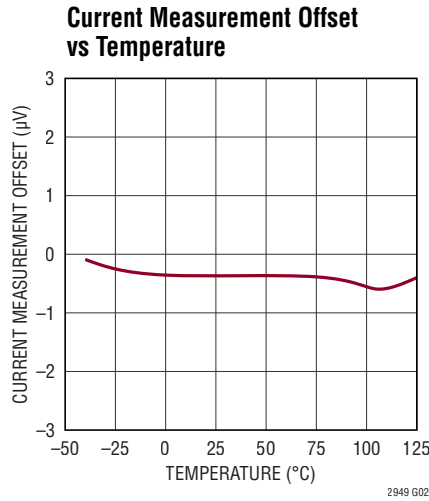
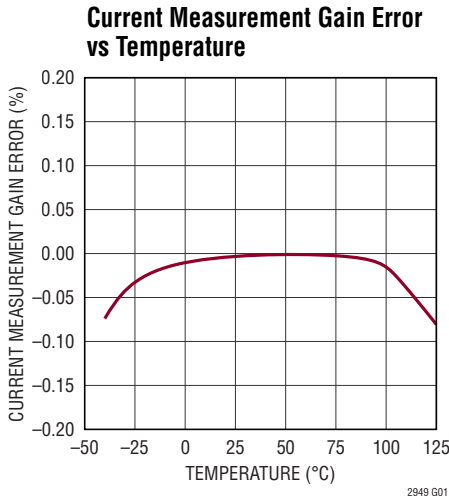
**Note 8:**  $C_B$  = capacitance of one bus line in pf ( $10\text{pF} < C_B < 400\text{pF}$ )

**Note 9:** These specifications do not include rise time of SDO due to pull up resistance and load capacitance on SDO pin.

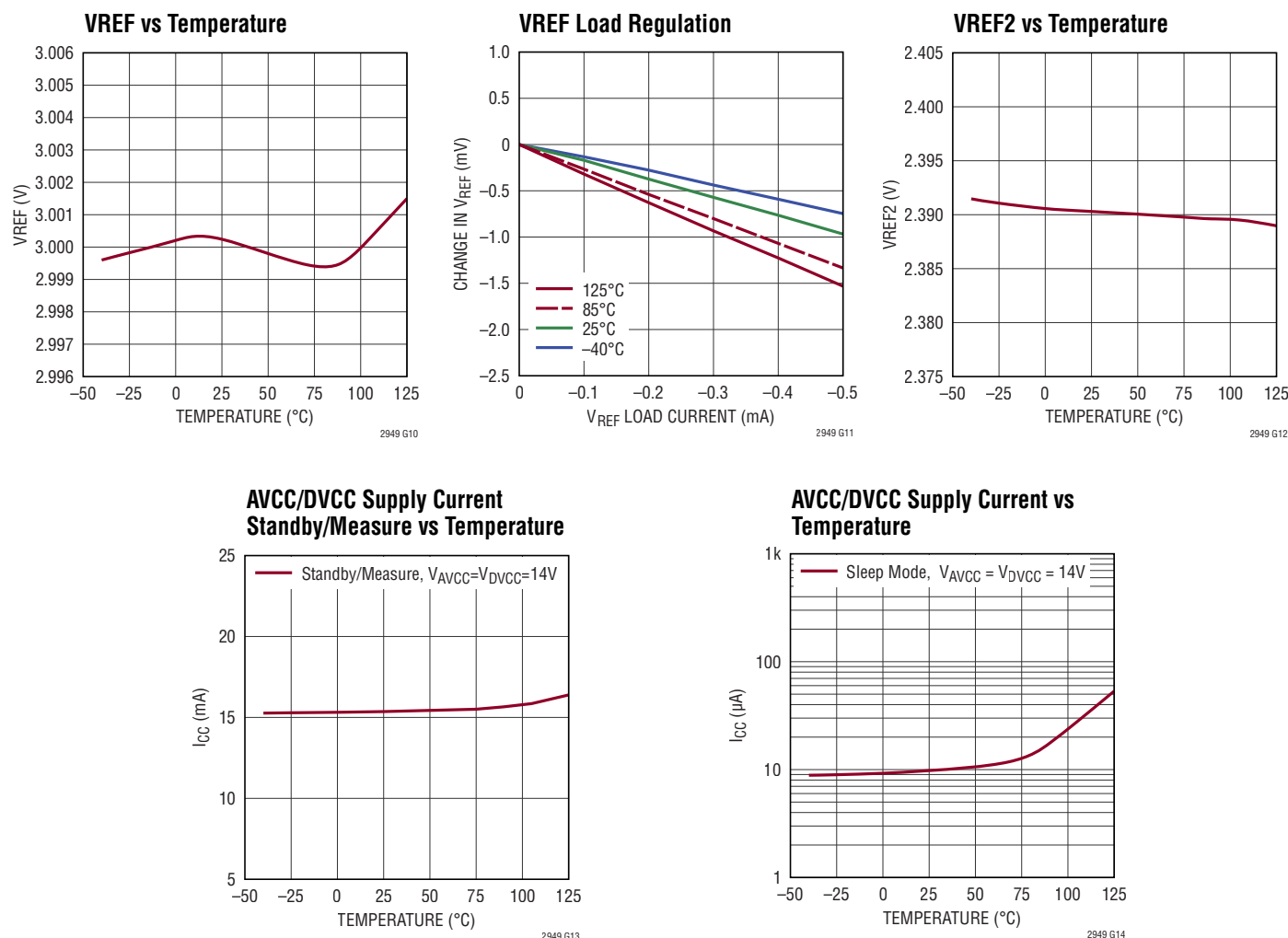
**Note 10:** Cycle time at which STATUS/FAULTS and  $V_{\text{REF}}$  registers are updated.

**Note 11:** Cycle time at which STATUS/ALERT/FAULTS registers and all slow channel measurement results are updated after the first update. The first update after enabling any measurement is typically 50ms delayed.

## TYPICAL PERFORMANCE CHARACTERISTICS



## TYPICAL PERFORMANCE CHARACTERISTICS



## PIN FUNCTIONS

**AVCC (Pin 19):** Analog Supply Voltage. Bypass this pin to AGND with a 0.1μF (or greater) capacitor. AVCC operating range is 4.5V to 14V.

**AGND (Pin 18):** Analog Ground. Bypass this pin to AVCC with a 0.1μF (or greater) capacitor.

**BYP1 (Pin 16):** Internal Supply Voltage. Bypass BYP1 to DGND with a 1μF capacitor. BYP1 is regulated to 2.5V. Can supply external circuitry (example EEPROM) with up to 10mA. Overloading might disrupt LTC2949 functionality.

**BYP2 (Pin 25):** Internal 3.25V Supply Voltage. Bypass BYP2 to DGND with a 1μF capacitor. Can supply external circuitry (example SPI isolator ADuM141E or ADuM4154) with up to 10mA. Overloading might disrupt LTC2949 functionality.

**CF1P, CF1M (Pins 44, 43):** Filter Capacitor Inputs for the first current channel. Connect a 1μF capacitor between CF1P and CF1M for filtering differential noise and fast current variations. Connect 0.1μF capacitors between AGND and the filter pins for damping high frequency common mode variations.

## PIN FUNCTIONS

**CF2P, CF2M (Pins 39, 40):** Filter Capacitor Inputs for the second current channel. Connect a 1 $\mu$ F capacitor between CF12P and CF12M for filtering differential noise and fast current variations. Connect 0.1 $\mu$ F capacitors between AGND and the filter pins for damping high frequency common mode variations.

**CLKI (Pin 33):** Clock Input. Connect to ground if internal clock is used. For improved measurement accuracy, connect a 4MHz crystal between CLKI and CLKO and matching capacitors to ground, or drive with an external clock. See the Timebase Control section.

**CLKO (Pin 34):** Clock Output. Connect a 4MHz crystal between CLKO and CLKI if used; leave pin unconnected otherwise.

**CSB/IM (Pin 30):** Active Low Chip Select in SPI mode or Isolated Interface Negative Input/Output in isoSPI mode.

**DGND (Pin 17):** Digital Ground. Connect to AGND.

**DNC (Pins 6, 21, 22, 23, 24, 31, 32, 36, 37, 46):** Do not connect.

**DVCC (Pin 20):** Supply Voltage. Bypass this pin to DGND with a 1 $\mu$ F capacitor. Operating range is 4.5V to 14V.

**I1P, I1M (Pins 45, 42):** Differential Input of I1ADC and overcurrent comparator 1. Tie to AGND if unused.

**I2P, I2M (Pins 38, 41):** Differential Input of I2ADC and overcurrent comparator 2. Tie to AGND if unused.

**IOVCC (Pin 26):** Serial Interface Configuration and Supply Pin. Tie pin to DGND for isoSPI communication. Tie pin to a voltage  $\geq 1.8$ V and  $\leq 4.5$ V and bypass with 1 $\mu$ F to DGND for standard SPI communication. In SPI mode IOVCC supplies the digital input and output circuits of the serial interface.

**SCK/IP (Pin 29):** Serial Clock Input in SPI mode or Isolated Interface Positive Input/Output in isoSPI mode.

**SCL (Pin 14):** I<sup>2</sup>C Master Clock Open Drain Output. Connect to clock input of EEPROM.

**SDA (Pin 15):** I<sup>2</sup>C Data Input And Open Drain Output. Connect to data line of EEPROM. SDA driven low at power up

prevents LTC2949 to go automatically into SLEEP state and to execute HW memory BIST. Connect a 4.7k-10k pull-up resistor from SDA to BYP1 to ensure correct operation of auto-sleep and memory BIST.

**SDI/ICMP (Pin 27):** Serial Data Input in SPI mode or Isolated Interface Comparator Voltage Threshold in isoSPI mode. Tie ICMP to the resistor divider between IBIAS and DGND to set the voltage threshold of the isoSPI receiver comparators. The comparator thresholds are set to 1/2 the voltage on the ICMP pin.

**SDO/IBIAS (Pin 28):** Open Drain Serial Data Output in SPI mode or Isolated Interface Current Bias in isoSPI mode. In SPI mode tie with a pullup resistor to IOVCC. In isoSPI mode tie IBIAS to DGND through a resistor divider to set the interface output current level. When the isoSPI interface is enabled, the IBIAS pin voltage is regulated to 2V. The IP/IM output current drive is set to 20 times the current IB, sourced from the IBIAS pin.

**V1, V2, V3, V4, V5, V6, V7 (Pins 1, 2, 3, 4, 5, 7, 8):** Voltage Measurement Inputs. Pins are internally buffered before being applied to the AUXADC for ensuring high input impedance (50M $\Omega$ ) and low leakage. Can be left floating if unused.

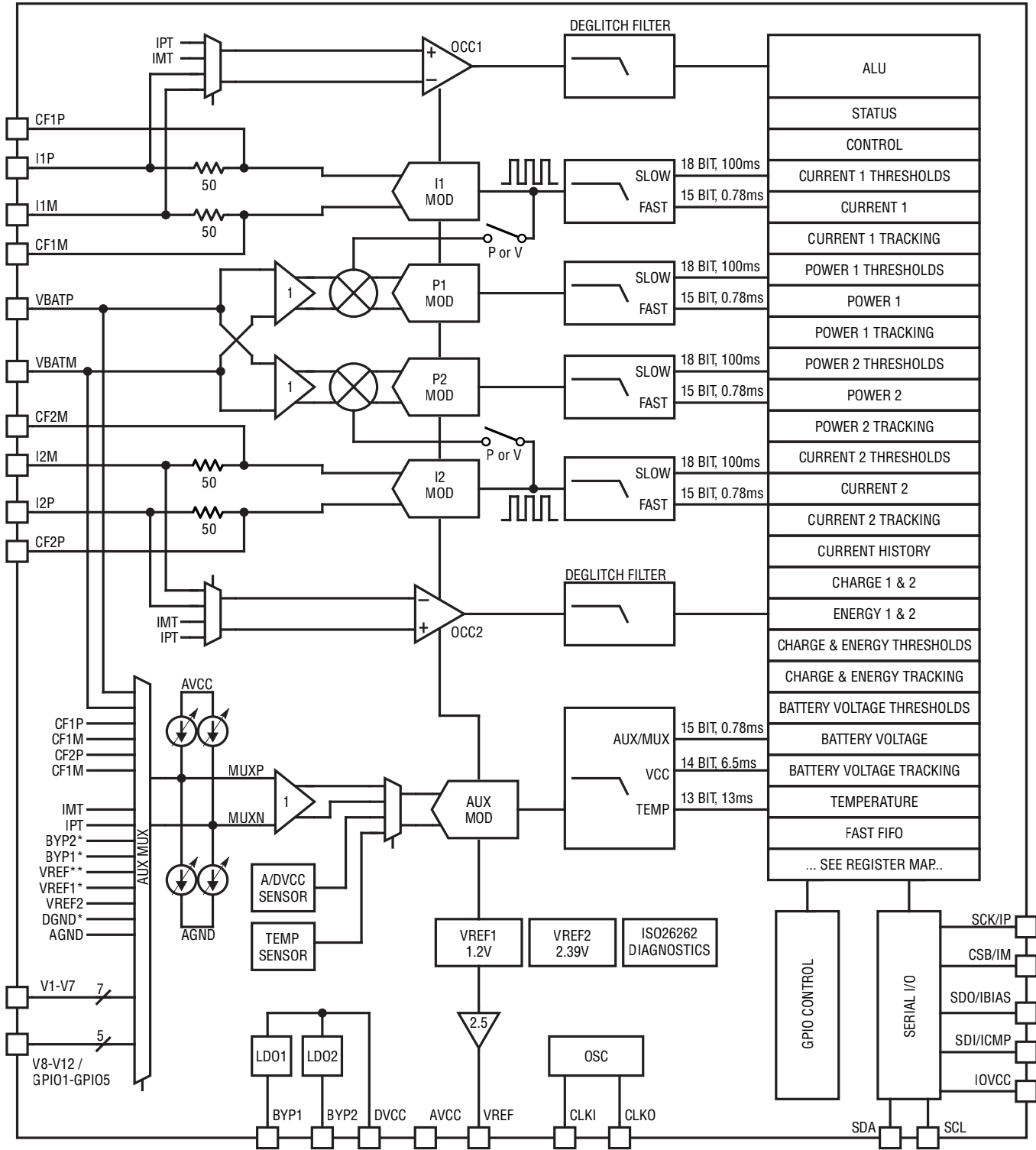
**V8-V12/GPIO1-GPIO5 (Pins 9, 10, 11, 12, 13):** General Purpose Voltage In— and Digital Outputs. Pins are internally buffered before being applied to the AUXADC for ensuring high input impedance (50M $\Omega$ ) and low leakage (<10nA). Each pin can be switched to DVCC, switched to DGND or to toggle at 400kHz (typ.) between DVCC and DGND. Pins are tri-state in sleep mode. Can be left floating if unused.

**VBATP, VBATM (Pins 48, 47):** Battery Voltage Measurement. The differential voltage between VBATP and VBATM is internally buffered for ensuring high input impedance (50M $\Omega$ ) and low leakage (<10nA).

**VREF (Pin 35):** Reference Voltage Output. VREF provides a buffered 3V reference voltage for temperature measurements with NTCs. Current load is limited to 0.5mA. Bypass this pin to AGND with a 1 $\mu$ F capacitor.

**EXPOSED PAD (Pin 49):** Connect to AGND.

## BLOCK DIAGRAM



\* Measured value not accessible by user. Only used for internal diagnostics.

\*\* VREF measurement value is only accessible by user from the AUX slow channel.

See also section 'Unused Input Pins V1-V12' for recommendation to allow VREF measurement from AUX fast channel.

See also 'Table 57. MUX Settings' for more details on AUX MUX configuration.

## OPERATION

### OVERVIEW

The LTC2949 is a high precision current, voltage, charge and energy meter for electrical and hybrid vehicles or other applications requiring isolated data acquisition. Operating from supply voltages from 4.5 to 14V, it infers charge and energy flowing in and out of the battery pack by monitoring simultaneously the current through up to two sense resistors and the battery pack voltage. Five rail-to-rail low-offset  $\Delta\Sigma$  ADCs ensure accurate measurement of currents, voltage and power with insignificant power loss. The LTC2949 uses instantaneous multiplication of voltage and current at a high sampling rate to infer accurately power even in presence of fast load variations. Additionally to the inputs for measuring currents and battery voltage, the LTC2949 features 12 analog input pins (V1 to V12) for measuring external voltages. Using its built-in multiplexer, the LTC2949 performs differential high input impedance rail-to-rail voltage measurements between any pair of input pins. Pins V8 to V12 can be configured as high voltage digital outputs, swinging from ground to digital supply voltage (DVCC) for controlling external components such as high voltage transistors. One automatic measurement cycle of current, voltage, power, temperature, supply voltage and two programmable multiplexer settings takes 100ms in slow mode. The LTC2949 repeatedly performs such measurements and recalculates energy, charge, time and updates the minimum/maximum tracking and threshold registers, resulting in continuous integration of current and power with lossless tracking of charge and energy delivered or received by the battery pack. An on-chip oscillator provides a 1% precise time base for calculating total charge, energy and time. If higher accuracy is required, a 4MHz crystal connected between pin CLKI and CLKO or an external clock can be used.

For time critical applications, a fast mode is available which reduces conversion times to 782 $\mu$ s. Data acquired during fast operation is stored in four FIFOs which contain each up to 1000 fast ADC readings from 4 synchronously measured parameters. Reading data from the FIFO yields simultaneously converted conversion results, enabling battery impedance tracking, current profiling or monitoring of other fast events, such as the pre-charging voltage before closing contactors. Thresholds can be set for parameters

measured in slow mode, and the LTC2949 will set the corresponding bit in the Alert Register if a threshold is exceeded. Programmable heartbeat functions on up to two GPIOs allow to signal any enabled alert over an isolation barrier, independent of the serial interface. Those pins toggle at 400kHz and stop toggling in case of an alert.

The LTC2949 features a programmable analog overcurrent comparator for each current channel for applications which require fast detection of overcurrent conditions. A programmable deglitch filter allows to discard overcurrent conditions shorter than a predefined time duration\*.

A 3V reference voltage output (VREF) is provided for connecting external NTCs or voltage dividers allowing to measure signals below ground. In slow mode, the LTC2949 provides means for linearizing temperature readings of up to two external NTCs by solving Steinhart-Hart equations with programmable coefficients. The LTC2949 can be configured to automatically compensate user-programmed temperature coefficients of low-cost shunt resistors by using linearized NTC temperature readings.

The LTC2949 features programmable gain correction factors to compensate for tolerances of external shunt resistors and resistor dividers. A master I<sup>2</sup>C interface and dedicated commands allow to read from and write to an external EEPROM which can be used for storing calibration factors and the entire register content of the LTC2949 to guarantee data retention without supply. Storing correction factors in an EEPROM enables a modular approach to factory-calibration of application boards.

A thermal shutdown circuit trips at die temperatures above 150°C and resets the IC to default state, only the thermal shutdown bit itself is not reset.

Measured quantities are stored in internal registers accessible via the onboard SPI or LTC-proprietary isoSPI interface which allows fully isolated operation of the LTC2949. The LTC2949 was developed for compatibility with Linear's Multicell Battery Monitors (LTC68XX). Various bus structures in either SPI or isoSPI, multi-drop and/or daisy chaining are possible. The LTC2949 supports a limited set of Linear's Battery Cell Monitor compatible commands for triggering synchronous ADC conversions and reading back data.

\*An overcurrent condition is signaled by a dedicated heartbeat pin for fastest response times.

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Digital data acquired in isolated operation is transferred over external capacitors or transformers across an isolation barrier. Bridging potential differences of several kV is achieved by choosing appropriate external components.

All those features enable a wide variety of applications beyond current and charge measurement, like measuring isolation resistance, controlling pre-charge switches, signaling alarm conditions, monitoring state of contactors, etc. The LTC2949 offers various diagnosis functions to support functional safety critical systems, see the Safety Manual for more information.

## MODES OF OPERATION

### Core State Description

When all power supply voltages have risen above their UVLO thresholds, the LTC2949 boots up, sets all registers to their default state and enters after 1s its default SLEEP state with a current consumption of 9 $\mu$ A (typ), preventing rapid discharge after insertion when being supplied by a battery.

In SLEEP state, all GPIOs are tri-state and the LTC2949 monitors the serial interface and initiates the boot sequence on a falling edge of CSB in SPI mode. In isoSPI mode the isoSPI interface must first be woken up by a wake-up pulse before a pulse generating a negative edge on the internal CSB can be sent. During the boot sequence, the host can poll the SLEEP bit in the Operation Control Register to check that the LTC2949 is awake and in STANDBY mode (see also Figure 20 about Wake-Up and Boot procedure). LTC2949 enters STANDBY state maximum 100ms ( $t_{BOOT}$ ) after the first falling edge of CSB. In STANDBY state all reference voltages are powered up and a clock is provided to digital circuits. The LTC2949 automatically returns to SLEEP state if no wake up confirmation command is received within 1 second ( $t_{ACKN}$ ) after entering STANDBY state. Wake up is confirmed by writing 0x00 to register WKUPACK.

The LTC2949 enters SLEEP state ~200ms ( $t_{SLEEP}$ ) after receiving a sleep command. A negative edge on CSB during

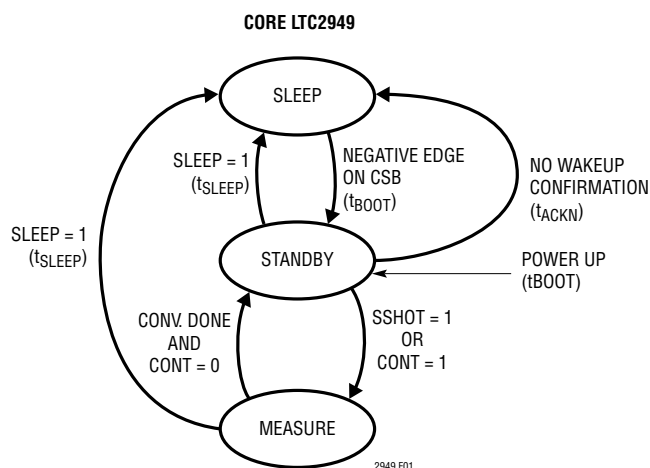


Figure 1. LTC2949 Operation State Diagram

$t_{SLEEP}$  will prevent the LTC2949 from entering SLEEP state. In SLEEP, internal analog supplies and BYP1 are switched off, causing the UVLOA and UVLOD bits to be set when the LTC2949 resumes from SLEEP. An internal always-on regulated voltage supplies the memory and guarantees data retention during SLEEP. If AVCC or DVCC drop below the UVLO threshold, the UVLO bit of the internal always-on supply UVLOSTBY is set and a power-on-reset occurs, resetting all registers to their default value. In STANDBY state, all internal circuitry is active but no measurements except the reference voltage (VREF) are being made. From STANDBY, the LTC2949 can be instructed to go into MEASURE state by setting the single shot (SSHOT) or continuous (CONT) bit in the Operations Control Register OPCTRL.

### isoSPI State Description

If the IOVCC pin is tied to a supply voltage  $\geq 1.8$ V, the LTC2949 operates in normal SPI mode and IOVCC supplies the receiving circuit and output driving circuit for all SPI signals.

Tying IOVCC to DGND enables the isoSPI port. The isoSPI port has three different states: IDLE, READY and ACTIVE. In IDLE state, the isoSPI port is powered down. Only

## OPERATION

differential activity on IP-IM generates a wake-up signal and the isoSPI port will enter READY state after  $t_{\text{READY}}$  (10 $\mu$ s) and be ready to send or receive data. The current consumption increases by several mA in READY. When communication takes place the isoSPI port is in ACTIVE state and supply current rises further depending on clock frequency. In order to save power the isoSPI port enters IDLE state when there has been no differential activity on IP-IM for more than  $t_{\text{IDLE}}$  (6.4ms typ.). Communication to the LTC2949 core is only possible if the isoSPI port is not in IDLE state. This means that even when the LTC2949 core is in STANDBY or MEASURE state and the isoSPI port is in IDLE state, communication can only take place 10 $\mu$ s ( $t_{\text{READY}}$ ) after differential activity on IP-IM.

Figure 2 displays the sequence of states which the isoSPI interface and the LTC2949 core go through from waking up the interface until effectuating ADC measurements. See also Figure 20 for recommended wake-up sequence implementations.

### DATA ACQUISITION CHANNELS

The LTC2949 has two current ADCs (I1ADC, I2ADC), two power ADCs (P1ADC, P2ADC) and one Auxiliary ADC (AUXADC). I1ADC and P1ADC are grouped together and form data acquisition channel 1 (CH1), I2ADC and P2ADC form channel 2 (CH2) and the AUXADC together with auxiliary multiplexer (AUXMUX), die-temperature sensor and supply voltage sensor form channel AUX (CHAUX).

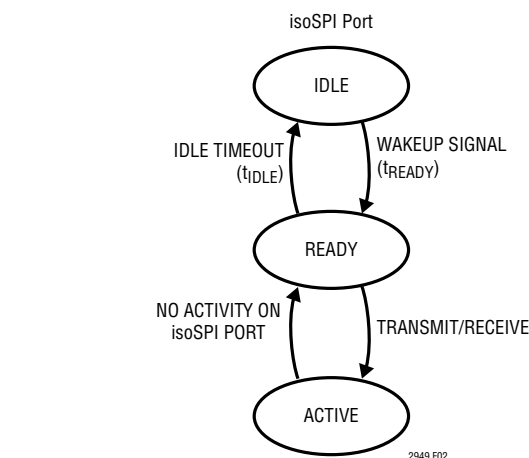


Figure 2. isoSPI State Diagram

CH1 and CH2 can be individually set to an 18-bit high precision mode (slow mode, default) or a 15-bit fast mode. Activating fast mode reduces conversion times from 100ms to 782 $\mu$ s on the selected channel. The power ADCs can be individually configured as voltage ADCs by disabling the power multiplication after the input buffers by setting the corresponding Power as Voltage (PasV) bit in ADC Configuration Register (ADCCONF).

### Slow, High Precision Mode

By default, LTC2949's acquisition channels are in slow high precision mode where conversions of CH1 or CH2 take 100ms and yield 18-bit conversion results of current and power or current and voltage, if PasV set. During these 100ms the auxiliary channel (CHAUX) measures

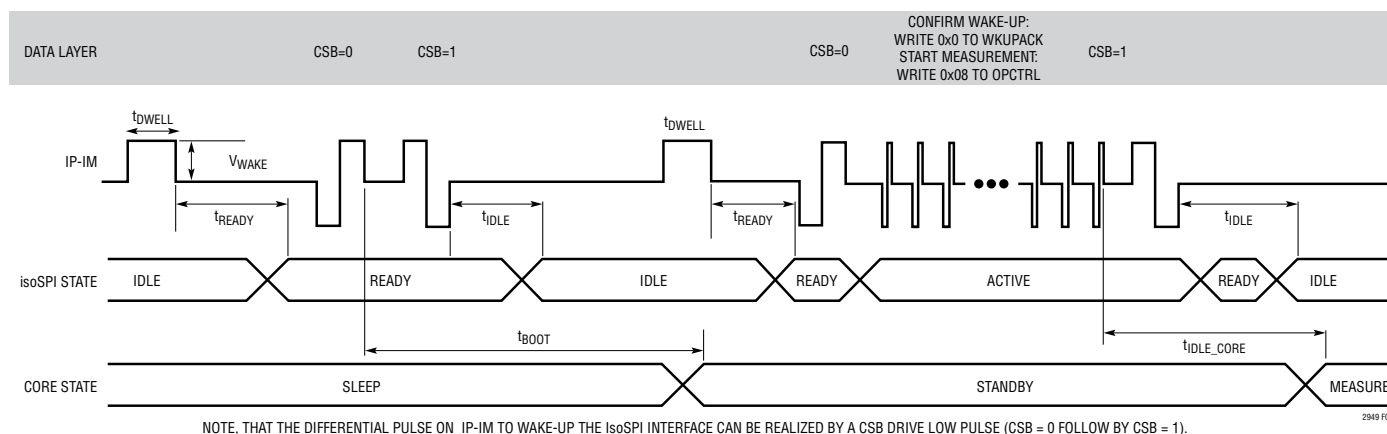


Figure 3. Timing of IsoSPI and Core States

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sequentially six different quantities using its Round Robin (RR) mode starting with VBATP – VBATM (BAT) then die-temperature (TEMP), AVCC supply voltage (VCC), two AUXMUX inputs (SLOT1 and SLOT2), selectable by the Multiplexer Setting Registers and finally the Reference Voltage (VREF). Furthermore, a moving average of the last four measurements of IADC1 and IADC2 in slow mode is provided, yielding a 20-bit result. In slow, high precision mode a single conversion or continuous conversions can be triggered. The continuous slow mode (CONT) is the most typical operation and also the prerequisite to make fast conversions.

### Single Shot Measurement Mode (SSHOT)

When bit SSHOT in the Operation Control Register is set, the LTC2949 takes measurements of CH1 and CH2 as well as the six auxiliary channel measurements described above, updates the corresponding minimum, maximum and threshold registers, resets bit SSHOT, sets the bit UPDATE in Status Register and returns to the STANDBY state. No time measurements are made and the charge and energy registers are not updated and therefore not compared against minimum/maximum thresholds. The host can poll the UPDATE bit in the STATUS Register to detect the completion of the measurement cycle. A measurement starts within 20ms ( $t_{IDLE\_CORE}$ ) after setting bit SSHOT.

### Continuous Measurement Mode (CONT)

When the bit CONT in the Operation Control is set, the LTC2949 repeatedly takes measurements of CH1 and CH2 as well as the six auxiliary channel measurements, recalculates energy, charge, time and updates the minimum/maximum tracking and status registers every 100ms. The start of continuous high precision measurements can take up to 20ms ( $t_{IDLE\_CORE}$ ) after setting bit CONT. The current and power ADCs run continuously in this mode, ensuring that no charge or energy is missed. If a power ADC is configured to measure voltage (PasV), the energy of the corresponding channel is not accumulated. The LTC2949 remains in continuous mode until bit CONT of the Operation Control Register is reset by the user. If the SSHOT bit is set while in continuous mode, the LTC2949 completes the current measurement cycle and then enters single shot mode, clearing the CONT bit in the Operation Control Register.

In continuous measurement mode, the host can poll for the end of a measurement cycle by periodically checking the corresponding time registers (TB1, TB2, TB3 or TB4) for incrementation.

### Accessing High Precision Results

At the end of each measurement cycle of 100ms, all result register for the measured quantities are updated; in continuous mode, accumulated quantities are updated also. Furthermore, the four preceding measurements of each current channel are stored in Current History Registers and their average in Current Average Registers, see the Register Map section for more details. The completion of register updates of the measurement results can be detected by reading one of the time registers (TB1-TB4) and looking for a changed value.

### Fast Mode

The LTC2949 provides a fast mode with a reduced conversion time of 782 $\mu$ s and a resolution of 15-bit. Fast mode allows to start measurements at a precise point in time and thereby perform measurements synchronized with the voltage measurements of LTC's Battery Stack Monitors, for example to deduce cell impedance of individual cells.

### Fast Mode Configurations

The LTC2949 allows to set data acquisition channel 2 in fast mode while data acquisition channel 1 stays in slow high precision mode or to set both data acquisition channels 1 and 2 in fast mode by setting the corresponding bit FACH1 or FACH2 in the Fast Control Register (FACTRL). The auxiliary channel can be set to fast mode independently of CH1 and CH2, converting only a single quantity (selected by the Fast MUX Control Registers) instead of Round-Robin (RR).

To enable short startup delays, the LTC2949 must be in continuous mode (CONT=1) before triggering fast conversions. Fast measurements are triggered either by an ADCV command (fast single shot) or by setting bit FACONV in the Fast Control Register (FACTRL). The ADCV command triggers a single fast conversion of the selected channels right after the correct PEC is received, synchronous to

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LTC's Battery Stack Monitors. If fast measurements are triggered by setting  $\text{FACONV}=1$ , LTC2949 executes a sequence of fast conversions until  $\text{FACONV}$  or  $\text{CONT}$  is reset. Samples acquired during fast continuous mode are stored in individual FIFOs for up to four fast input channels (I1, I2, BAT via P1 or P2 and AUX).

CH1 and CH2 automatically restart in slow high precision mode after completion of joint fast mode conversions. If CH2 was in fast mode while CH1 continued in slow high precision mode, CH2 will stop converting after completion of fast mode acquisitions ready to perform further fast mode conversions when requested either by an  $\text{ADCV}$  command or by setting  $\text{FACONV}$  again. The auxiliary channel slow mode Round-Robin (BAT, TEMP, VCC, SLOT1, SLOT2, VREF) is automatically restarted after all fast measurements were stopped for 300 ms. In applications where continuous high AUX measurement rates (faster than every 100ms) are required, it is recommended to measure also VREF and optionally VCC via external connections to V1-V12 and implement a manual Round-Robin by fast single shot measurements in software.

### Accessing Fast Mode Results

The last results of fast conversions can be read out by the  $\text{RDCV}$  command providing sequentially the results of I1, I2, BAT via P1 or P2 and AUX followed by an indicator if the data is new (0xF) or old (0x0). BAT is the result of the power ADC, if the ADC is set in voltage mode (bit  $\text{PasV}=1$ ), otherwise, the power ADC result is 0. If both channels are in fast mode with their power ADCs in voltage mode, BAT is obtained from  $\text{PADC1}$ . Please note that to be compliant with LTC's Battery Stack Monitors,  $\text{RDCV}$  reports LSByte first.

Furthermore, the last 1000 fast conversion results of I1, I2, BAT via P1 or P2 and AUX are stored in First-In-First-Out Registers accessible by  $\text{FIFOI1}$ ,  $\text{FIFOI2}$ ,  $\text{FIOBAT}$  and  $\text{FIOAUX}$ . Reading continuously from  $\text{FIFOI1}$  provides successively 3 bytes for each sample of the first current ADC: I1 MSB, I1 LSB and a qualifier (TAG) whether the corresponding FIFO data is fine (0x00), has been already read because no new data has been added to the FIFO

since the whole FIFO was read (0x55, default), or has been overwritten because the FIFO was filled without being read (0xAA). The other FIFOs present the respective quantities accordingly. All tags are initialized to their default value (0x55), if fast conversions are triggered by an  $\text{ADCV}$  command (while  $\text{FACONV} = 0$ ) or by setting  $\text{FACONV}$ . Also leaving the continuous mode by resetting  $\text{CONT}$  will clear the FIFOs.

The LSB sizes of the fast conversion results are the same for the  $\text{RDCV}$  and FIFO readings and are listed in Table 28.

When CH1 and CH2 are both in fast mode, 128 conversion results of  $\text{IADC1}$  and  $\text{IADC2}$  are averaged and stored in their respective non-accumulated results registers  $\text{Current1}$  and  $\text{Current2}$  and are added to the  $\text{Charge1}$  and  $\text{Charge2}$  registers ensuring that battery charge and discharge is monitored also in fast mode.

Similarly 128 conversion results of  $\text{PADC1}$  and  $\text{PADC2}$  with 11 bit resolution are averaged and stored in their respective non-accumulated results registers  $\text{Power1}$  and  $\text{Power2}$  and are added to the  $\text{Energy1}$  and  $\text{Energy2}$  registers if the PADCs are in Power Mode ( $\text{PasV}=0$ ). If CH1 is in slow mode and CH2 in fast mode, only CH1 results are reported in the Current and Power results registers, CH2 results can be accessed via  $\text{RDCV}$  or the respective FIFOs.

### Recommended Configurations of Data Acquisition Channels

In a typical application case, both data acquisition channels offered by LTC2949 could monitor the current over a single shunt resistor, where CH1 is used to do high precision current and power measurements and charge and energy integration, while channel two takes fast snapshots of current and voltage for example for impedance measurement.

Alternatively, the two data acquisition channels offered by LTC2949 might be used to monitor currents over two different shunt resistors. In this application case, both channels might be used in either fast or slow mode.  $\text{CHAUX}$  can be configured fully independently from CH1 and CH2. The default mode of  $\text{AUXADC}$  is RR, which is deactivated by enabling fast mode on  $\text{CHAUX}$ .

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**Table 1. Acquisition Channels Configurations**

|       | SINGLE SHUNT | DUAL SHUNT |         |
|-------|--------------|------------|---------|
| CH1   | Slow         | Slow       | Fast    |
| CH2   | Fast         | Slow       | Fast    |
| CHAUX | RR/Fast      | RR/Fast    | RR/Fast |

### Single Shunt Configuration

If only one external shunt is used, CH1 can be used to perform continuous high precision integrated charge and energy measurements, while CH2 is used to perform fast measurements synchronized with LTC's Battery Stack Monitors. By setting bit CONT in the Operation Control Register (OPCTRL) and bit FACH2 in the Fast Control Register (FACTRL), CH1 will effectuate consecutive slow measurements, while CH2 is available for fast measurements triggered by an ADCV command. Measurements of CH1 and its integrated quantities are updated every 100ms while CH2 results can be read out with an RDCV command or obtained from the FIFO registers, in case of fast continuous (FACONV) operation.

### Dual Shunt High Precision Configuration

For dual shunt applications that require continuous uninterrupted high precision coulomb counting and energy measurement CH1 and CH2 should be both configured to slow high precision mode by setting bit CONT in OPCTRL. Conversions on CH1 and CH2 take 100ms and a new RR cycle of CHAUX is started at every start of conversion of CH1.

If fast voltage data is required, the AUXADC can be configured for fast mode without interrupting charge and energy accumulation on CH1 and CH2. After setting bits FACONV and FACHA the AUXADC immediately stops RR mode and continuously measures a single quantity selected by the Fast MUX Control Registers. Data is written to the FIFOAUX. After clearing bit FACHA the AUXADC automatically returns to RR operation (after 300ms). Measurements of VREF, internal die temperature and VCC are only available if RR is enabled. Alternatively, external connections to V1-V12 can be applied to measure VREF and VCC (via an external resistive divider) also in fast mode.

### Dual Shunt Fast Measurement Configuration

CH1 and CH2 are both set to fast mode by setting bits FACONV, FACH1 and FACH2. Charge is accumulated by summing up 15-bit current results, energy by summing up 11 bit power results.

One conversion takes 782 $\mu$ s and a new RR cycle is started after every 100ms. This configuration fits to an application where two shunt resistors are used and fast current, voltage and power is required. E.g.: Fast impedance tracking or measuring pre-charge voltage and current.

## POWER MEASUREMENT

The LTC2949 measures power with additional ADCs that multiply voltage ( $V_{BATP} - V_{BATM}$ ) and current at the full 5.24MHz sampling frequency, prior to any averaging due to the analog-to-digital conversion. This maintains accuracy even if current and voltage change in phase during the 100ms conversion time, which can happen if the power is drawn from a battery with significant impedance. Figure 4 shows an example of the BAT voltage dropping from 4V to 3V due to battery impedance when an AC current is drawn by the load. In this example, the multiplication of average current with average voltage would lead to a +8% error in the calculated power as the voltage is significantly lower than the average voltage at the moments where the peak current is drawn. The scheme used by the LTC2949 avoids this error, maintaining specified accuracy with signals up to 50kHz.

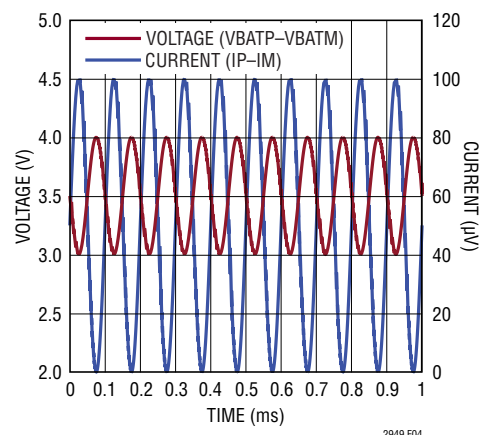


**Figure 4. Power Measurement of Transient Signals**

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### CHARGE, ENERGY AND TIME

The LTC2949 integrates the current and power measurements over time to calculate charge and energy flowing to the load. It also keeps track of total accumulated time used for the integration.

For the quantities charge and energy the LTC2949 provides three sets of registers each, for the quantity "time" four register sets.

Charge1, Energy1 and Time1 contain accumulated quantities of Channel1. Charge2, Energy2 and Time2 contain accumulated quantities of Channel2. Charge3 and Time3 contain the sum of charges monitored by Channel1 and Channel2 and the corresponding time. Similarly Energy4 and Time4 contain the sum of energies monitored by Channel1 and Channel2 and the corresponding time. See the Accumulated Result Registers section in the Register Map description for more details.

Each register set can be separately configured to accumulate current and power based on the sign of the measured current. A minimum current threshold can also be set below which integration is stopped. See the Control Registers section in the Register Map description for more details.

### Time Base

Accurately measuring charge and energy by integrating current and power requires a precise integration period. The LTC2949 uses either a trimmed internal oscillator or an external clock as the time base for determining the integration period. It can use either an external square wave clock in a frequency range between 100kHz and 25MHz or a 4MHz crystal as external clock input. If an external square wave is used, it should be connected to the CLKI pin and the CLKO pin should be left unconnected.

Figure 5 shows the recommended circuit if a crystal is used to generate the reference clock. In case the internal clock is used, tie CLKI to ground and leave CLKO unconnected.

### Timebase Control

The LTC2949 uses the internal oscillator by default. If an external clock or a crystal is used, the PRE and DIV parameters in the Timebase Control Register need to be set appropriately. The LTC2949 then compares its inter-

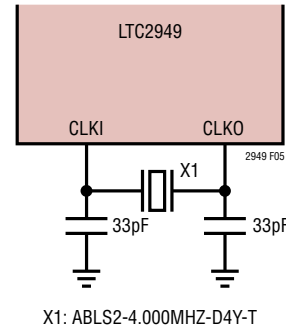


Figure 5. Reference Clock with a 4MHz Crystal

nal clock to the external frequency and represents Time, Charge, and Energy as multiples of the external clock period. To accommodate the large range of allowed external frequencies, an internal prescaler must be configured via the Timebase Control Register.

The prescaler consists of 2 stages, with the first dividing the external frequency  $f_{REF}$  by a factor  $2^{PRE}$ , and the second by a factor DIV. PRE is set between 0 and 5 with bits [2:0] of the Timebase Control Register. PRE should be configured such that the external frequency divided by  $2^{PRE}$  is less than 1MHz as shown in Table 2:

Table 2. Parameter PRE with External Clock

| $f_{REF}$                                     | PRE | $2^{PRE}$ | PRE[2:0] |
|-----------------------------------------------|-----|-----------|----------|
| $0.1\text{MHz} \leq f_{REF} \leq 1\text{MHz}$ | 0   | 1         | 000      |
| $1\text{MHz} \leq f_{REF} \leq 2\text{MHz}$   | 1   | 2         | 001      |
| $2\text{MHz} \leq f_{REF} \leq 4\text{MHz}$   | 2   | 4         | 010      |
| $4\text{MHz} \leq f_{REF} \leq 8\text{MHz}$   | 3   | 8         | 011      |
| $8\text{MHz} \leq f_{REF} \leq 16\text{MHz}$  | 4   | 16        | 100      |
| $16\text{MHz} \leq f_{REF} \leq 25\text{MHz}$ | 5   | 32        | 101      |
| Internal                                      | 7   |           | 111      |

The second stage of the prescaler then divides the result by a factor DIV. DIV is set between 0 and 31 by bits [7:3] of the Time Base Control Register. DIV should be set to the next lower integer value of the ratio between the output of the first stage of the prescaler ( $f_{REF\_1} = f_{REF}/2^{PRE}$ ) and 32768Hz or, in other terms:

$$\text{DIV} = \text{floor}\left(\frac{f_{REF}}{2^{PRE} \cdot 32768\text{Hz}}\right)$$

If a crystal is used, the values are: PRE = 2, DIV = 30. The Quick Eval™ Software for the LTC2949 contains an easy to use calculator for these parameters. Table 3 gives a few examples for common frequencies.

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**Table 3. Timebase Settings for Common Frequencies**

| f <sub>REF</sub> [MHz] | PRE | 2 <sup>PRE</sup> | f <sub>REF_1</sub> [MHz] | DIV | TIME BASE CONTROL [7:0] |
|------------------------|-----|------------------|--------------------------|-----|-------------------------|
| 1                      | 0   | 1                | 1                        | 30  | 1111 0000               |
| 1.5                    | 1   | 2                | 0.75                     | 22  | 1011 0001               |
| 4                      | 2   | 4                | 1                        | 30  | 1111 0010               |
| 10                     | 4   | 16               | 0.625                    | 19  | 1001 1100               |
| 20                     | 5   | 32               | 0.625                    | 19  | 1001 1101               |
| 25                     | 5   | 32               | 0.781                    | 23  | 1011 1101               |
| Int.                   | 7   |                  |                          | X   | XXXX X111               |

## OVERCURRENT COMPARATORS

The LTC2949 features two fast differential over-current comparators with rail to rail input common mode and programmable threshold followed by configurable filters to suppress input glitches. Overcurrent comparator 1 (OCC1) is connected to pins I1P and I1M while overcurrent comparator 2 (OCC2) supervises the differential voltage between I2P and I2M. Both overcurrent comparators can individually be configured to detect either only positive or only negative overcurrents or overcurrents independent of their polarity. When at least one of the overcurrent comparators is enabled, GPIO5 turns into a heartbeat signal toggling at 400kHz while currents are within the desired range and staying low if any current exceeds its programmed limit.

The overcurrent comparator 1 (OCC1) between I1P and I1M is controlled by the control register OCC1CTRL while overcurrent comparator 2 (OCC2) is controlled by its control register at OCC2CTRL, both on page 0 of the register map. Both OCC Control Registers are organized as shown in Table 4.

**Table 4. Overcurrent Comparator Control Registers**

| BIT # | NAME      | FUNCTION         |
|-------|-----------|------------------|
| 0     | OCCxEN    | Enable OCC       |
| 1     | OCCxDAC0  | Threshold DAC[0] |
| 2     | OCCxDAC1  | Threshold DAC[1] |
| 3     | OCCxDAC2  | Threshold DAC[2] |
| 4     | OCCxDGLT0 | Deglintch [0]    |
| 5     | OCCxDGLT1 | Deglintch [1]    |
| 6     | OCCxPOL0  | Polarity [0]     |
| 7     | OCCxPOL1  | Polarity [1]     |

The overcurrent comparators are enabled by setting the respective OCCxEN to 1.

Bits OCCxPOLx control the polarity sensitivity of the comparator as in Table 5.

**Table 5. OCC Polarity Configuration**

| OCCxPOL1 | OCCxPOL0 | POLARITY          |
|----------|----------|-------------------|
| 0        | 0        | Both Polarities   |
| 0        | 1        | Positive Currents |
| 1        | 0        | Negative Currents |

The thresholds of the overcurrent comparators can be programmed individually by means of the OCCxDACx bits between 0 and 310mV.

**Table 6. OCC Thresholds**

| OCCxDAC2 | OCCxDAC1 | OCCxDAC0 | Threshold [mV] |
|----------|----------|----------|----------------|
| 0        | 0        | 0        | 0              |
| 0        | 0        | 1        | 26             |
| 0        | 1        | 0        | 52             |
| 0        | 1        | 1        | 78             |
| 1        | 0        | 0        | 103            |
| 1        | 0        | 1        | 155            |
| 1        | 1        | 0        | 207            |
| 1        | 1        | 1        | 310            |

Similarly, the duration of a threshold exceeding not reported by the comparator (Deglitch Time) can be programmed by the bits OCCxDGLTx between 20µs to 1.28ms.

**Table 7. OCC Deglitch Time**

| OCCxDGLT1 | OCCxDGLT0 | DEGLITCH TIME [µs] |
|-----------|-----------|--------------------|
| 0         | 0         | 20                 |
| 0         | 1         | 80                 |
| 1         | 0         | 320                |
| 1         | 1         | 1280               |

Overcurrents are reported by setting OCC1 and OCC2 of VCC and OCC Status Register (STATVCC) and by stopping the heartbeat signal on GPIO5. While the update of the output register can take up to 100ms, the heartbeat is stopped within 15µs after an overcurrent exceeded the programmed deglitch time. Once an overcurrent occurred, the result bits in the register remain set until they are read by the host and subsequently cleared.

For diagnostic purposes, the overcurrent comparators have a self-test built in using test input signals IPT and IMT, see the Safety Manual for more information.

## SERIAL INTERFACES

### SERIAL INTERFACES OVERVIEW

LTC2949 has two serial interfaces, one for communication with the host and a second to address an external EEPROM. The interface for host communication is composed by pins 27 through 30 and can be configured to be either a standard 4-wire serial peripheral interface (SPI) or a 2-wire isolated interface (isoSPI) based on the voltage of the IOVCC pin. Regardless of which configuration is selected, the LTC2949 acts as an SPI slave. The LTC2949 can be operated in addressable mode (SPI & isoSPI) or as last element of a daisy chain of LTC68xx Cell Monitors (isoSPI only).

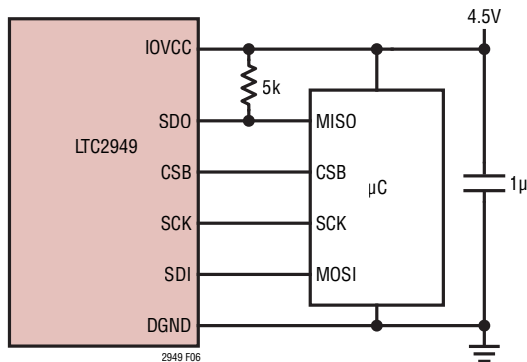


Figure 6. 4-Wire SPI External Connections

A second interface composed by pins 14 and 15 is a master I<sup>2</sup>C interface, allowing to save and restore LTC2949's register content to and from an external EEPROM see the External EEPROM Control Register section for more information.

### 4-WIRE SERIAL PERIPHERAL INTERFACE (SPI) PHYSICAL LAYER

Connecting pin IOVCC to a supply voltage  $\geq 1.8V$  configures the serial port for 4-wire SPI. Logic input thresholds and output swings are set by the voltage at the IOVCC pin, which should be connected to the same supply as the SPI master device. A  $1\mu F$  bypass capacitor is recommended from IOVCC to DGND. The pin SDI is often referred to as MOSI, the pin SDO as MISO. The 4-wire serial port is configured to operate in a SPI system using CPHA = 1 and CPOL = 1. Consequently, data on SDI must be stable during the rising edge of SCK and data on SDO will be updated on the falling edge of SCK. The timing is depicted in Figure 7. The maximum data rate is 1Mbps. See Electrical Characteristics. SDO is open drain and requires a pull-up.

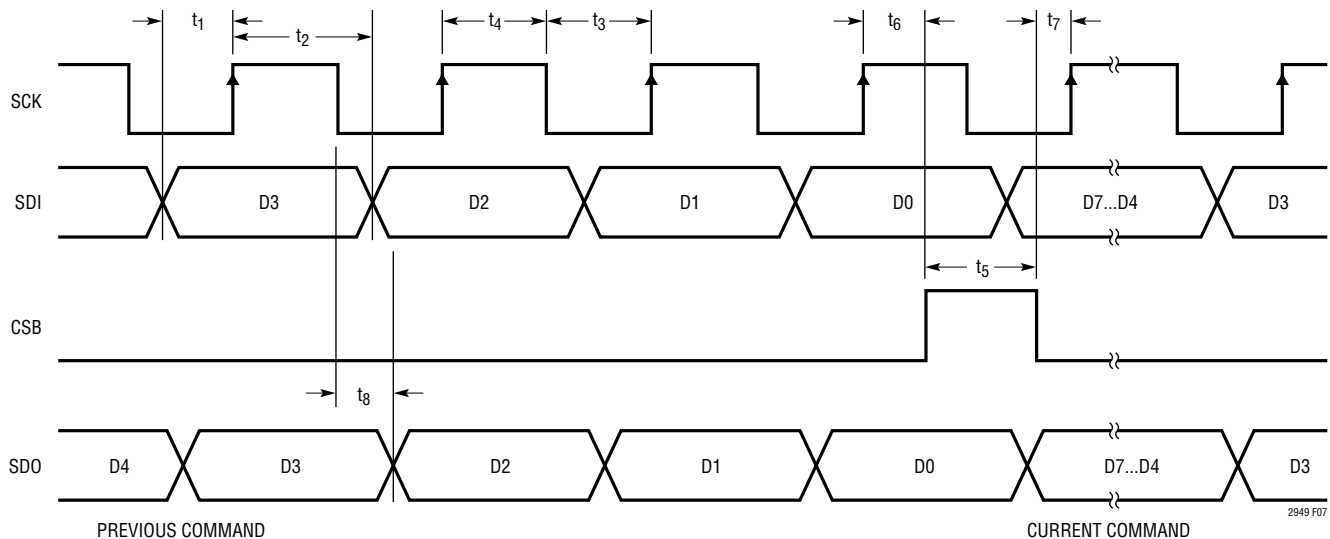


Figure 7. Timing Diagram of 4-Wire Serial Peripheral Interface



## SERIAL INTERFACES

circuit operates. A 2V reference drives the IBIAS pin. External resistors  $R_{B1}$  and  $R_{B2}$  create the reference current  $I_B$ . This current sets the drive strength of the transmitter.  $R_{B1}$  and  $R_{B2}$  also form a voltage divider of the 2V reference at the ICMP pin. This sets the threshold voltage of the receiver circuit.

### Waking Up the isoSPI Port

The isoSPI port has 3 modes of operation, IDLE, READY and ACTIVE as described in the section isoSPI State Description. In IDLE, the WAKEUP circuit monitors activity on pins IP and IM. Differential activity on IP-IM wakes up the isoSPI interface. The isoSPI port will return to the low power IDLE state if there is no activity on IP/IM for a time of  $t_{IDLE}$ . The LTC2949 will be ready to communicate when the core is not in SLEEP and the isoSPI state changes to READY (within  $t_{READY}$  after wakeup) as illustrated in Figure 3. Common mode signals will not wake up the serial interface. The interface is designed to wake up after receiving a large signal single-ended pulse, or a low-amplitude symmetric pulse. The differential signal  $|IP - IM|$ , must be at least  $V_{WAKE} = 200mV$  for a minimum duration of  $t_{DWELL} = 240ns$  to qualify as a wake up signal that powers up the serial interface.

"Long -1" or "Long +1" pulses (= drive CSB low, high) generated by LTC6820 and compatible isoSPI devices (e.g. LTC68xx Cell Monitors) will always meet this requirement. See following chapters for isoSPI pulse details.

### Selecting Bias Resistors

The adjustable signal amplitude allows the system to trade power consumption for communication robustness, and the adjustable comparator threshold allows the system to account for signal losses. The isoSPI transmitter drive current and comparator voltage threshold are set by a resistor divider ( $R_{BIAS} = R_{B1} + R_{B2}$ ) between the IBIAS and DGND. The divided voltage ( $V_{ICMP}$ ) is connected to the ICMP pin which sets the comparator threshold ( $V_{ICMP}$ ) to 1/2 of this voltage. When the isoSPI interface is enabled (not IDLE)

IBIAS is held at 2V, causing a current  $I_B$  to flow out of the IBIAS pin. The IP and IM pin drive currents are  $20 \cdot I_B$ .

As an example, if divider resistor  $R_{B1}$  is 2.8k and resistor  $R_{B2}$  is 1.21k (so that  $R_{BIAS} = 4k$ ), then:

$$I_B = \frac{2V}{R_{B1} + R_{B2}} = 0.5mA$$

$$I_{DRV} = I_{IP} = I_{IM} = 20 \cdot I_B = 10mA$$

$$V_{ICMP} = 2V \cdot \frac{R_{B2}}{R_{B1} + R_{B2}} = I_B \cdot R_{B2} = 603mV$$

$$V_{TCMP} = 0.5 \cdot V_{ICMP} = 302mV$$

In this example, the pulse drive current  $I_{DRV}$  will be 10mA, and the receiver comparators will detect pulses with IP-IM amplitudes greater than  $\pm 302mV$ . If the isolation barrier uses 1:1 transformers connected by a twisted pair and terminated with  $100\Omega$  resistors on each end, then the transmitted differential signal amplitude ( $\pm$ ) will be:

$$V_A = I_{DRV} \cdot \frac{R_M}{2} = 0.5V$$

(This result ignores transformer and cable losses, which may reduce the amplitude).

### isoSPI Pulse Detail

The transmitter can output three voltage levels:  $+V_A$ , 0V, and  $-V_A$ . A positive output results from IP sourcing current and IM sinking current across load resistor  $R_M$ . A negative voltage is developed by IP sinking and IM sourcing. When both outputs are off, the load resistance forces the differential output to 0V. To eliminate the DC signal component and enhance reliability, the isoSPI uses bipolar pulses of two different pulse length. This allows for four types of pulses to be transmitted, as shown in Table 8. A +1 pulse will be transmitted as a positive pulse followed by a negative pulse. A -1 pulse will be transmitted as a negative pulse followed by a positive pulse. The duration of each pulse is defined as  $t_{1/2PW}$ , since each is half of the required symmetric pair. (The total isoSPI pulse duration is  $2 \cdot t_{1/2PW}$ ).

## SERIAL INTERFACES

**Table 8. isoSPI Pulse Types**

| PULSE TYPE | FIRST LEVEL<br>( $t_{1/2PW}$ ) | SECOND LEVEL<br>( $t_{1/2PW}$ ) | ENDING LEVEL |
|------------|--------------------------------|---------------------------------|--------------|
| Long +1    | $+V_A$ (150ns)                 | $-V_A$ (150ns)                  | 0V           |
| Long -1    | $-V_A$ (150ns)                 | $+V_A$ (150ns)                  | 0V           |
| Short +1   | $+V_A$ (50ns)                  | $-V_A$ (50ns)                   | 0V           |
| Short -1   | $-V_A$ (50ns)                  | $+V_A$ (50ns)                   | 0V           |

An LTC6820 should be used to translate the SPI signals of a micro controller into isoSPI pulses. On the other side of the isolation barrier (i.e. at the other end of the cable), the LTC2949 will have IOVCC tied to its local GND. It receives transmitted pulses and reconstructs the SPI signals internally, as shown in Table 9. In addition, during a READ command this port may transmit return data pulses which are transmitted  $t_{RTN}$  after the received pulse. The LTC2949 isoSPI port is a slave port and only transmits short -1 pulses, never long CSB pulses nor short +1 pulses. The master port recognizes a null response as a logic 1 (for this reason a no reply to a read command is equivalent to read only 0xFF.. on the MISO line, which will also cause a PEC error, see chapters DATA LINK LAYER and following).

This allows for multiple slave devices on a single cable without risk of collisions (Multidrop). Figure 11 shows the isoSPI timing diagram for a READ command.

**Table 9. LTC2949 isoSPI Port Function**

| RECEIVED PULSE | INTERNAL SPI PORT ACTION       | RETURN PULSE                                                |
|----------------|--------------------------------|-------------------------------------------------------------|
| Long +1        | Drive CSB High                 | None                                                        |
| Long -1        | Drive CSB Low                  |                                                             |
| Short +1       | 1. Set SDI = 1<br>2. Pulse SCK | Short -1 Pulse if Reading a 0-bit                           |
| Short -1       | 1. Set SDI = 0<br>2. Pulse SCK | (No Return Pulse if Not in READ Mode or if Reading a 1-bit) |

### Supported Bus Structures

The addressing feature of the LTC2949 and LTC68xx-2 Cell Monitors allows multiple devices with different addresses to be connected on a single bus by multi-dropping them. Multi-dropping can be used in either SPI or isoSPI (See Figure 12 (A)). The LTC2949 also operates in parallel to or as last element of a daisy chain of LTC68xx Cell Monitors (See Figure 12 (B&C)).

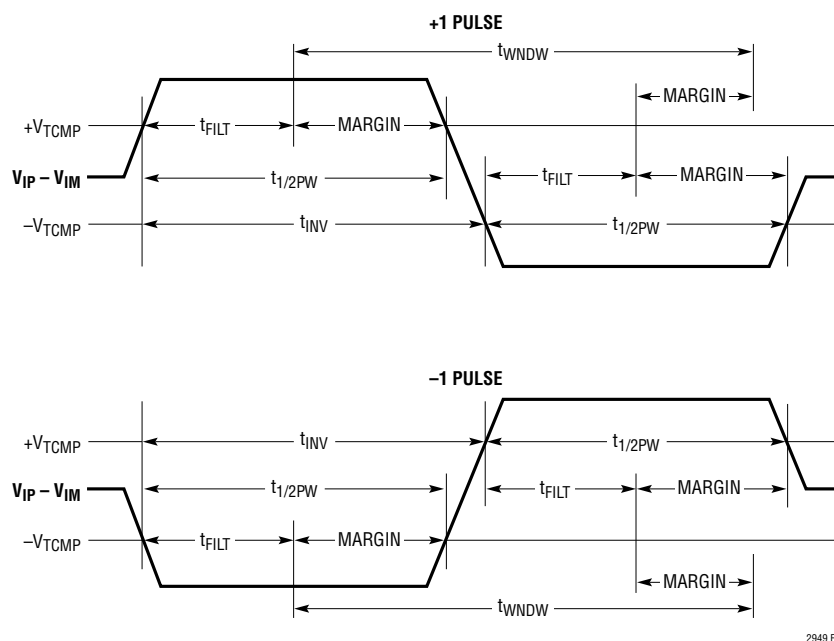


**Figure 10. isoSPI Pulse Detail**

2949 F10

## SERIAL INTERFACES

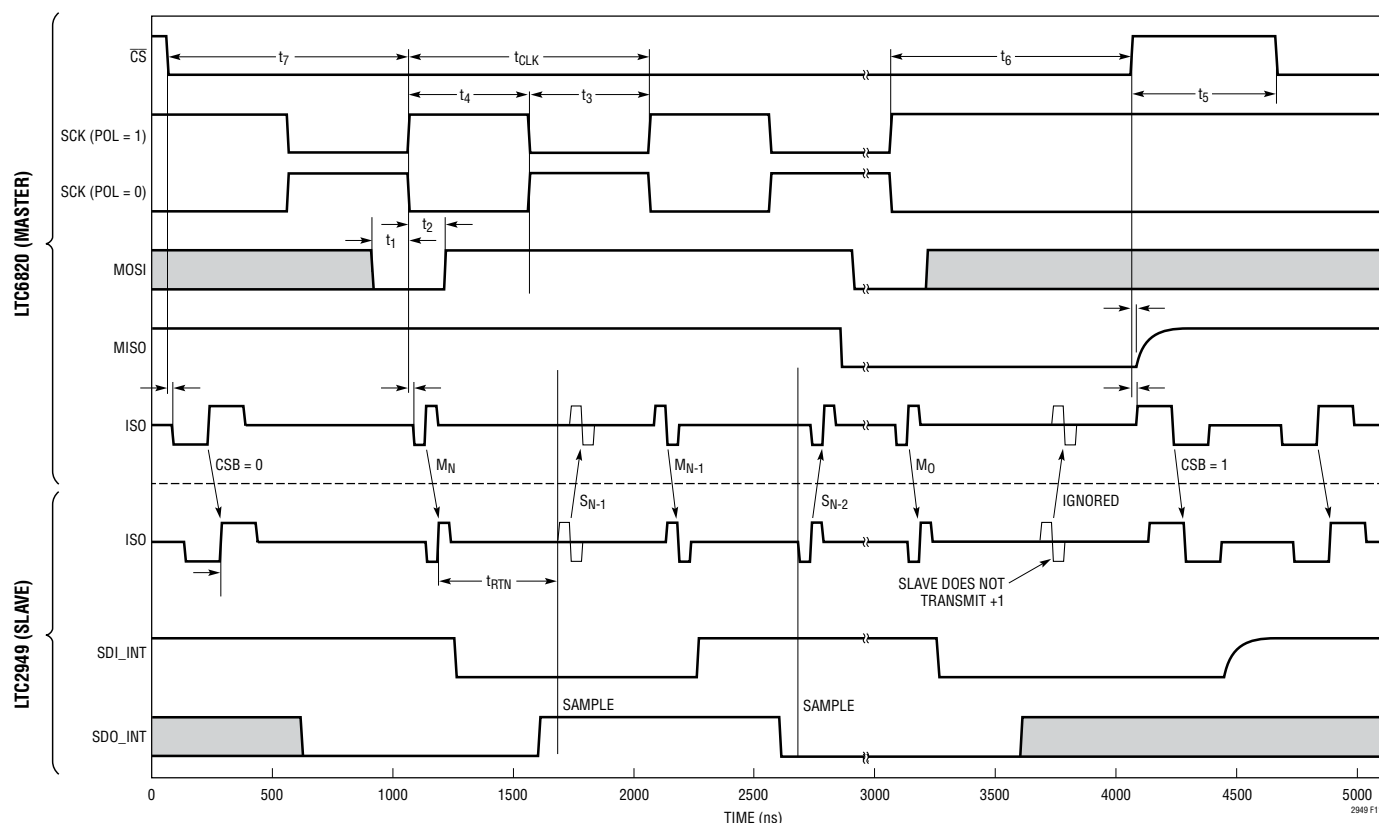


Figure 11. isoSPI Timing Diagram

## LTC2949 in Addressable/Multidrop Bus Configuration

An LTC2949 can be directly connected to the master in SPI or through an LTC6820 in isoSPI mode. When operating together with LTC68xx Cell Monitors it is recommended to use the LTC2949 in a multidrop bus configuration to take advantage of the full feature set and minimize communication overhead. The LTC2949 can operate on the same SPI/isoSPI with other LTC68xx Cell Monitors (Figure 12 (A, B)). The LTC2949 responds to address 0xF. This address is hardwired and cannot be changed. Consequently, other LTC68xx Cell Monitors on the same bus must be pin-configured to different addresses. Simultaneous writing to all devices on one bus is done by issuing a broadcast command. This feature proves useful for synchronous ADC conversions of LTC2949 and LTC68xx Cell Monitors. The common SDO pin is open drain and requires a pull-up.

## LTC2949 Connected to Reversible isoSPI Ring

LTC2949 can be connected to one end of a reversible isoSPI ring. In this scenario the default communication to LTC2949 is done with direct commands, equivalent to the scenario where LTC2949 is connected in parallel to a daisychain. In case the direct link between the left side LTC6820 and LTC2949 fails, the communication to LTC2949 can be routed through the daisychain via the right side LTC6820, equivalent to the scenario where LTC2949 is connected on top of a daisychain.

## LTC2949 on Top of a Daisy Chain

It is recommended to operate LTC2949 in parallel to a daisy chain of LTC68xx Cell Monitors in either isoSPI or normal SPI by using its addressing feature. This is the mode with the minimum communication overhead. However, also operation as last element of a daisy chain is supported.

# SERIAL INTERFACES

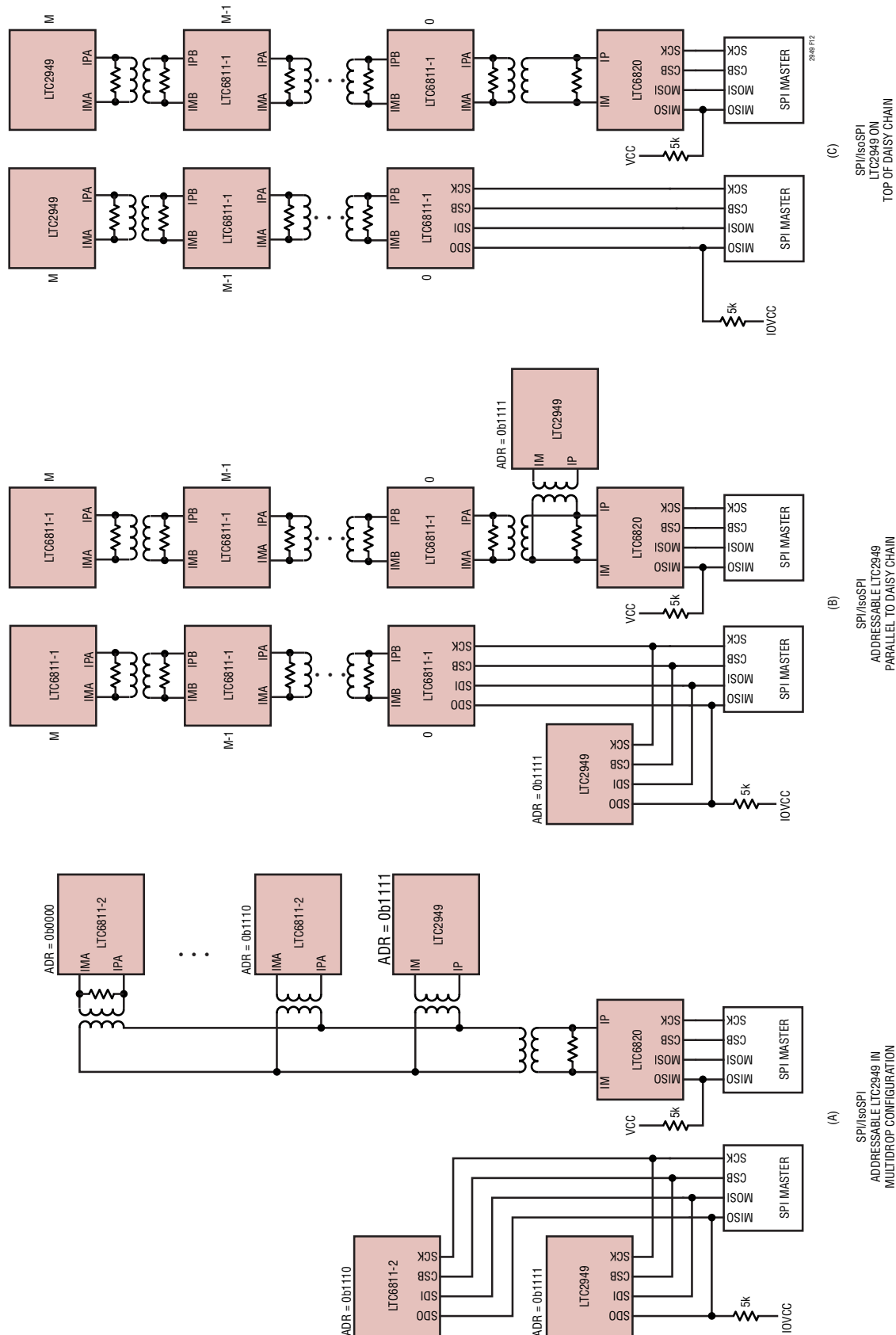


Figure 12. Supported Bus Structures. LTC6811 is shown here as an example for the whole cell monitor family LTC681x, ADBMS68xx that is supported to operate together with the LTC2949.

SERIAL INTERFACES

As the LTC2949 has only one isoSPI port it must be placed as the last (M<sup>th</sup>) element in a daisy chain. The 0<sup>th</sup> element communicates to the master via port A which can be configured as isoSPI or normal SPI mode, depending on the connection of the ISOMOD pin. The 0<sup>th</sup> element connects via port B to the 1<sup>st</sup> element of the daisy chain using isoSPI, and so on. When the LTC68xx Cell Monitor is operating with port A as SPI (ISOMD = V<sup>-</sup>), the SPI detects one of four communication events: CSB falling, CSB rising, SCK rising with SDI = 0, and SCK rising with SDI = 1. Each event is converted into one of the four pulse types for transmission through the daisy chain. Long pulses are used to transmit CSB changes and short pulses are used to transmit data, as explained in Table 8. When both ports are operated in isoSPI mode, isoSPI pulses on port A are passed to port B within a short delay.

DATA LINK LAYER

All data transfers on LTC2949 occur in byte groups. Every byte consists of 8-bits. Bytes are transferred with the most significant bit (MSB) first. CSB must remain low for the entire duration of a command sequence, including between a command byte and subsequent data. A write command takes effect after a correct PEC is processed.

NETWORK LAYER

The LTC2949 registers can be accessed by a direct read/write command (DCMD) containing the registers to be

written or read from followed by the register data – see following section Direct Read/Write Command (DCMD). Beside the DCMD, the LTC2949 supports the LTC68xx Cell Monitor compatible commands ADCV and RDCV.

When LTC2949 is the last element in an isoSPI daisy chain, the DCMD can be used to write to LTC2949 but not to read data from the device, because the DCMD is not supported by other LTC68xx Cell Monitors and thus they do not pass data from their port B to port A. Therefore, the RDCV command must be used to read from LTC2949 as element of a daisy chain. LTC2949 registers read by the RDCV command can be configured by a preceding DCMD.

Table 10 summarizes the possibilities to communicate to LTC2949.

Table 10. Communication with LTC2949

|                                 | PARALLEL TO DAISY CHAIN OR LTC2949 SOLE  | LTC2949 ON TOP OF DAISY CHAIN            |
|---------------------------------|------------------------------------------|------------------------------------------|
| Read of Registers               | DCMD                                     | Broadcast RDCV (RDCVCONF = 0, BCREN = 1) |
| Write of Registers              | DCMD                                     |                                          |
| Trigger of Fast ADC Conversion  | Addressed ADCV<br>Broadcast ADCV         |                                          |
| Read of Fast Conversion Results | Addressed RDCV (RDCVCONF = 1, BCREN = 0) | Broadcast RDCV (RDCVCONF = 1, BCREN = 1) |

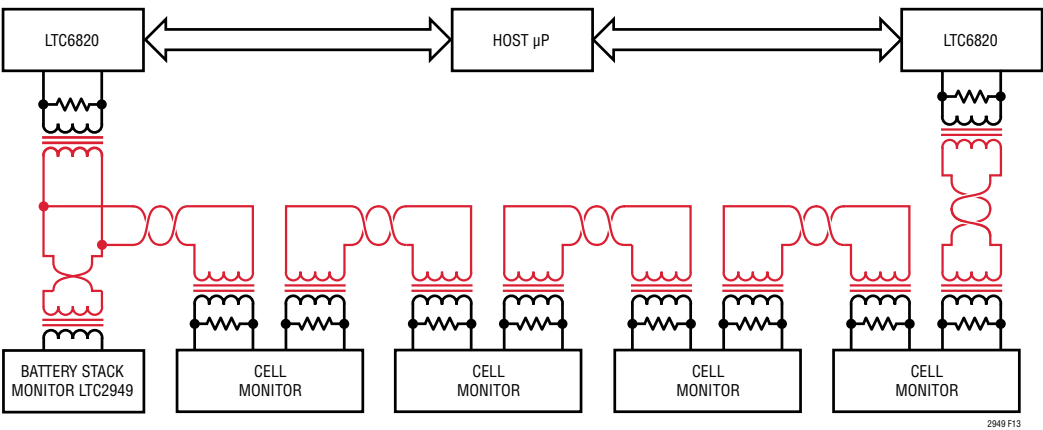


Figure 13. LTC2949 Connected to a Reversible isoSPI Ring

## SERIAL INTERFACES

### Fast Measurement Timings

The following timing diagrams shows LTC2949 fast single shot timing in relation to LTC6810's timing of the ADCV command for measuring all six cells. Other LTC681x Cell Monitors have similar timing diagram, just with different number of ADCs and cells. The LTC681x devices have several ADC modes with different filter bandwidth and accuracy. Typically, in the 7kHz normal mode, all cells are converted within a time window very close to LTC2949's fast conversion time which is nominal 782 $\mu$ s. For example, the LTC6810 converts all cells within 815 $\mu$ s in the normal mode.

As an example, only three (I2, BAT, AUX) of maximum four ADCs of LTC2949 are configured for fast conversions. The displayed timings are valid for any allowed combinations of fast channels.

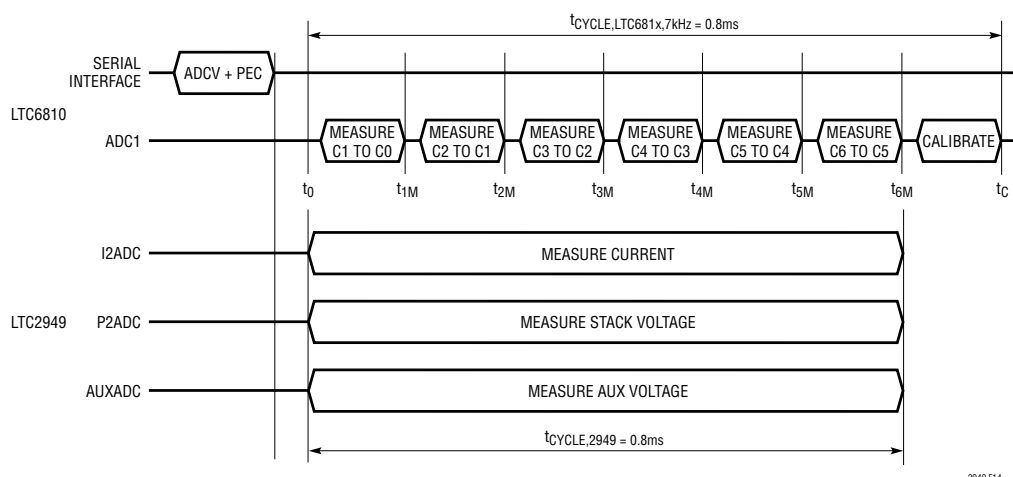


Figure 14. Timing for ADCV Command Measuring Cell Voltages and LTC2949's Current and Voltage Inputs

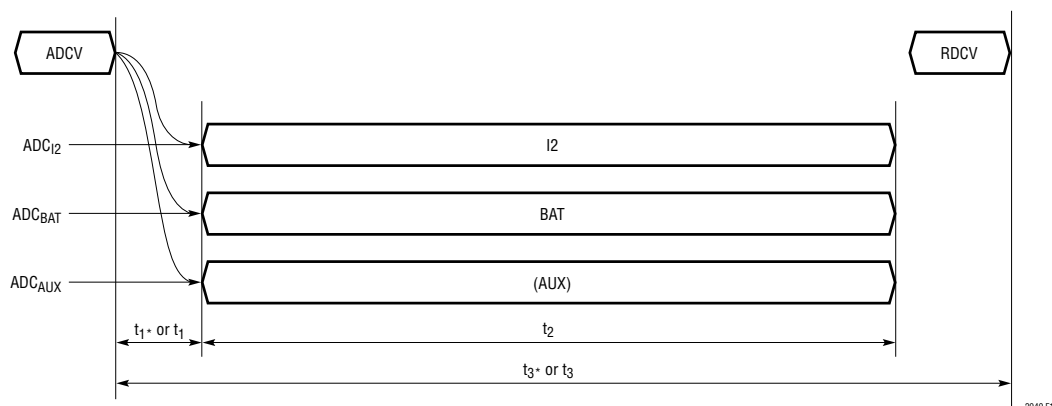


Figure 15. Timing for LTC2949's ADCV Command Measuring Current and Voltage Inputs.

| DESCRIPTION                                                                                                                      | PARAMETER | VALUE/TOLERANCE     |
|----------------------------------------------------------------------------------------------------------------------------------|-----------|---------------------|
| ADVC's last PEC byte to start of conversion latency without AUX conversion                                                       | $t_1$     | 6 to 8 $\mu$ s      |
| ADVC's last PEC byte to start of conversion latency with AUX conversion                                                          | $t_{1^*}$ | 6 to 170 $\mu$ s    |
| Conversion time                                                                                                                  | $t_2$     | 742 to 821 $\mu$ s  |
| ADVC's last PEC byte to HS = 0x0F (hand shake byte read by RDCV indicating conversion results ready, see note below) without AUX | $t_3$     | 855 to 945 $\mu$ s  |
| ADVC's last PEC byte to HS = 0x0F (hand shake byte read by RDCV indicating conversion results ready, see note below) with AUX    | $t_{3^*}$ | 855 to 1260 $\mu$ s |

## SERIAL INTERFACES

Note: If the first HS byte of the RDCV data is 0x0F, the conversion results of the very same data set are already valid. If the first HS byte of the RDCV data is 0x00, the conversion results of the very same data set are not valid. A new RDCV must be issued to check for updated conversion results. If the first HS byte of the RDCV data is 0x00 the host can continue to read HS bytes until it changes to 0x0F. The following RDCV command for sure will have valid conversion results, still, the HS byte of the very same data set will be 0x00, because it was already internally cleared after it was read 0x0F in the previous RDCV.

The following diagram shows details on LTC2949's fast continuous conversion timing. Fast continuous operation is started by a direct write command that sets bit FACONV and at least one of the channel bits (CH1, CH2, AUX) in register FACTRL.

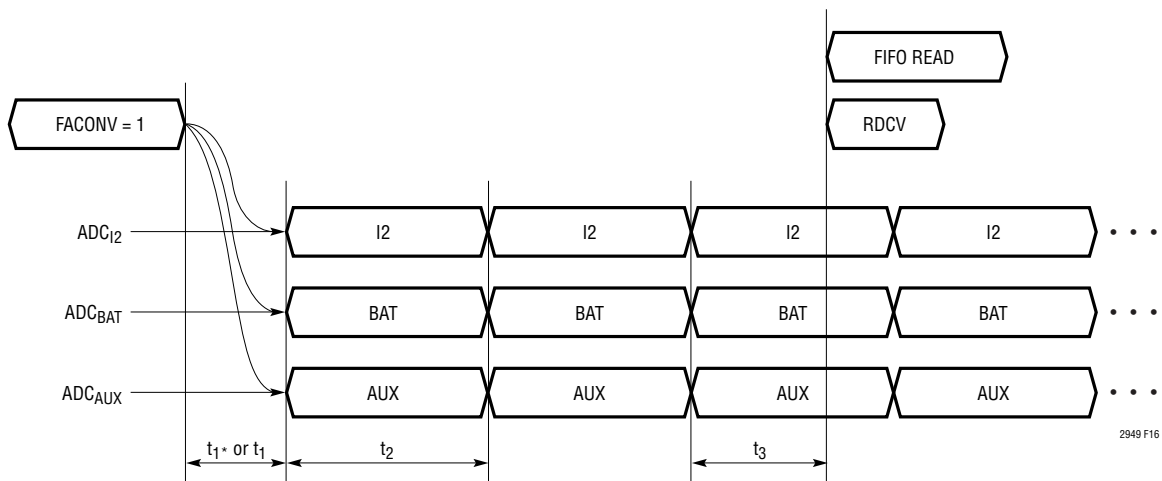


Figure 16. Timing for LTC2949's Fast Continuous Current and Voltage Measurements.

| DESCRIPTION                                                                                                                                                       | PARAMETER | VALUE/TOLERANCE    |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------|--------------------|
| Direct write's last PEC byte to start of conversion latency without AUX conversion                                                                                | $t_1$     | 6 to 8 $\mu$ s     |
| Direct write's last PEC byte to start of conversion latency with AUX conversion                                                                                   | $t_1^*$   | 6 to 170 $\mu$ s   |
| Conversion time                                                                                                                                                   | $t_2$     | 742 to 821 $\mu$ s |
| Any sample's start of conversion to $HS = 0x0F$ (hand shake byte read by RDCV indicating conversion results ready) or to sample available via FIFO read operation | $t_3$     | 0 to 315 $\mu$ s   |

## SERIAL INTERFACES

### Fast AUX Measurements

It is not possible to change the AUX MUX configuration during fast continuous mode (FCM) measurements. FAMUXP, FAMUXN can be written and the same value read back at any time, but the internal MUX will only be set to the requested configuration when receiving a new fast conversion request. This is either the ADCV command for fast single shot (FSSHT) or the transition from 0 to 1 of the FACONV bit for FCM measurements.

When leaving the FCM (FACONV = 0), the host must wait for the last conversion being completed before any new fast conversion is triggered. This can be achieved by waiting at least 1.26 ms.

If both channels are configured fast, it must be ensured that either the FCM stays active for at least 128 samples or FSSHT measurements are inhibited for at least 100ms. Only after every 128 samples / 100 ms, the slow channel registers (including STATUS, FAULTS, EXTFAULTS) are updated. In applications in which it is required to enable

and disable FACONV periodically or to perform repetitive FSSHT measurements it is recommended to configure CH1 for slow and CH2 for fast mode, which ensures the slow channel being updated periodically.

### Fast AUX Round-Robin Measurements

FSSHT measurements shall be used in applications that require different inputs via the AUX MUX at high update rates (faster than 100 ms). Optionally, the FSSHT measurements can be surrounded by FCM periods, during which a single MUX input is converted continuously. The conversion results of the FCM periods can be read via the FIFO registers or via RDCV. Reading of conversion results from FIFOs is possible at any time. Still, the FSSHT trigger command (ADCV while CONT= 1 and FACTRL unequal zero) will clear all FIFOs.

Following table shows an example sequence of 4 FSSHT measurements that interrupt a FCM period. If only FSSHT measurements are required, the rows CONT0, CONT1 can be omitted.

| NAME  | MOSI / MISO                                                                                 | DESCRIPTION                                            |
|-------|---------------------------------------------------------------------------------------------|--------------------------------------------------------|
| CONT0 | MOSI:FEF5EB50400EE4C6<br>MISO:XXXXXXXXXXXXXXXXXX                                            | Write to FACTRL to disable FCM (FACONV = 0)            |
| MUX0  | MOSI:FEF3C798450013D6E<br>MISO:XXXXXXXXXXXXXXXXXX                                           | Write two bytes to FAMUXN to select V1 vs. GND (NTC)   |
| ADCV  | MOSI:FB60FADE<br>MISO:XXXXXXXX                                                              | ADCV to trigger conversion                             |
| RDCV  | MOSI:F8040970FFFFFFFFFFFFFFFFFFFFFFFFFFFFF<br>MISO:XXXXXXXX010000000000FE4AE8180F0F0F0FC602 | RDCV to read conversion results                        |
| MUX1  | MOSI:FEF3C798450016C1BA<br>MISO:XXXXXXXXXXXXXXXXXX                                          | Write two bytes to FAMUXN to select VREF2 vs. GND      |
| ADCV  | MOSI:FB60FADE<br>MISO:XXXXXXXX                                                              | ADCV to trigger conversion                             |
| RDCV  | MOSI:F8040970FFFFFFFFFFFFFFFFFFFFFFFFFFFFF<br>MISO:XXXXXXXX000000000000C212610F0F0F0F76B6   | RDCV to read conversion results                        |
| MUX2  | MOSI:FEF3C7984517007512<br>MISO:XXXXXXXXXXXXXXXXXX                                          | Write two bytes to FAMUXN to select GND vs. VREF2_250k |
| ADCV  | MOSI:FB60FADE<br>MISO:XXXXXXXX                                                              | ADCV to trigger conversion                             |
| RDCV  | MOSI:F8040970FFFFFFFFFFFFFFFFFFFFFFFFFFFFF<br>MISO:XXXXXXXX000000000000C212E7180F0F0F0F1A78 | RDCV to read conversion results                        |

## SERIAL INTERFACES

| NAME    | MOSI / MISO                                                                               | DESCRIPTION                                                                                            |
|---------|-------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------|
| MUX3    | MOSI:FEF3C7984500174A88<br>MISO:XXXXXXXXXXXXXXXXXX                                        | Write two bytes to FAMUXN to select VREF2_250k vs. GND                                                 |
| ADCV    | MOSI:FB60FADE<br>MISO:XXXXXXXX                                                            | ADCV to trigger conversion                                                                             |
| RDCV    | MOSI:F8040970FFFFFFFFFFFFFFFFFFFFFFFFF<br>MISO:XXXXXXXX00000000000000C2121AE70F0F0F0F7C26 | RDCV to read conversion results                                                                        |
| MUXCONT | MOSI:FEF3C79845111294A6<br>MISO:XXXXXXXXXXXXXXXXXX                                        | Write two bytes to FAMUXN to select CF2P vs. CF2M (necessary to do the open wire check during the FCM) |
| CONT1   | MOSI:FEF5EB50400F6FF4<br>MISO:XXXXXXXXXXXXXXXXXX                                          | Write to FACTRL to enable FCM (FACONV = 1)                                                             |

**Note 1:** MISO data is only shown as an example and the actual data may change. 'X' indicates don't care data.

**Note 2:** A delay of  $\geq 1.26$  ms is mandatory between any ADCV and RDCV to ensure valid conversion result readings.

**Note 3:** Above MUX settings convert one external pin voltage V1 vs. GND and the internal VREF2 in three different ways. This example and can be adjusted and extended to any MUX configurations required.

**Note 4:** CONT0 and MUX0 can be merged to a single 3-write command to FAMUXN, FAMUXP, FACTRL (MOSI: 0xFEf3C7984600010E9516)

**Note 5:** When LTC2949 is in STANDBY state it can be moved to MEASURE state at any time by writing CONT=1. From the write command it takes  $t_{IDLE\_CORE}$  until the MEASURE state is active and then worst case 140ms until the first slow channel conversion results can be read from LTC2949's registers. First fast measurements can be performed, if FACTRL was configured appropriately, already when MEASURE state is active.

**Note 6:** The following sequence allows a fast and efficient initialization of LTC2949 before any fast conversions can be performed:

1. Wakeup, configure ADCCONF and perform ADJUPD as required.
2. Write 0x08 (CONT) to OPCTRL
3. 3-Byte-Write to FAMUXN (e.g. 0x00 = GND), FAMUXP (e.g. 0x16 = VREF2), FACTRL (e.g. 0x02 = FACHA or another allowed combination to perform any fast conversion)
4. Send any ADxx (e.g. ADCV, see table 17)
5. Wait at least 1.2 ms
6. Send any RDxx (e.g. RDCVA, see table 18). If HS byte is unequal 0x0F go back to 3.
7. Initialization is done. LTC2949 is now in MEASURE mode and any fast conversions can be performed subsequently (e.g. the sequence from above table)

## SERIAL INTERFACES

### Direct Read/Write Command (DCMD)

To access the full register map of the LTC2949, a special direct command (DCMD) is provided which is not used by other LTC68xx Cell Monitors. DCMD allows to read/write arbitrary number of bytes from/to LTC2949's register map. The LTC2949 auto-increments its address pointer after each data byte, so multiple registers can be written/read as part of a single transaction. Data packets from one to up to 16 bytes are interleaved by a two-byte data PEC. Data packets written without PEC are discarded. Read commands may stop at any byte.

**Table 11. Direct Read/Write Command Format**

| Byte | 0                      | 1     | 2    | 3    | 4  | 5                                                                               | ... | N+4                 | N+5  | N+6  | N+7               | ... | 2N+6                 | 2N+7 | 2N+8 | ... |
|------|------------------------|-------|------|------|----|---------------------------------------------------------------------------------|-----|---------------------|------|------|-------------------|-----|----------------------|------|------|-----|
| R/W  | Master to slave (MOSI) |       |      |      |    | Write commands: Master to slave (MOSI)<br>Read commands: Slave to master (MISO) |     |                     |      |      |                   |     |                      |      |      |     |
| Name | DCMD                   | RADDR | PEC0 | PEC1 | ID | DATA <sub>0</sub>                                                               | ... | DATA <sub>N-1</sub> | PEC0 | PEC1 | DATA <sub>N</sub> | ... | DATA <sub>2N-1</sub> | PEC0 | PEC1 | ... |

ID byte is used to distinguish between read and write commands and it defines the number of data bytes per PEC (parameter N in above table). The ID byte is not part of any PEC, instead it has intrinsic error detection via redundancy and error check bits. See following tables for details.

**Table 12. Bit Definitions of Byte ID[7:0]**

| ID[7] | ID[6]  | ID[5]               | ID[4]   | ID[3]   | ID[2]               | ID[1]   | ID[0]   |
|-------|--------|---------------------|---------|---------|---------------------|---------|---------|
| RW    | NOT RW | PECC[3] XOR PECC[2] | PECC[3] | PECC[2] | PECC[1] XOR PECC[0] | PECC[1] | PECC[0] |

**Table 13. ID[7:0] Byte Format Description**

| NAME      | DESCRIPTION                                                                                                                                                                                                                                                                                                                                      |
|-----------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| RW        | ID[7] = RW indicates read (RW=1) or write (RW=0) commands. For safe data transmission redundancy is added to ID[6] which is the inverse of RW (NOT RW, meaning 0 for read and 1 for write).                                                                                                                                                      |
| PECC[3:0] | PEC Configure determines the number of data bytes after which a PEC is transmitted. Number of data bytes is DECIMAL(PECC[3:0])+1 (parameter N in above table). Allowed values for PECC are 0 to 15 (1 to 16 data bytes per PEC). ID[5] (= PECC[3] XOR PECC[2]) and ID[2] (=PECC[1] XOR PECC[0]) are error check bits for safe data transmission. |

**Table 14. Direct Read/Write Command Format Details**

| NAME              | DESCRIPTION                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
|-------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| DCMD[7:0]         | Direct command. It is fixed to the value 0xFE.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| RADDR[7:0]        | Starting register address from which data is read or to which data is written.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| PEC0,1            | The Packet Error Code Bytes PEC0 and PEC1 hold a 15-bit CRC according to CAN BUS CRC15 which is right padded with 0 (see Table 22. Write/Read PEC Format). The PEC in bytes 2-3 is calculated on DCMD and RADDR. All following PECs are calculated on preceding M data-bytes. The number of data bytes per PEC is defined by the ID byte, which is not part of any PEC, see below.<br><br>For read commands the MOSI line is don't care, the slave will send the data PEC on its MISO line and the master must compare it to the PEC calculated on the data received. The read command was successful if both PECs match. For write commands, the master must send the PEC on its MOSI line and LTC2949 will compare the received PEC with its internal calculated PEC. In case of a PEC mismatch the data will be discarded and an external communication PEC error (EXTCOMMERR) will be flagged in the FAULTS register. |
| DATA <sub>x</sub> | Data bytes to be send to or read from LTC2949's register map. The starting address is given by RADDR and is auto-incremented for every data byte.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |

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### Commands Compatible with LTC68xx Cell Monitors (RDCV, ADCV)

The LTC2949 supports several RDCV and ADCV style commands compatible with LTC68xx Cell Monitors. RDCVA-RDCVF, RDAUXA-RDAUXD, RDCFGA, RDCFGB (all referred as RDCV commands in this document), ADCV, ADOW, ADOL, ADAX, ADAXD, ADCVAX and ADCVSC (all referred as ADCV commands in this document) are supported as broadcast and addressed commands. Addressed commands are used to address LTC2949 exclusively. To trigger actions on LTC2949 and LTC68xx Cell Monitors simultaneously, broadcast commands are used. This is for example useful to initiating ADC conversions of several devices at the same time. No matter if LTC2949 is connected parallel to or on top of a daisy chain, addressed ADCV commands can trigger measurements on LTC2949 only and broadcast ADCV commands can perform synchronous ADC conversions on all devices connected to the SPI / isoSPI bus. The conversion starts at the end of the PEC for all devices.

In cases where LTC2949 is connected parallel to a daisy chain, direct read commands (DCMD) must be used to read register data and addressed RDCV commands (with RDCVCONF=1) must be used to read the last fast conversion results. If LTC2949 is connected on top of a daisy chain, broadcast RDCV commands must be used to read register data (RDCVCONF=0) or to read the last fast conversion results (RDCVCONF=1) depending on setting of REGSCTRL.RDCVCONF. Write to LTC2949's register map is always done with direct write commands (DCMD) independent of the bus topology. See Table 10 (Communication with LTC2949) for a summary of all possible communication scenarios.

Before LTC2949 can react on ADCV commands it must be running in slow continuous measurement mode (bit CONT in OPCTRL), at least one fast measurement channel must be selected via the Fast Control Register (FACTRL) and optionally, to make also fast BAT conversions via one of the power ADCs (P1 or P2 in voltage mode), P1ASV and/or P2ASV in the ADC configuration register (ADCCONF) must be set. If LTC2949 is running in fast continuous mode (FACONV=1) any ADCV command is ignored and

acquired samples can be read from the FIFO registers (FIFO1, FIFO2, FIFOBAT, FIFOAUX). Still, also in this mode, it is possible to read the last fast conversion results via RDCV (RDCVCONF=1). If fast continuous mode is disabled (FACONV=0), any ADCV command will clear all FIFOs. If needed, samples within FIFOs should be read before sending an ADCV command while FACONV is cleared.

In the configuration where LTC2949 is on top of a daisy chain, after a broadcast RDCV command, the stacked LTC68xx Cell Monitors turn into a cascaded shift register, in which data is shifted through each device to the next device in the stack. In this scenario, LTC2949 responds to RDCV commands only if the Broadcast Read Enable bit (BCREN) in the Register Control Register (REGSCTRL) is set.

In the scenario where LTC2949 is placed in parallel to a daisy chain of LTC68xx Cell Monitors, the bit BCREN must be cleared (default) to avoid bus collisions. Still, any broadcast RDCV may clear LTC2949's internal HS byte (see below) if the bit RDCVCONF is set, no matter if BCREN is set or not. For this reason, it is recommended to read LTC2949's fast conversion results before reading from the LTC68xx Cell Monitors. Or, if for software timing reasons it is necessary to read from the LTC68xx Cell Monitors first, the bit RDCVCONF must be cleared before (it must be set again afterwards to read fast conversion data from LTC2949).

The last results of any fast conversion can be read out by the RDCV command, providing sequentially the results of I1, I2, BAT and AUX (least significant bytes first to be compatible with LTC68xx Cell Monitors) followed by one or more hand shake (HS) bytes, indicating if the data is new (0x0F) or old (0x00). Once LTC2949 sends the HS byte, it will continue sending it as long as the master is reading bytes. Still, a PEC will always be send for every 6 data bytes. Per transaction, the HS byte may only change from 0x00 to 0x0F, once it is 0x0F it won't change. This allows the master to poll for conversion results being ready by checking for a transition of the HS byte from 0x00 to 0x0F. If the first HS byte is 0x0F the conversion data received with that command is already new and valid. If the first HS byte is 0x00 the data received in the same transaction was not yet updated. A subsequent RDCV

## SERIAL INTERFACES

command is necessary to read the updated conversion results, still, the HS byte will be reported as 0x00 for this RDCV command, as it was internally already cleared after it was read 0x0F with the previous RDCV.

LTC2949's fast conversion time is typically 0.8ms. Additional processing time is necessary for the results being ready to be read by the master. Worst case, 1.26 ms after a conversion was triggered, the results can be read via a FIFO register (in case of fast continuous mode) or via the RDCV command. For fast single shot measurements, this limits the maximum guaranteed sample rate to ~0.8ksps.

For fast continuous measurement, the sample rate is fixed to 1.25ksps and the mentioned delay is just a latency between the actual measurements and the time the samples are available to be read. The master shall wait at least 1.26ms between the time fast continuous mode is enabled and the first time any FIFO register is read, to allow the first sample to be read from the FIFO. Alternatively, it is also possible to use a RDCV command to check when the first sample is ready (see HS byte above) and then read all samples from the FIFO registers periodically.

**Table 15. Format of ADCV/RDCV Style Commands. Only for RDCV Commands the Slave Sends Data to the Master on the MISO Line**

| BYTE | 0                      | 1    | 2    | 3    | 4                      | ... | 9     | 10   | 11   | 12    | ... | 17     | 18   | 19   | ... |
|------|------------------------|------|------|------|------------------------|-----|-------|------|------|-------|-----|--------|------|------|-----|
| R/W  | Master to slave (MOSI) |      |      |      | Slave to master (MISO) |     |       |      |      |       |     |        |      |      |     |
| Name | CMD0                   | CMD1 | PEC0 | PEC1 | DATA0                  | ... | DATA6 | PEC0 | PEC1 | DATA7 | ... | DATA11 | PEC0 | PEC1 | ... |

CMD0 and CMD1 are the command bytes. The format for the commands is shown in Table 16. CC[10:0] is the 11-bit command code. A list of supported command codes is shown in Table 17 and Table 18. Broadcast commands have a value 0, addressed commands have a value 1 for CMD0[7] through CMD0[3]. The PEC must be computed on the entire 16-bit command (CMD0 and CMD1).

**Table 16. CMD0, CMD1 Command Bytes Format. Data is Send from Master to Slave (MOSI). A/B is 0 for Broadcast and 1 for Addressed Commands.**

| NAME | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2  | BIT 1 | BIT 0 |
|------|-------|-------|-------|-------|-------|--------|-------|-------|
| CMD0 | A/B   | A/B   | A/B   | A/B   | A/B   | CC[10] | CC[9] | CC[8] |
| CMD1 | CC[7] | CC[6] | CC[5] | CC[4] | CC[3] | CC[2]  | CC[1] | CC[0] |

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**Table 17. ADCV Style Commands. LTC2949 Performs a Fast Conversion Depending on FACTRL/ADCCONF Registers Upon Those Commands**

| NAME   | CMD0[7:3]        | CC[10:0]              | DESCRIPTION                                                                                                      |
|--------|------------------|-----------------------|------------------------------------------------------------------------------------------------------------------|
| ADCV   | Broadcast: all 0 | 0 1 x x 1 1 x 0 x x x | LTC2949 reacts to all commands in the same way by triggering a fast conversion (if enabled via FACTRL register). |
| ADOW   | Addressed: all 1 | 0 1 x x x 1 x 1 x x x |                                                                                                                  |
| ADOL   |                  | 0 1 x x 0 0 x 0 0 0 1 |                                                                                                                  |
| ADAX   |                  | 1 0 x x 1 1 0 0 x x x |                                                                                                                  |
| ADAXD  |                  | 1 0 x x 0 0 0 0 x x x |                                                                                                                  |
| ADCVAX |                  | 1 0 x x 1 1 x 1 1 1 1 |                                                                                                                  |
| ADCVSC |                  | 1 0 x x 1 1 x 0 1 1 1 |                                                                                                                  |

**Table 18. RDCV Style Commands. Used to Read Fast Conversion Results or for Indirect Memory Map Reads from LTC2949**

| NAME   | CMD0[7:3]        | CC[10:0]              | DESCRIPTION                                                                                                                                                       |
|--------|------------------|-----------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| RDCFGA | Broadcast: all 0 | 0 0 0 0 0 0 0 0 0 1 0 | LTC2949 reacts to all commands in the same way by either transmitting fast conversion results (default, RDCVCONF=1) or by transmitting register data (RDCVCONF=0) |
| RDCFGB | Addressed: all 1 | 0 0 0 0 0 1 0 0 1 1 0 |                                                                                                                                                                   |
| RDCVA  |                  | 0 0 0 0 0 0 0 0 1 0 0 |                                                                                                                                                                   |
| RDCVB  |                  | 0 0 0 0 0 0 0 0 1 1 0 |                                                                                                                                                                   |
| RDCVC  |                  | 0 0 0 0 0 0 0 1 0 0 0 |                                                                                                                                                                   |
| RDCVD  |                  | 0 0 0 0 0 0 0 1 0 1 0 |                                                                                                                                                                   |
| RDCVE  |                  | 0 0 0 0 0 0 0 1 0 0 1 |                                                                                                                                                                   |
| RDCVF  |                  | 0 0 0 0 0 0 0 1 0 1 1 |                                                                                                                                                                   |
| RDAUXA |                  | 0 0 0 0 0 0 0 1 1 0 0 |                                                                                                                                                                   |
| RDAUXB |                  | 0 0 0 0 0 0 0 1 1 1 0 |                                                                                                                                                                   |
| RDAUXC |                  | 0 0 0 0 0 0 0 1 1 0 1 |                                                                                                                                                                   |
| RDAUXD |                  | 0 0 0 0 0 0 0 1 1 1 1 |                                                                                                                                                                   |

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The RDCV command allows reading data packets much longer than the daisy chain shift register. The length of the shift register is  $64 \cdot M$  bits, whereas  $M$  is the number of elements in the chain excluding LTC2949. Data from the LTC2949 is received by the master after  $64 \cdot M$  data bits starting with bit I1[7] according to the figure below. A PEC is calculated after every 6 data bytes. After the transmission of the conversions results, the LTC2949 continuously sends the hand shake byte (HS) indicating if the data is new (0x0F) or old (0x00). A transition of the hand shake byte from 0x00 to 0x0F indicates the arrival of new data, which can be read out by a subsequent RDCV command.

**Table 19. RDCV Command Format. CMD0, CMD1 According to Table 18 (RDCV Style Commands). Requires RDCVCONF=1.**

| CMD0      | CMD1 | PEC0 | PEC1     | I1[7:0]   | I1[15:8] | I2[7:0] | I2[15:8] | BAT[7:0] |
|-----------|------|------|----------|-----------|----------|---------|----------|----------|
| BAT[15:8] | PEC0 | PEC1 | AUX[7:0] | AUX[15:8] | HS       | HS      | HS       | HS       |
| PEC0      | PEC1 | HS   | HS       | HS        | HS       | HS      | HS       | PEC0     |
| PEC1      | HS   | HS   | HS       | HS        | HS       | HS      | .....    |          |

Note: The conversion results I1, I2, BAT, AUX are converted to volts by multiplication with the LSB size  $7.60371 \mu\text{V}$  for the current and  $375.183 \mu\text{V}$  for the BAT and AUX channel.

### Indirect Memory Access RDCV Command

DCMD is the recommended way of reading data from the LTC2949 in addressable mode. When LTC2949 is the last element in a daisy chain, an RDCV has to be used to read data from the LTC2949, as DCMD is not supported by LTC68xx Cell Monitors and therefore does not configure them as shift registers. In default, the LTC2949 will respond to RDCV with the fast mode conversion results as described above (RDCVCONF = 1).

In order to gain access to the entire register map of LTC2949 an address pointer can be set causing the LTC2949 to provide data starting at that register address on subsequent RDCV commands. To use this indirect memory access RDCV command, the RDCV Configuration Bit (RDCVCONF) has to be reset and Broadcast Read Enable bit (BCREN) has to be set in REGSCTRL and the starting pointer must be written to the RDCV Indirect Address Register (RDCVIADDR). In this way any register can be read by subsequent RDCV commands. The address pointer is auto-incremented after every data byte for reading data bursts of any length. A PEC is transmitted after every six data bytes. Once the REGSCTRL is written accordingly, only the Indirect Address Register must be updated to read from other memory locations.

Please note that the RDCVIADDR can also be written before the REGSCTRL if a single DCMD spanning from RDCVIADDR to REGSCTRL is used. For this single write burst, the two bytes between RDCVIADDR and REGSCTRL are don't care and can be written 0x00.

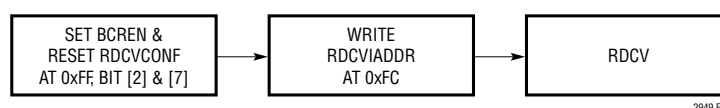


**Figure 17. Indirect Memory Access Read Procedure Using RDCV Command**

**Table 20. Indirect Address RDCV Command Format, CMD0, CMD1 According to Table 18 (RDCV Style Commands), Requires RDCVCONF = 0 and BCREN = 1**

|                   |      |       |                   |                   |                   |                   |                    |                    |
|-------------------|------|-------|-------------------|-------------------|-------------------|-------------------|--------------------|--------------------|
| CMD0              | CMD0 | PEC0  | PEC1              | DATA <sub>0</sub> | DATA <sub>1</sub> | DATA <sub>2</sub> | DATA <sub>3</sub>  | DATA <sub>4</sub>  |
| DATA <sub>5</sub> | PEC0 | PEC1  | DATA <sub>6</sub> | DATA <sub>7</sub> | DATA <sub>8</sub> | DATA <sub>9</sub> | DATA <sub>10</sub> | DATA <sub>11</sub> |
| PEC0              | PEC1 | ..... |                   |                   |                   |                   |                    |                    |

DATA<sub>0</sub> is the content of the register at the starting address that was written to RDCVIADDR. DATA<sub>1</sub> is the content of the register at the following address and so on.

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### Packet Error Code

The packet error code (PEC) is a 15-bit cyclic redundancy check (CRC) value calculated for all of the bits in a register group in the order they are passed, using the initial PEC seed value of 000000000010000 and the following characteristic polynomial:  $x^{15} + x^{14} + x^{10} + x^8 + x^7 + x^4 + x^3 + 1$ . To calculate the 15-bit PEC value, a simple procedure can be established:

1. Initialize the PEC to 000000000010000 (PEC is a 15-bit register group)
2. For each bit DIN coming into the PEC register group, set
  - IN0 = DIN XOR PEC [14]
  - IN3 = IN0 XOR PEC [2]
  - IN4 = IN0 XOR PEC [3]
  - IN7 = IN0 XOR PEC [6]
  - IN8 = IN0 XOR PEC [7]
  - IN10 = IN0 XOR PEC [9]
  - IN14 = IN0 XOR PEC [13]
3. Update the 15-bit PEC as follows
  - PEC [14] = IN14,
  - PEC [13] = PEC [12],
  - PEC [12] = PEC [11],
  - PEC [11] = PEC [10],
  - PEC [10] = IN10,
  - PEC [9] = PEC [8],
  - PEC [8] = IN8,
  - PEC [7] = IN7,
  - PEC [6] = PEC [5],
  - PEC [5] = PEC [4],
  - PEC [4] = IN4,
  - PEC [3] = IN3,
  - PEC [2] = PEC [1],
  - PEC [1] = PEC [0],
  - PEC [0] = IN0
4. Go back to step 2 until all the data is shifted. The final PEC (16-bits) is the 15-bit value in the PEC register right padded with 0. An example to calculate the PEC for a 16-bit word (0x0001) is listed in Table 21. The PEC for 0x0001 is computed as 0x3D6E after stuffing a 0-bit at the LSB. For longer data streams, the PEC is valid at the end of the last bit of data sent to the PEC register. LTC2949 calculates PEC for any command or data received and compares it with the PEC following the command or data. The command or data is regarded as valid only if the PEC matches. LTC2949 also attaches the calculated PEC at the end of the data it shifts out. Table 22 shows the format of PEC while writing to or reading from LTC2949.

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**Table 21. PEC Calculation for 0x0001**

|             |   |   |   |   |   |   |   |   |   |   |    |    |    |    |    |    |    |                 |
|-------------|---|---|---|---|---|---|---|---|---|---|----|----|----|----|----|----|----|-----------------|
| PEC[14]     | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1  | 1  | 1  | 1  | 1  | 0  | 0  | <b>0</b>        |
| PEC[13]     | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0  | 0  | 0  | 0  | 1  | 1  | 0  | <b>0</b>        |
| PEC[12]     | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0  | 0  | 0  | 1  | 1  | 0  | 1  | <b>1</b>        |
| PEC[11]     | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0  | 0  | 1  | 1  | 0  | 1  | 1  | <b>1</b>        |
| PEC[10]     | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0  | 1  | 1  | 0  | 1  | 1  | 1  | <b>1</b>        |
| PEC[9]      | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0  | 0  | 1  | 0  | 0  | 0  | 1  | <b>1</b>        |
| PEC[8]      | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0  | 1  | 0  | 0  | 0  | 1  | 0  | <b>0</b>        |
| PEC[7]      | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 1  | 1  | 1  | 0  | 1  | 1  | <b>1</b>        |
| PEC[6]      | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 0  | 0  | 1  | 0  | 0  | 0  | <b>0</b>        |
| PEC[5]      | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 0  | 1  | 0  | 0  | 0  | 1  | <b>1</b>        |
| PEC[4]      | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 1  | 0  | 0  | 0  | 1  | 1  | <b>1</b>        |
| PEC[3]      | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 1  | 1  | 1  | 0  | 0  | 0  | <b>0</b>        |
| PEC[2]      | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 0  | 0  | 1  | 1  | 1  | 1  | <b>1</b>        |
| PEC[1]      | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 0  | 1  | 1  | 1  | 1  | 1  | <b>1</b>        |
| PEC[0]      | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 1  | 1  | 1  | 1  | 1  | 1  | <b>1</b>        |
| IN14        | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1  | 1  | 1  | 1  | 0  | 0  |    | <b>0</b>        |
| IN10        | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 1  | 1  | 0  | 1  | 1  | 1  |    | <b>PEC Word</b> |
| IN8         | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 1  | 0  | 0  | 0  | 1  | 0  |    |                 |
| IN7         | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1  | 1  | 1  | 0  | 1  | 1  |    |                 |
| IN4         | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1  | 0  | 0  | 0  | 1  | 1  |    |                 |
| IN3         | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1  | 1  | 1  | 0  | 0  | 0  |    |                 |
| IN0         | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1  | 1  | 1  | 1  | 1  | 1  |    |                 |
| DIN         | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0  | 0  | 0  | 0  | 0  | 1  |    |                 |
| Clock Cycle | 0 | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 |                 |

**Table 22. Write/Read PEC Format**

| NAME | RD/WR | Bit 7   | Bit 6   | Bit 5   | Bit 4   | Bit 3   | Bit 2  | Bit 1  | Bit 0  |
|------|-------|---------|---------|---------|---------|---------|--------|--------|--------|
| PEC0 | RD/WR | PEC[14] | PEC[13] | PEC[12] | PEC[11] | PEC[10] | PEC[9] | PEC[8] | PEC[7] |
| PEC1 | RD/WR | PEC[6]  | PEC[5]  | PEC[4]  | PEC[3]  | PEC[2]  | PEC[1] | PEC[0] | 0      |

### Improved PEC Calculation

The PEC allows the user to have confidence that the serial data read from the LTC2949 is valid and has not been corrupted by any external noise source. This is a critical feature for reliable communication and the LTC2949 requires that a PEC be calculated for all data being read from and written to the LTC2949. For this reason it is important to have an efficient method for calculating the PEC. The code below demonstrates a simple implementation of a lookup table

derived PEC calculation method. There are two functions, the first function `init_PEC15_Table()` should only be called once when the microcontroller starts and will initialize a PEC15 table array called `pec15Table[]`. This table will be used in all future PEC calculations. The `pec15` table can also be hard coded into the microcontroller rather than running the `init_PEC15_Table()` function at startup. The `pec15()` function calculates the PEC and will return the correct 15-bit PEC for byte arrays of any given length.

**SERIAL INTERFACES**

```
/******
```

```
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```

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PERFORMANCE OF THIS SOFTWARE.
```

```
*****/
```

```
int16 pec15Table[256];  
int16 CRC15_POLY = 0x4599;  
void init_PEC15_Table()  
{  
    for (int i = 0; i < 256; i++)  
    {  
        remainder = i << 7;  
        for (int bit = 8; bit > 0; --bit)  
        {  
            if (remainder & 0x4000)  
            {  
                remainder = ((remainder << 1));  
                remainder = (remainder ^ CRC15poly)  
            }  
            else  
            {  
                remainder = ((remainder << 1));  
            }  
        }  
        pec15Table[i] = remainder&0xFFFF;  
    }  
}  
  
unsigned int16 pec15 (char *data , int len)  
{  
    int16 remainder,address;  
  
    remainder = 16; //PEC seed  
    for (int i = 0; i < len; i++)  
    {  
        address = ((remainder >> 7) ^ data[i]) & 0xff; //calculate PEC table address  
        remainder = (remainder << 8 ) ^ pec15Table[address];  
    }  
    return (remainder*2); //The CRC15 has a 0 in the LSB so the final value must be multiplied by 2  
}
```

| PAGE 1 |       |     |            |     |       |     |                |     |       |     |                |     |       |     |                |     |
|--------|-------|-----|------------|-----|-------|-----|----------------|-----|-------|-----|----------------|-----|-------|-----|----------------|-----|
|        | 0x0   | 0x1 | 0x2        | 0x3 | 0x4   | 0x5 | 0x6            | 0x7 | 0x8   | 0x9 | 0xA            | 0xB | 0xC   | 0xD | 0xE            | 0xF |
| 0x0    | C1TH  |     | 0x7FFFFFFF |     | E1TH  |     | 0x800000000000 |     | C1TL  |     | 0x800000000000 |     | E1TL  |     | 0x800000000000 |     |
| 0x10   | C2TH  |     | 0x7FFFFFFF |     | E2TH  |     | 0x800000000000 |     | C2TL  |     | 0x800000000000 |     | E2TL  |     | 0x800000000000 |     |
| 0x20   | C3TH  |     | 0x7FFFFFFF |     | E3TH  |     | 0x800000000000 |     | C3TL  |     | 0x800000000000 |     | E3TL  |     | 0x800000000000 |     |
| 0x30   | C4TH  |     | 0x7FFFFFFF |     | E4TH  |     | 0x800000000000 |     | C4TL  |     | 0x800000000000 |     | E4TL  |     | 0x800000000000 |     |
| 0x40   | C5TH  |     | 0x7FFFFFFF |     | E5TH  |     | 0x800000000000 |     | C5TL  |     | 0x800000000000 |     | E5TL  |     | 0x800000000000 |     |
| 0x50   | C6TH  |     | 0x7FFFFFFF |     | E6TH  |     | 0x800000000000 |     | C6TL  |     | 0x800000000000 |     | E6TL  |     | 0x800000000000 |     |
| 0x60   | C7TH  |     | 0x7FFFFFFF |     | E7TH  |     | 0x800000000000 |     | C7TL  |     | 0x800000000000 |     | E7TL  |     | 0x800000000000 |     |
| 0x70   | C8TH  |     | 0x7FFFFFFF |     | E8TH  |     | 0x800000000000 |     | C8TL  |     | 0x800000000000 |     | E8TL  |     | 0x800000000000 |     |
| 0x80   | C9TH  |     | 0x7FFFFFFF |     | E9TH  |     | 0x800000000000 |     | C9TL  |     | 0x800000000000 |     | E9TL  |     | 0x800000000000 |     |
| 0x90   | C10TH |     | 0x7FFFFFFF |     | E10TH |     | 0x800000000000 |     | C10TL |     | 0x800000000000 |     | E10TL |     | 0x800000000000 |     |
| 0xA0   | C11TH |     | 0x7FFFFFFF |     | E11TH |     | 0x800000000000 |     | C11TL |     | 0x800000000000 |     | E11TL |     | 0x800000000000 |     |
| 0xB0   | C12TH |     | 0x7FFFFFFF |     | E12TH |     | 0x800000000000 |     | C12TL |     | 0x800000000000 |     | E12TL |     | 0x800000000000 |     |
| 0xC0   | C13TH |     | 0x7FFFFFFF |     | E13TH |     | 0x800000000000 |     | C13TL |     | 0x800000000000 |     | E13TL |     | 0x800000000000 |     |
| 0xD0   | C14TH |     | 0x7FFFFFFF |     | E14TH |     | 0x800000000000 |     | C14TL |     | 0x800000000000 |     | E14TL |     | 0x800000000000 |     |
| 0xE0   | C15TH |     | 0x7FFFFFFF |     | E15TH |     | 0x800000000000 |     | C15TL |     | 0x800000000000 |     | E15TL |     | 0x800000000000 |     |
| 0xF0   | C16TH |     | 0x7FFFFFFF |     | E16TH |     | 0x800000000000 |     | C16TL |     | 0x800000000000 |     | E16TL |     | 0x800000000000 |     |

- = reserved registers can be used to store custom data to external EEPROM
- = registers can be used to store custom data to external EEPROM, if they are initialized by the host controller after EEPROM restore.

See chapter "External EEPROM Control Register" for more details on using the optional external EEPROM

**Figure 18. Register Map**

## REGISTER DESCRIPTION

### Register Naming Conventions

|    |                 |     |                  |
|----|-----------------|-----|------------------|
| RW | Read-Write      | DEF | Default Value    |
| RO | Read Only       | SI  | Signed Integer   |
| SO | Set Only (Note) | UI  | Unsigned Integer |

Note: Write 1 to SO bits to request the associated action. Successful write can be checked by a read command directly following the write command. After the action was performed the SO bit will be cleared automatically by LTC2949. Do not write to registers with SO bits, before all SO bits were read as 0. The typical processing time per action is  $t_{IDLE\_CORE}$  or  $t_{CONT}$  depending on operation mode, see related bit description for details.

### MEMORY MAP AND PAGING MECHANISM

The memory map of the LTC2949 is organized in two pages, PAGE0 and PAGE1. PAGE0 contains all slow channel result quantities, control and status registers while PAGE1 contains all threshold and configuration registers. Each page has a register address space ranging from 0x00 to 0xFF, with each register consisting of one 8-bit byte of data. Registers 0xF0 to 0xFF are common to both register pages. Register REGSCTRL at 0xFF is part of this range and is used to switch between pages, see below. For clarity, all register addresses on PAGE1 are expressed as p1.0xYY in the following while addresses on PAGE0 are simply referred to as 0xYY.

Multiple-byte data is stored with most significant byte at the lowest address (little-endian). For instance, the MSB C1[47:40] of the quantity C1 is stored at address 0x00 in PAGE0.

Note that reading data from LTC2949's memory map (no matter if using direct command or indirect memory access RDCV command with RDCVCONF=0) reports MSBytes first, while reading fast conversion results via RDCV (RDCVCONF=1) reports LSBytes first.

Some addresses in the register map are not used and are reserved. Bits in non-reserved registers that are not explicitly described are also reserved. Writing to unused reserved registers or reserved bits in non-reserved registers may result in unwanted behavior of the LTC2949, reserved bits in non-reserved registers should be written as 0; reading of unused registers is generally harmless but will return random data. If software detection of device revision is necessary, then contact the factory for details.

### Register Control Register

The Register Control Register (0xFF) selects the active memory page, allows to configure the LTC2949 to respond to broadcast read commands, configures the RDCV command to indirect memory access mode and provides a memory locking mechanism.

**Table 23. Control Register REGSCTRL (0xFF)**

| BIT   | SYMBOL   | TYPE | DEFAULT | OPERATION                                                                                                                                                                                               |
|-------|----------|------|---------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 0     | PAGE     | RW   | 0       | Memory Map Page Select<br>0: PAGE0 of the memory map is selected.<br>1: PAGE1 of the memory map is selected.                                                                                            |
| 2     | BCREN    | RW   | 0       | Broadcast Read Enable<br>0: LTC2949 does not respond to broadcast read commands<br>1: LTC2949 responds to broadcast read commands                                                                       |
| [5:4] | MLK[1:0] | RW   | 00      | Memory Lock<br>00: Memory not locked<br>01: Memory lock requested by master<br>10: Memory locked                                                                                                        |
| 7     | RDCVCONF | RW   | 1       | RDCV Configuration Bit<br>0: Indirect memory access mode. RDCV will report data starting at address written to RDCVIADDR (0xFC).<br>1: RDCV command will report latest fast channel conversion results. |

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## REGISTER DESCRIPTION

LTC2949 provides a mechanism to lock the memory to keep coherency between registers when accessing the memory. A memory locking can be requested by the master by setting bits MLK[1:0] to 01. Now the LTC2949 updates its registers, e.g. with measurement results. During this time, read and write access to the LTC2949 memory apart from registers REGSCTR and RDCVIADDR is blocked. After all registers are updated by the LTC2949, it sets MLK[1:0] to 10 to indicate to the Master that memory is locked. The LTC2949 does not update the memory map any more until the master unlocks the memory by writing MLK[1:0] to 00.

The LTC2949's internal memory is still updated while the memory is locked and thus accumulation of values and updating of alerts is not interrupted. Once the memory is locked the master can read consistent data even by single byte access. Data does not change between those single read transactions. It is also possible to manipulate result parameter values e. g. to set a certain start value for Charge

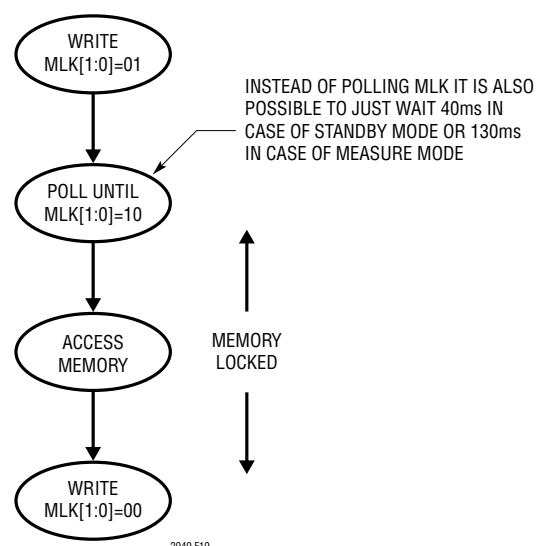


**Figure 19. Memory Locking**

or Energy etc. Coherency within a single row of 16 bytes (register ranges 0x00 to 0x0F, 0x10 to 0x1F, ... and 0xE0 to 0xEF) is always guaranteed for multiple byte read and write bursts and does not require memory locking.

**Table 24. Operation Control OPCTRL (0xF0)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
|-----|--------|------|---------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 0   | SLEEP  | RW   | 0       | 0: Normal operation<br>1: SLEEP. The LTC2949 will exit SLEEP state if the pin CSB is pulled low in SPI mode or if a wake-up pulse followed by another "Long -1" pulse is sent in isoSPI mode.                                                                                                                                                                                                                                                                                                           |
| 1   | CLR    | SO   | 0       | 1: Clear. The Accumulation and Tracking (max/min) registers are cleared: C1, E1, TB1, C2, E2, TB2, C3, TB4, E4, TB4 IMAX, IMIN, PMAX, PMIN, VMAX, VMIN, TEMPMAX, TEMPMIN, VDVCCMAX, VDVCCMIN, SLOTXMAX, SLOTXMIN                                                                                                                                                                                                                                                                                        |
| 2   | SSHOT  | SO   | 0       | 1: Single Shot Measurement. LTC2949 enters state MEASURE and returns to state STANDBY after completion of a single set of measurements of Current, Voltage, Power, Temperature, $V_{CC}$ , SLOT1, SLOT2, $V_{REF}$ . The result registers are updated and SSHOT is cleared when returning to STANDBY. If CONT is set, it is cleared after completion of any conversion cycle in progress and the single shot measurement is executed.                                                                   |
| 3   | CONT   | RW   | 0       | 0: Continuous measurement is disabled<br>1: Continuous measurement is enabled after $< t_{DLE\_CORE}$ . Measurement cycles run continuously. Charge, Energy and Time measurements are only active in Continuous mode.                                                                                                                                                                                                                                                                                   |
| 5   | ADJUPD | SO   | 0       | To insure data coherency, changes in the 2nd page's configuration registers, except threshold settings, only become effective after an update procedure, which is initialized by setting bit ADJUPD. Once the new configuration values are valid, LTC2949 resets the bit ADJUPD. Changes to the threshold registers may be done at any time and don't require the ADJUPD procedure.<br>1: Request an update of configuration registers on 2nd memory page, except threshold settings.<br>0: Update done |
| 7   | RST    | SO   | 0       | 0: Normal operation, 1: Reset device. As default the reset feature is locked and writing 1 to this bit has no effect. See RSTUNLCK for procedure how to reset the device.                                                                                                                                                                                                                                                                                                                               |

Note 9: ADJUPD shall be issued when in STANDBY mode only. The recommended implementation is to set ADJUPD as the last action of the initialization routine, before entering continuous mode. Once ADJUPD is set it takes a maximum of 100ms until LTC2949 has finished the internal update process and the bit ADJUPD is cleared automatically. Thus it is also possible to poll the bit ADJUPD for being cleared to indicate when the operation is done.

In cases where it is necessary to assert ADJUPD after CONT was enabled, it is necessary to clear the bit CONT before, wait 100ms to ensure that all measurement cycles have completed and then assert ADJUPD. After ADJUPD was cleared automatically, the Continuous Mode may be entered again.

To avoid the 100ms wait time when going to STANDBY mode, it is also possible to clear CONT and set CLR at the same time and poll for the bit CLR being cleared by LTC2949. This indicates also the end of any previously ongoing measurement cycle.

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Reading of status (0x80), faults (0xDC-0xDD) and alert (0x81-0x87) registers may always be done without memory locking. Still, once it is necessary to clear those registers, memory locking is mandatory to avoid missing any alert and faults reporting. If an alert condition occurs while the memory is locked, LTC2949 will set the corresponding bit after the memory is unlocked by the host. This rule must be followed independent of the core state, as certain faults may also be raised in STANDBY mode.

Any fast conversions are not affected by the memory locking mechanism, thus it is still possible to change FAMUX settings, trigger fast single shots, read results via RDCV. Also reading conversion results from the FIFOs during fast continuous measurements is still possible.

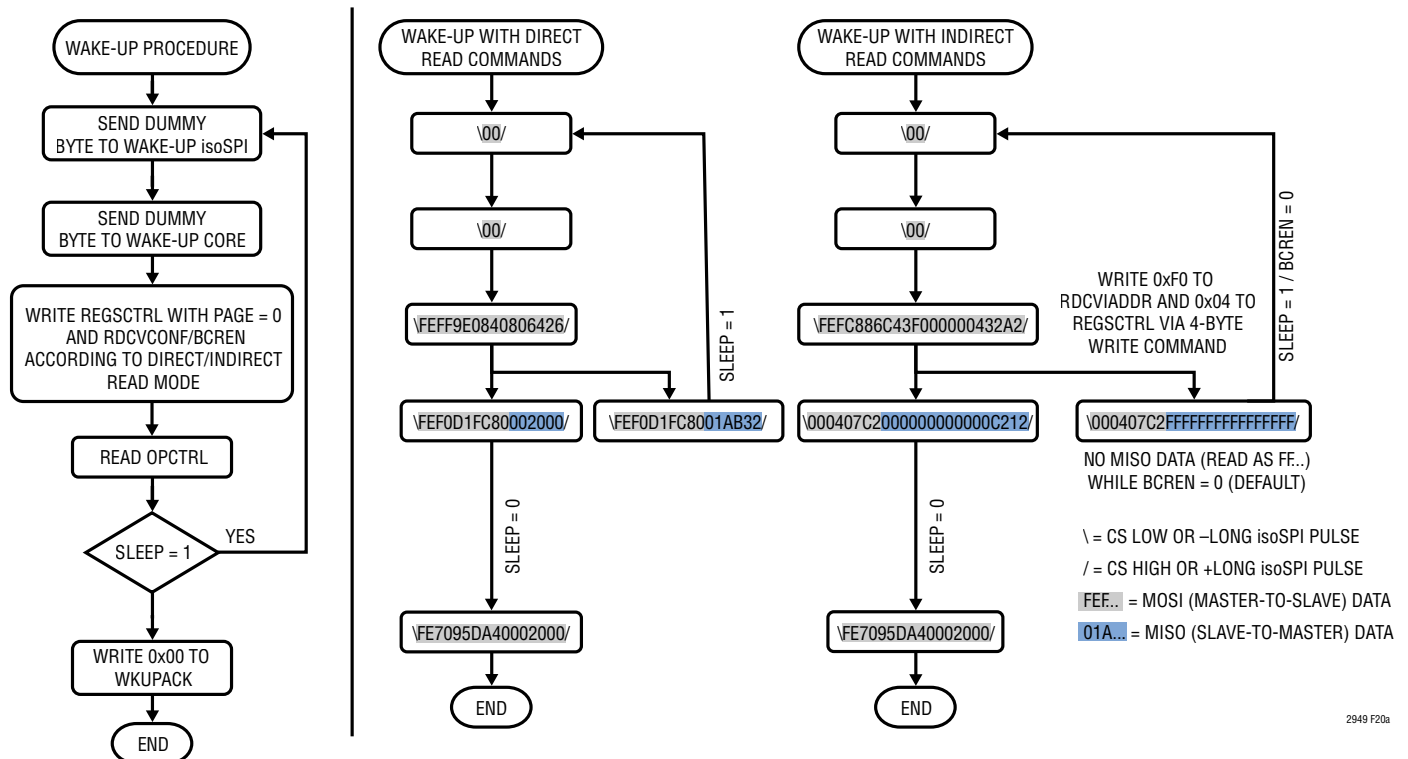
### Operation Control Register

The Operation Control Register OPCTRL (0xF0) controls LTC2949's transitions between its CORE States: SLEEP, STANDBY, and MEASURE. Furthermore, it allows to clear accumulation and tracking registers, to validate changes of the configuration registers and to reset the LTC2949.

## REGISTER MAP PAGE0

### Wake Up Acknowledge

The LTC2949 automatically returns to SLEEP state if no wake up confirmation command is received within 1 second after entering STANDBY state. Wake up confirmation can be either writing 0x00 to register 0x70 or starting of a measurement. Before wake up confirmation, WKUPACK will report a countdown from 0xFF to 0x00 within approximately 1 second. Countdown will stop and WKUPACK will statically report 0x00 after wake up confirmation.

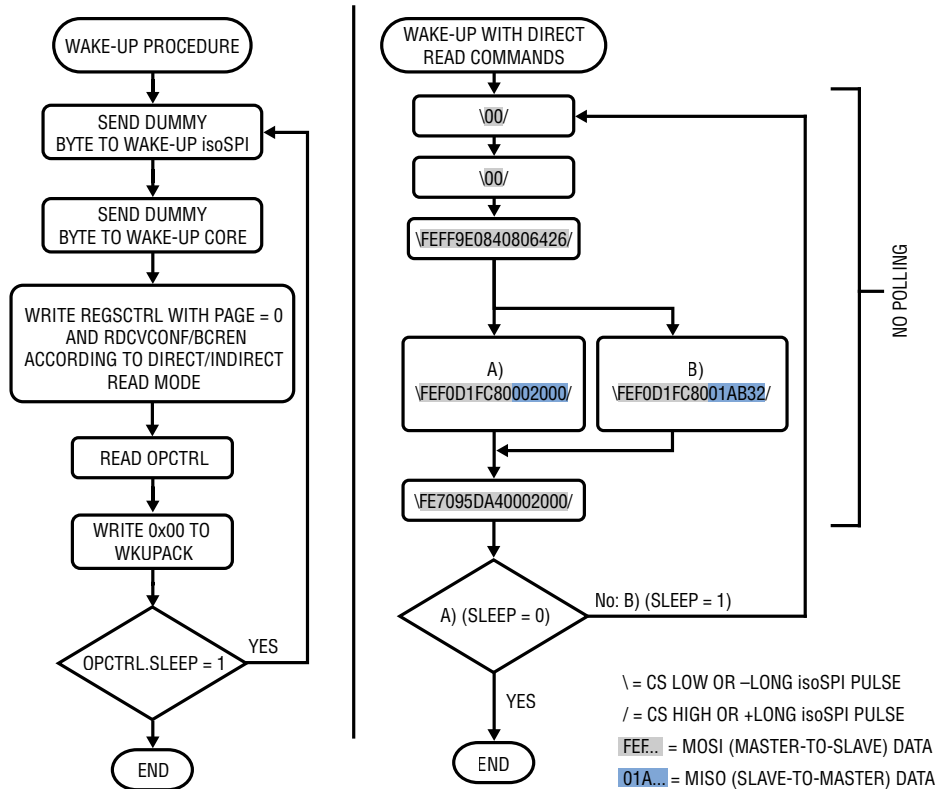


**Note:** When operating on top of a daisy chain, more than one dummy byte has to be send every time the isoSPI chain has to be woken up. See also 'Waking a Daisy Chain' chapters in latest cell monitor datasheets (e.g. LTC6812) for recommended procedures.

**Figure 20a. Flow Chart of Recommended Wake-Up Procedure and Example SPI Transactions for Direct and Indirect Read Scenarios**

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## REGISTER DESCRIPTION



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Figure 20b. Flow Chart of Recommended Wake-Up Procedure Implemented in a Sequence Without Polling

## REGISTER DESCRIPTION

**Table 25. Wake Up Acknowledge Register (0x70)**

| BIT   | SYMBOL  | TYPE | DEFAULT   | OPERATION                                                                                                                         |
|-------|---------|------|-----------|-----------------------------------------------------------------------------------------------------------------------------------|
| [7:0] | WKUPACK | RW   | see above | 0x00: Wake up is confirmed. Part will not return to SLEEP.<br>Anything else: Wake up is not confirmed. Part will return to SLEEP. |

In applications where LTC2949 is connected on top of a daisychain, the bit BCREN in REGSCTRL must be set before being able to read from LTC2949. This is only possible after the boot sequence has finished. Polling of the SLEEP bit being cleared can still be implemented by interleaving the read of OPCTRL with a write to REGSCTRL with BCREN=1 (all other bits 0). As this scenario also implies indirect register reads via RDCV commands (for this reason RDCVCONF=0), the write to REGSCTRL can be done in a single four byte burst together with RDCVIADDR (set to 0xF0); the two bytes between RDCVIADDR and REGSCTRL set to 0x00. Thus the four bytes to be written are 0xF0, 0x00, 0x00, 0x04 and the following RDCV command will report the content of OPCTRL. Still, if the boot sequence is not completed, LTC2949 will ignore the broadcast RDCV command and thus the master will read always 0xFF (which is also compatible with SLEEP=1), including PEC=0xFFFF if 8 bytes are read (its not necessary to read till the PEC in this case). After the boot OPCTRL will be read as 0x00.

### Accumulated Result Registers

The registers in Table 26 and Table 27 contain the accumulated quantities Charge, Energy and Time. The Time registers are unsigned integer values while the Charge and Energy registers are two's complement signed integer values. The value of each accumulated quantity can be determined by multiplying the respective register value with the corresponding LSB value from Table 26 (if the internal clock or crystal is used as a reference clock) or Table 27 (if an external reference clock is used).

**Table 26. Accumulated Results Register Parameters for Use with Crystal or Internal Clock**

| ADDRESS | NAME      | TYPE | DEFAULT | PARAMETER            | LSB (4MHz CRYSTAL OR INTERNAL CLOCK) | PRE (4MHz CRYSTAL) | DIV (4MHz CRYSTAL) | UNIT             | SI/UI |
|---------|-----------|------|---------|----------------------|--------------------------------------|--------------------|--------------------|------------------|-------|
| 0x00    | C1[47:0]  | RW   | 0x00    | Charge1 = C1 • LSBC1 | LSBC1 = 377.887e-12                  | 2                  | 30                 | Vs               | SI    |
| 0x06    | E1[47:0]  | RW   | 0x00    | Energy1 = E1 • LSBE1 | LSBE1 = 2.32175e-09                  | 2                  | 30                 | V <sup>2</sup> s | SI    |
| 0x0C    | TB1[31:0] | RW   | 0x00    | Time1 = TB1 • LSBTB1 | LSBTB1 = 397.777E-06                 | 2                  | 30                 | s                | UI    |
| 0x10    | C2[47:0]  | RW   | 0x00    | Charge2 = C2 • LSBC2 | LSBC2 = 377.887e-12                  | 2                  | 30                 | Vs               | SI    |
| 0x16    | E2[47:0]  | RW   | 0x00    | Energy2 = E2 • LSBE2 | LSBE2 = 2.32175e-09                  | 2                  | 30                 | V <sup>2</sup> s | SI    |
| 0x1C    | TB2[31:0] | RW   | 0x00    | Time2 = TB2 • LSBTB2 | LSBTB2 = 397.777E-06                 | 2                  | 30                 | s                | UI    |
| 0x24    | C3[63:0]  | RW   | 0x00    | Charge3 = C3 • LSBC3 | LSBC3 = 377.887e-12                  | 2                  | 30                 | Vs               | SI    |
| 0x2C    | TB3[31:0] | RW   | 0x00    | Time3 = TB3 • LSBTB3 | LSBTB3 = 397.777E-06                 | 2                  | 30                 | s                | UI    |
| 0x34    | E4[63:0]  | RW   | 0x00    | Energy4 = E4 • LSBE4 | LSBE4 = 2.32175e-09                  | 2                  | 30                 | V <sup>2</sup> s | SI    |
| 0x3C    | TB4[31:0] | RW   | 0x00    | Time4 = TB4 • LSBTB4 | LSBTB4 = 397.777E-06                 | 2                  | 30                 | s                | UI    |

Charge1, Energy1 and Time1 contain accumulated quantities of Channel1. Charge2, Energy2 and Time2 contain accumulated quantities of Channel2. Charge3 and Time3 contain the weighted sum of charges monitored by Channel1 and Channel2 and the corresponding time. Similarly Energy4 and Time4 contain the weighted sum of energies monitored by Channel1 and Channel2 and the corresponding time.

If different sense resistors are used on CH1 and CH2, the LTC2949 uses the ratio of the sense resistors (RSRATIO) set in the Gain Configuration Registers to compute the correct weighted sums Charge3 and Energy4.

When the internal clock is used, PRE and DIV should be set to their default values which is done by writing 0x07 to register (0xE9), otherwise the values of PRE(0xE9)[2:0] and DIV(0xE9)[7:3] should be set according to section Timebase Control.

## REGISTER DESCRIPTION

**Table 27. Accumulated Results Register Parameters for Use with External Clock**

| ADDRESS | NAME      | TYPE | DEFAULT | PARAMETER            | LSB                                                              | UNIT             | SI/UI |
|---------|-----------|------|---------|----------------------|------------------------------------------------------------------|------------------|-------|
| 0x00    | C1[47:0]  | RW   | 0x00    | Charge1 = C1 • LSBC1 | $LSBC1 = 1.21899e-5 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$ | Vs               | SI    |
| 0x06    | E1[47:0]  | RW   | 0x00    | Energy1 = E1 • LSBE1 | $LSBE1 = 7.4895e-5 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$  | V <sup>2</sup> s | SI    |
| 0x0C    | TB1[31:0] | RW   | 0x00    | Time1 = TB1 • LSBTB1 | $LSBTB1 = 12.8315 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$   | s                | UI    |
| 0x10    | C2[47:0]  | RW   | 0x00    | Charge2 = C2 • LSBC2 | $LSBC2 = 1.21899e-5 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$ | Vs               | SI    |
| 0x16    | E2[47:0]  | RW   | 0x00    | Energy2 = E2 • LSBE2 | $LSBE2 = 7.4895e-5 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$  | V <sup>2</sup> s | SI    |
| 0x1C    | TB2[31:0] | RW   | 0x00    | Time2 = TB2 • LSBTB2 | $LSBTB2 = 12.8315 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$   | s                | UI    |
| 0x24    | C3[63:0]  | RW   | 0x00    | Charge3 = C3 • LSBC3 | $LSBC3 = 1.21899e-5 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$ | Vs               | SI    |
| 0x2C    | TB3[31:0] | RW   | 0x00    | Time3 = TB3 • LSBTB3 | $LSBTB3 = 12.8315 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$   | s                | UI    |
| 0x34    | E4[63:0]  | RW   | 0x00    | Energy4 = E4 • LSBE4 | $LSBE4 = 7.4895e-5 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$  | V <sup>2</sup> s | SI    |
| 0x3C    | TB4[31:0] | RW   | 0x00    | Time4 = TB4 • LSBTB4 | $LSBTB4 = 12.8315 \cdot 1/f_{EXT} \cdot 2^{PRE} \cdot (DIV+1)$   | s                | UI    |

Note: Values of PRE and DIV should be calculated according to Timebase Control section.

For instance, an external clock frequency of 10MHz would require values PRE to be set to 4 and DIV to be set to 19. With  $f_{EXT}=10\text{MHz}$ , LSBC1 is calculated as  $390.078e-12\text{Vs}$ . To get the Charge1 value, the register content of C1 is multiplied with LSBC1. In this case, a C1 register value of 0x 75 5A 10 or 7690768 and the resulting Charge1 is 0.003 Vs. For a sense resistor of  $300\mu\Omega$  this corresponds to 10As.

LSB values may be calculated easily using the Quick Eval software for the LTC2949 or by using the C/C++ header files provided in the code section of the LTC2949 (see LTC2949 evaluation board DC2732A manual for details). The registers for Charge, Energy and Time can be preset to a non-zero initial value. In Continuous Mode all bytes of the respective quantity must be written in the same multi-byte transaction or while the memory is locked.

### Non-Accumulated Result Registers

Registers in Table 28 contain measured values of Currents, Powers, Voltages, Temperatures, VCC and VREF. All quantities are represented as two's complement signed integer values.

Current 1 represents the differential voltage sensed between CF1P and CF1M. Current 2 represents the differential voltage sensed between CF2P and CF2M. Battery voltage (BAT) is the differential voltage across pins VBATP and VBATM. Power 1 is the instantaneous multiplication of BAT and current 1. Power 2 is the instantaneous multiplication of BAT and current 2. Temperature is the temperature of the on-silicon temperature sensor. VCC is the voltage across pins A/DVCC and AGND. Registers SLOT1 and SLOT2 contain the results of the two multiplexer inputs chosen according to Table 58 and can be configured to give out voltage or temperature by means of the NTC Configuration Registers (Table 70). VREF is the voltage across pins VREF and AGND. The moving average of the four preceding current measurements are stored in I1AVG and I2AVG. The values of these four current measurements are retained in the Current History registers; Current 1 History 1 is the result prior to Current 1, Current 1 History 2 is the current result prior to Current 1 History 1, and so on. All measured values are scaled with the LSB values from . To calculate the physical value of the measured parameter, multiply the register value by the appropriate LSB value.

**Table 28. Non-Accumulated Results Register Parameters**

| ADDRESS | NAME     | TYPE | DEFAULT | PARAMETER                    | LSB    | UNIT          | SI/UI |
|---------|----------|------|---------|------------------------------|--------|---------------|-------|
| 0x90    | I1[23:0] | RO   | 0x00    | Current 1                    | 950    | nV            | SI    |
| 0x93    | P1[23:0] | RO   | 0x00    | Power 1 (Power, P1ASV = 0)   | 5.8368 | $\mu[V^2]$    | SI    |
|         |          |      |         | Power 1 (Voltage, P1ASV = 1) | 46.875 | $\mu\text{V}$ | SI    |
| 0x96    | I2[23:0] | RO   | 0x00    | Current 2                    | 950    | nV            | SI    |

## REGISTER DESCRIPTION

**Table 28. Non-Accumulated Results Register Parameters (continued)**

| ADDRESS | NAME          | TYPE | DEFAULT | PARAMETER                  | LSB     | UNIT        | SI/UI |
|---------|---------------|------|---------|----------------------------|---------|-------------|-------|
| 0x99    | P2[23:0]      | RO   | 0x00    | Power 2 (Power, P2ASV =0)  | 5.8368  | $\mu[V^2]$  | SI    |
|         |               |      |         | Power 2 (Voltage, P2ASV=1) | 46.875  | $\mu V$     | SI    |
| 0x9C    | I1AVG[23:0]   | RO   | 0x00    | Current 1 Moving Average   | 237.5   | nV          | SI    |
| 0xA0    | BAT[15:0]     | RO   | 0x00    | Battery Voltage            | 375     | $\mu V$     | SI    |
| 0xA2    | TEMP [15:0]   | RO   | 0x00    | Temperature                | 0.2     | $^{\circ}C$ | SI    |
| 0xA4    | VCC[15:0]     | RO   | 0x00    | Voltage at A/DVCC          | 2.26    | mV          | SI    |
| 0xA6    | SLOT1[15:0]   | RO   | 0x00    | SLOT 1 (Voltage)           | 375     | $\mu V$     | SI    |
|         |               |      |         | SLOT 1 (Temp.)             | 0.2     | $^{\circ}C$ | SI    |
| 0xA8    | SLOT2[15:0]   | RO   | 0x00    | SLOT 2 (Voltage)           | 375     | $\mu V$     | SI    |
|         |               |      |         | SLOT 2 (Temp)              | 0.2     | $^{\circ}C$ | SI    |
| 0xAA    | VREF[15:0]    | RO   | 0x00    | Voltage at VREF            | 375     | $\mu V$     | SI    |
| 0xAC    | I2AVG[23:0]   | RO   | 0x00    | Current 2 Moving Average   | 237.5   | nV          | SI    |
| 0xB3    | I1H1[23:0]    | RO   | 0x00    | Current 1 History 1        | 950     | nV          | SI    |
| 0xB6    | I1H2[23:0]    | RO   | 0x00    | Current 1 History 2        | 950     | nV          | SI    |
| 0xB9    | I1H3[23:0]    | RO   | 0x00    | Current 1 History 3        | 950     | nV          | SI    |
| 0xBC    | I1H4[23:0]    | RO   | 0x00    | Current 1 History 4        | 950     | nV          | SI    |
| 0xC3    | I2H1[23:0]    | RO   | 0x00    | Current 2 History 1        | 950     | nV          | SI    |
| 0xC6    | I2H2[23:0]    | RO   | 0x00    | Current 2 History 2        | 950     | nV          | SI    |
| 0xC9    | I2H3[23:0]    | RO   | 0x00    | Current 2 History 3        | 950     | nV          | SI    |
| 0xCC    | I2H4[23:0]    | RO   | 0x00    | Current 2 History 4        | 950     | nV          | SI    |
| 0xF7    | FIFOI1[15:0]  | RO   | 0x00    | Fast Current 1             | 7.60371 | $\mu V$     | SI    |
| 0xF8    | FIFOI2[15:0]  | RO   | 0x00    | Fast Current 2             | 7.60371 | $\mu V$     | SI    |
| 0xF9    | FIFOBAT[15:0] | RO   | 0x00    | Fast Battery Voltage       | 375.183 | $\mu V$     | SI    |
| 0xFA    | FIFOAUX[15:0] | RO   | 0x00    | Fast AUX HVMUX             | 375.183 | $\mu V$     | SI    |

The FIFO registers 0xF7 to 0xFA allow to read conversion results in fast continuous mode. When reading from those registers, the internal address auto-increment stops, allowing to read any number of bytes the fixed addresses. For each sample, three bytes have to be read which are MSB, LSB and TAG, see also fast mode section and below description for more details.

In Fast Mode, ADC conversion results turn negative when exceeding positive and clip when exceeding negative full-scale values. In Slow Modes, ADC conversion results clip when exceeding positive and negative full-scale values. Full-scale values are always beyond the specified input range.

Registers I1AVG (0x9C) and I2AVG (0xAC) are copied to registers 0xB0 and 0xC0, respectively. Thus, 0x9C-0x9E will report the same values as 0xB0-0xB2 and 0xAC-0xAE will report the same values as 0xC0-0xC2.

## REGISTER DESCRIPTION

**Table 29. FIFO Register Read Format.**

| DATA BYTE       | NAME            | DESCRIPTION                |
|-----------------|-----------------|----------------------------|
| 0               | $S_N[15:8]$     | MSB of measured sample N   |
| 1               | $S_N[7:0]$      | LSB of measured sample N   |
| 2               | $TAG_N$         | Tag of sample N            |
| 3               | $S_{N+1}[15:8]$ | MSB of measured sample N+1 |
| 4               | $S_{N+1}[7:0]$  | LSB of measured sample N+1 |
| 5               | $TAG_{N+1}$     | Tag of sample N+1          |
| ...             | ...             | ...                        |
| $3 \cdot M$     | $S_{N+M}[15:8]$ | MSB of measured sample N+M |
| $3 \cdot M + 1$ | $S_{N+M}[7:0]$  | LSB of measured sample N+M |
| $3 \cdot M + 2$ | $TAG_{N+M}$     | Tag of sample N+M          |

The column Data Byte does not count the PEC bytes, which depend on the setting of data bytes per PEC (ID-byte for DCMD or fixed to six for RDCV). For maximum data throughput it is recommended to read the FIFOs with DCMDs with 16 bytes per PEC and multiples of 16 samples (= 48 data bytes + 3 • 2 PEC bytes).

**Table 30. FIFO TAG Definitions.**

| TAG  | NAME  | DESCRIPTION                                                                               |
|------|-------|-------------------------------------------------------------------------------------------|
| 0x00 | OK    | Valid, new sample                                                                         |
| 0x55 | RDOVR | Read overrun, sample was already read                                                     |
| 0xAA | WROVR | Write overrun, FIFO was filled completely and at least one sample was already overwritten |

It is recommended to connect LTC2949 always in parallel to a daisy chain. Also, in the scenario where LTC2949 is connected at one end of a reversible isoSPI chain, the default communication should be done with direct read commands. Only in case the direct isoSPI link to LTC2949 fails, the communication would be routed through the daisy chain.

In this configuration where LTC2949 is on top of a daisy chain, after the broadcast RDCV command, the stacked LTC68xx Cell Monitors turn into a cascaded shift register, in which data is shifted through each device to the next device in the stack. In this scenario, at the end of the read transaction, there is always a fixed number of samples stuck in the shift register, that is never transmitted to the master.

Several approaches are possible to avoid or minimize the loss of samples. Either fast continuous mode is stopped (FACONV=0), the FIFO is read until empty and then fast continuous measurement is repeated (FACONV=1). This results in a time window without measurements, equal to the time it takes to read the samples. For example, at 1Mbit/s serial clock rate, it takes 0.8 ms (approximately one fast conversion time) to read 24 samples (four byte command and PEC, 72 data bytes, 24 data PEC bytes equals in total 100 bytes or 800 bits). For lower clock speeds or longer cycle times, where more samples are read per cycle, the following approach is more efficient.

Alternatively, the FIFO read burst must be long enough to always empty the FIFO and read at least one sample with TAG RDOVR. Still, also here, one sample with TAG OK can arrive after the RDOVR and would then be stuck in the daisy chain's shift register. If the latency of the shift register (number of devices in the daisy chain times eight bytes times eight bit per byte divided by SPI clock speed) is longer than one fast conversion time, even more than one sample can get stuck in the daisy chain.

## REGISTER DESCRIPTION

### Tracking Registers

The tracking registers keep track of the maximum and minimum values of previous conversions since the last reset. Value scaling is done in the same manner as the non-accumulated register values, using LSB values from Table 31. Negative values are treated as smaller (more minimum) than positive values as the minimum registers are updated.

For example: A register value I1MAX(0x40,0x41) of 0000 0001 1111 0100b = 01 F4h = 500d indicates a resulting maximum sense resistor signal of  $500 \cdot 3.8\mu\text{V} = 1.9\text{mV}$ . A register value I1MIN(0x42,0x43) of 1111 1010 0010 0100b = FA 24h = -1500d indicates a minimum sense resistor signal of  $-1500 \cdot 3.8\mu\text{V} = -5.7\text{mV}$ . The calculation of the other tracked parameter values is done the same way with their corresponding LSB values.

**Table 31. Tracking Registers**

| ADDRESS | NAME           | TYPE | DEFAULT | PARAMETER                                    | LSB            | UNIT                                 | SI/UI |
|---------|----------------|------|---------|----------------------------------------------|----------------|--------------------------------------|-------|
| 0x40    | I1MAX[15:0]    | RW   | 0x8000  | Max I1 Current                               | 3.8            | $\mu\text{V}$                        | SI    |
| 0x48    | I2MAX[15:0]    | RW   | 0x8000  | Max I2 Current                               | 3.8            | $\mu\text{V}$                        | SI    |
| 0x42    | I1MIN[15:0]    | RW   | 0x7FFF  | Min I1 Current                               | 3.8            | $\mu\text{V}$                        | SI    |
| 0x4A    | I2MIN[15:0]    | RW   | 0x7FFF  | Min I2 Current                               | 3.8            | $\mu\text{V}$                        | SI    |
| 0x44    | P1MAX[15:0]    | RW   | 0x8000  | Max Power 1 (or Battery Voltage for P1ASV=1) | 23.347 (187.5) | $\mu[\text{V}^2]$ ( $\mu\text{V}$ )  | SI    |
| 0x4C    | P2MAX[15:0]    | RW   | 0x8000  | Max Power 2 (or Battery Voltage for P2ASV=1) | 23.347 (187.5) | $\mu[\text{V}^2]$ ( $\mu\text{V}$ )  | SI    |
| 0x46    | P1MIN[15:0]    | RW   | 0x7FFF  | Min Power 1 (or Battery Voltage for P1ASV=1) | 23.347 (187.5) | $\mu[\text{V}^2]$ ( $\mu\text{V}$ )  | SI    |
| 0x4E    | P2MIN[15:0]    | RW   | 0x7FFF  | Min Power 2 (or Battery Voltage for P2ASV=1) | 23.347 (187.5) | $\mu[\text{V}^2]$ ( $\mu\text{V}$ )  | SI    |
| 0x50    | BATMAX[15:0]   | RW   | 0x8000  | Max Battery Voltage                          | 375            | $\mu\text{V}$                        | SI    |
| 0x52    | BATMIN[15:0]   | RW   | 0x7FFF  | Min Battery Voltage                          | 375            | $\mu\text{V}$                        | SI    |
| 0x54    | TEMPMAX[15:0]  | RW   | 0x8000  | Max Temperature                              | 0.2            | $^{\circ}\text{C}$                   | SI    |
| 0x56    | TEMPMIN[15:0]  | RW   | 0x7FFF  | Min Temperature                              | 0.2            | $^{\circ}\text{C}$                   | SI    |
| 0x58    | VCCMAX[15:0]   | RW   | 0x8000  | Max Voltage at A/DVCC                        | 2.26           | mV                                   | SI    |
| 0x5A    | VCCMIN[15:0]   | RW   | 0x7FFF  | Min Voltage at A/DVCC                        | 2.26           | mV                                   | SI    |
| 0x5C    | SLOT1MAX[15:0] | RW   | 0x8000  | Max Voltage (or Temperature) at SLOT1        | 375 (0.2)      | $\mu\text{V}$ ( $^{\circ}\text{C}$ ) | SI    |
| 0x5E    | SLOT1MIN[15:0] | RW   | 0x7FFF  | Min Voltage (or Temperature) at SLOT1        | 375 (0.2)      | $\mu\text{V}$ ( $^{\circ}\text{C}$ ) | SI    |
| 0x60    | SLOT2MAX[15:0] | RW   | 0x8000  | Max Voltage (or Temperature) at SLOT2        | 375 (0.2)      | $\mu\text{V}$ ( $^{\circ}\text{C}$ ) | SI    |
| 0x62    | SLOT2MIN[15:0] | RW   | 0x7FFF  | Min Voltage (or Temperature) at SLOT2        | 375 (0.2)      | $\mu\text{V}$ ( $^{\circ}\text{C}$ ) | SI    |

Note that the tracking registers for current and power report only the 16MSBs of the respective 18-bit result registers, leading to a four times larger LSB value.

### STATUS, (EXT)FAULTS, Threshold and Overflow Alert Registers

The registers described in the following chapters are used to signal certain events, like a voltage threshold violation, charger or energy overflow, supply undervoltage events and others. After power-up it is recommended to lock the memory, read STATUS, FAULTS and EXTFaults registers, check for the default values, clear them and finally unlock the memory. During normal operation those registers shall be checked periodically to be all zero, except for the UPDATE bit. Any other value indicates a failure.

Any bits in the STATUS, alerts (0x81-0x87), FAULTS and EXTFaults registers are only set to 1 by LTC2949 in case of an event, but never cleared automatically. After the master reads some bits being set, actions should be taken (e.g. to clear the charge register in case of a charge overflow), the memory must be locked (see REGSCTRL), the registers

should be read again as other events may have occurred in the meantime, registers that or not 0x00 must be written to 0x00 and finally the memory must be unlocked to proceed with normal operation.

It is not recommended to write those registers without usage of the memory lock, as this may lead to loss of failure and alert reports.

## Status and Fault Registers

The STATUS register reports the status of register updates, undervoltage lockout, and reference clock errors. On power up, all undervoltage lockouts and the power-on reset are set to 1. After exit from shutdown, bits UVLOA and UVLOD are set. UPDATE is set to 1 when the LTC2949 has finished a measurement cycle and updated the result registers, the accumulation registers, and the tracking registers.

ADCERR is set to 1 if the supply voltage at AVCC is too low for a proper operation of the ADCs. The values in the result registers are not valid and should be discarded if ADCERR is set. TBERR is set to 1 if the internal time base overflows. This indicates an incorrect setting of the values PRE and DIV with respect to the external clock at CLKI. The values of accumulated results registers should be discarded if TBERR is set.

**Table 32. STATUS (0x80)**

| BIT | SYMBOL   | TYPE | DEFAULT | OPERATION                                                                                             |
|-----|----------|------|---------|-------------------------------------------------------------------------------------------------------|
| 0   | UVLOA    | RW   | 1       | 1: Undervoltage in the analog domain or ADCs during a conversion                                      |
| 1   | PORA     | RW   | 1       | 1: Power-on reset has occurred due to undervoltage in the analog domain                               |
| 2   | UVLOSTBY | RW   | 1       | 1: Undervoltage in the standby domain                                                                 |
| 3   | UVLOD    | RW   | 1       | 1: Undervoltage in the digital domain                                                                 |
| 4   | UPDATE   | RW   | 0       | 1: Result registers have been updated                                                                 |
| 5   | ADCERR   | RW   | 0       | 1: The ADC conversion is not valid due to undervoltage during a conversion                            |
| 6   | TBERR    | RW   | 0       | 1: Overflow of the internal timebase register. The values of accumulated result registers are invalid |

LTC2949 has several types of internal memory that are checked during boot-up via built-in self-test (BIST) routines. Errors in individual blocks are reported by the EXTFAULTS and FAULTS registers. The FAULTS register additionally reports error in the internal (on-chip) and external (from master to slave on the SPI/isoSPI interface) communication and indicates thermal shutdown and fast channel error events.

**Table 33. EXTFAULTS (0xDC)**

| BIT | SYMBOL      | TYPE | DEFAULT | OPERATION                                                                                                                                                                                                                                 |
|-----|-------------|------|---------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 0   | HD1BITERR   | RW   | 0       | 1: Hamming decoder 1-bit error                                                                                                                                                                                                            |
| 1   | ROMERR      | RW   | 0       | 1: ROM CRC error                                                                                                                                                                                                                          |
| 2   | MEMERR      | RW   | 0       | 1: Memory error                                                                                                                                                                                                                           |
| 3   | FCAERR      | RW   | 0       | 1: Fast channel error                                                                                                                                                                                                                     |
| 4   | XRAMERR     | RW   | 0       | 1: XRAM error                                                                                                                                                                                                                             |
| 5   | IRAMERR     | RW   | 0       | 1: IRAM error                                                                                                                                                                                                                             |
| 7   | HWMBISTEXEC | RW   | 1       | 1: Memory BIST was executed. If SDA is externally pulled low during power-up, the memory BIST will be skipped and this bit will be zero. Connect a 4.7k-10k pull-up resistor from SDA to BYP1 to ensure correct operation of memory BIST. |

## REGISTER DESCRIPTION

**Table 34. FAULTS (0xDD)**

| BIT | SYMBOL     | TYPE | DEFAULT | OPERATION                                                    |
|-----|------------|------|---------|--------------------------------------------------------------|
| 0   | PROMERR    | RW   | 0       | 1: Error in trim values stored in internal PROM              |
| 1   | TSD        | RW   | 0       | 1: Shutdown due to over temperature                          |
| 2   | INTCOMMERR | RW   | 0       | 1: Parity check of internal communication failed             |
| 3   | EXTCOMMERR | RW   | 0       | 1: PEC error in external communication (SPI/isoSPI) occurred |
| 4   | FAERR      | RW   | 0       | 1: Fast mode error, see Safety Manual for more information   |
| 5   | HWBIST     | RW   | 0       | 1: Error during hardware BIST.                               |
| 6   | CRCCFG     | RW   | 0       | 1: Internal RAM gain coefficient CRC Error                   |
| 7   | CRCMEM     | RW   | 0       | 1: User accessible register CRC Error                        |

### Threshold and Overflow Alert Registers

Threshold and overflow alert registers are set when the respective threshold values are exceeded or when registers overflow. Thresholds are set in the Threshold Registers section.

The accumulated quantities are continuously checked against guard values to warn that a register is nearing overflow, nominally set to 90% of each register's maximum value. When any quantity crosses its guard threshold, the LTC2949 sets the corresponding overflow bit in the status register, generates an alert (if enabled) and continues accumulation. At the maximum voltage inputs, rollover typically happens several hours after an overflow alert is signaled, allowing the host time to take action to avoid data loss, by reading and clearing the concerned accumulators using the memory locking procedure. The overflow thresholds for 32-bit quantities (time) are 3865470565 LSB; for 48-bit quantities (charge and energy) is  $\pm 126663739519794$  LSB.

The threshold and overflow comparators for accumulated quantities charge, energy and time use a floating point format internally. This can appear to cause slight bit-level comparison discrepancies, but the comparisons between accumulated result registers and their respective threshold registers will always have an accuracy of better than 0.001%.

An alert condition needs to be present for at least for 200ms to be reported by the alert registers (0x81-0x87). Only overcurrent conditions detected by either OCC1 or OCC2 can be signaled to the host within some  $\mu$ s by stopping heart beat on GPIO5.

To acknowledge and release an overcurrent alert the following steps can be performed:

1. Stop the overcurrent event
2. Lock the memory
3. Read STATUS-STATVCC, (EXT)FAULTS for any newly arrived error flags (including the asserted OCCx bits)
4. Clear STATUS-STATVCC, (EXT)FAULTS
5. Unlock the memory
6. Heartbeat on GPIO5 will start again

## REGISTER DESCRIPTION

**Table 35. Voltage, Temperature Threshold Alerts STATVT (0x81)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                                          |
|-----|--------|------|---------|----------------------------------------------------|
| 0   | BATH   | RW   | 0       | 1: Voltage (VBATP – VBATM) high threshold exceeded |
| 1   | BATL   | RW   | 0       | 1: Voltage (VBATP – VBATM) low threshold exceeded  |
| 2   | TEMPH  | RW   | 0       | 1: Temperature high threshold exceeded             |
| 3   | TEMPL  | RW   | 0       | 1: Temperature low threshold exceeded              |
| 4   | SLOT1H | RW   | 0       | 1: SLOT1 high threshold exceeded                   |
| 5   | SLOT1L | RW   | 0       | 1: SLOT1 low threshold exceeded                    |
| 6   | SLOT2H | RW   | 0       | 1: SLOT2 high threshold exceeded                   |
| 7   | SLOT2L | RW   | 0       | 1: SLOT2 low threshold exceeded                    |

**Table 36. Current, Power Threshold Alerts STATIP (0x82)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                           |
|-----|--------|------|---------|-------------------------------------|
| 0   | I1H    | RW   | 0       | 1: Current1 high threshold exceeded |
| 1   | I1L    | RW   | 0       | 1: Current1 low threshold exceeded  |
| 2   | P1H    | RW   | 0       | 1: Power1 high threshold exceeded   |
| 3   | P1L    | RW   | 0       | 1: Power1 low threshold exceeded    |
| 4   | I2H    | RW   | 0       | 1: Current2 high threshold exceeded |
| 5   | I2L    | RW   | 0       | 1: Current2 low threshold exceeded  |
| 6   | P2H    | RW   | 0       | 1: Power2 high threshold exceeded   |
| 7   | P2L    | RW   | 0       | 1: Power2 low threshold exceeded    |

**Table 37. Charge Threshold Alerts STATC (0x83)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                          |
|-----|--------|------|---------|------------------------------------|
| 0   | C1H    | RW   | 0       | 1: Charge1 high threshold exceeded |
| 1   | C1L    | RW   | 0       | 1: Charge1 low threshold exceeded  |
| 2   | C2H    | RW   | 0       | 1: Charge2 high threshold exceeded |
| 3   | C2L    | RW   | 0       | 1: Charge2 low threshold exceeded  |
| 4   | C3H    | RW   | 0       | 1: Charge3 high threshold exceeded |
| 5   | C3L    | RW   | 0       | 1: Charge3 low threshold exceeded  |

**Table 38. Energy Threshold Alerts STATE (0x84)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                          |
|-----|--------|------|---------|------------------------------------|
| 0   | E1H    | RW   | 0       | 1: Energy1 high threshold exceeded |
| 1   | E1L    | RW   | 0       | 1: Energy1 low threshold exceeded  |
| 2   | E2H    | RW   | 0       | 1: Energy2 high threshold exceeded |
| 3   | E2L    | RW   | 0       | 1: Energy2 low threshold exceeded  |
| 6   | E4H    | RW   | 0       | 1: Energy4 high threshold exceeded |
| 7   | E4L    | RW   | 0       | 1: Energy4 low threshold exceeded  |

**Table 39. Charge, Energy Overflow Alerts STATCEOF (0x85)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                 |
|-----|--------|------|---------|---------------------------|
| 0   | C1OVF  | RW   | 0       | 1: Charge1 overflow alert |
| 1   | C2OVF  | RW   | 0       | 1: Charge2 overflow alert |
| 2   | C3OVF  | RW   | 0       | 1: Charge3 overflow alert |
| 4   | E1OVF  | RW   | 0       | 1: Energy1 overflow alert |
| 5   | E2OVF  | RW   | 0       | 1: Energy2 overflow alert |
| 7   | E4OVF  | RW   | 0       | 1: Energy4 overflow alert |

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## REGISTER DESCRIPTION

**Table 40. Time Base Alerts STATTB (0x86)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                   |
|-----|--------|------|---------|-----------------------------|
| 0   | T1TH   | RW   | 0       | 1: Time1 threshold exceeded |
| 1   | T2TH   | RW   | 0       | 1: Time2 threshold exceeded |
| 2   | T3TH   | RW   | 0       | 1: Time3 threshold exceeded |
| 3   | T4TH   | RW   | 0       | 1: Time4 threshold exceeded |
| 4   | T1OVF  | RW   | 0       | 1: Time1 overflow           |
| 5   | T2OVF  | RW   | 0       | 1: Time2 overflow           |
| 6   | T3OVF  | RW   | 0       | 1: Time3 overflow           |
| 7   | T4OVF  | RW   | 0       | 1: Time4 overflow           |

**Table 41. VCCOCC Threshold Alerts STATVCC (0x87)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                                                    |
|-----|--------|------|---------|--------------------------------------------------------------|
| 0   | VCCH   | RW   | 0       | 1: VCC high threshold exceeded                               |
| 1   | VCCL   | RW   | 0       | 1: VCC low threshold exceeded                                |
| 2   | OCC1H  | RW   | 0       | 1: Current1 above OCC1 threshold for more than deglitch time |
| 3   | OCC2H  | RW   | 0       | 1: Current2 above OCC2 threshold for more than deglitch time |

Note: The memory must be locked to clear status (0x80), faults (0xDC-0xDD) and alert (0x81-0x87) registers to avoid missing of any failure and alert reports. See REGSCTRL description for details.

### Mask Registers

The mask registers control which alerts stop heartbeat. If a mask register bit is reset to 0, exceeding of the respective threshold causes the heartbeat on GPIO4 pin to stop, if the latter is configured accordingly in the GPIO4HBCTRL register.

When a bit of the Status Mask Register (STATUSM) is set to 0, the corresponding bits of register STATUS (0x80) will stop heartbeat. When a bit of the status mask register is set to 1, heartbeat is unaffected by the corresponding bits of register STATUS (0x80).

**Table 42. Status Mask STATUSM (0x88)**

| BIT | SYMBOL  | TYPE | DEFAULT | OPERATION                   |
|-----|---------|------|---------|-----------------------------|
| 0   | UVLOAM  | RW   | 1       | Mask UVLOA of STATUS(0x80)  |
| 3   | UVLODM  | RW   | 1       | Mask UVLOD of STATUS(0x80)  |
| 4   | UPDATM  | RW   | 1       | Mask UPDATE of STATUS(0x80) |
| 5   | ADCERRM | RW   | 1       | Mask ADCERR of STATUS(0x80) |
| 6   | TBCERRM | RW   | 1       | Mask TBCERR of STATUS(0x80) |

When bits of STATVTM are set to 0, corresponding bits of register STATVT (0x81) will stop heartbeat. When a bit of STATVTM is set to 1, heartbeat is unaffected by the corresponding bits of register STATVT (0x81).

**Table 43. Voltage, Temperature Threshold Alert Mask STATVTM (0x89)**

| BIT | SYMBOL  | TYPE | DEFAULT | OPERATION                   |
|-----|---------|------|---------|-----------------------------|
| 0   | BATHM   | RW   | 1       | Mask BATH of STATVT(0x81)   |
| 1   | BATLM   | RW   | 1       | Mask BATL of STATVT(0x81)   |
| 2   | TEMPHM  | RW   | 1       | Mask TEMPH of STATVT(0x81)  |
| 3   | TEMPLM  | RW   | 1       | Mask TEMPL of STATVT(0x81)  |
| 4   | SLOT1HM | RW   | 1       | Mask SLOT1H of STATVT(0x81) |
| 5   | SLOT1LM | RW   | 1       | Mask SLOT1L of STATVT(0x81) |
| 6   | SLOT2HM | RW   | 1       | Mask SLOT2H of STATVT(0x81) |
| 7   | SLOT2LM | RW   | 1       | Mask SLOT2L of STATVT(0x81) |

## REGISTER DESCRIPTION

When bits from STATIPM are set to 0, bits from register STATIP(0x82) will stop heartbeat. When a bit of STATIPM register is set to 1, heartbeat is unaffected by the corresponding bits of register STATIP(0x82).

**Table 44. Current, Power Threshold Alert Mask STATIPM (0x8A)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                 |
|-----|--------|------|---------|---------------------------|
| 0   | I1HM   | RW   | 1       | Mask I1H of STATIP (0x82) |
| 1   | I1LM   | RW   | 1       | Mask I1L of STATIP (0x82) |
| 2   | P1HM   | RW   | 1       | Mask P1H of STATIP (0x82) |
| 3   | P1LM   | RW   | 1       | Mask P1L of STATIP (0x82) |
| 4   | I2HM   | RW   | 1       | Mask I2H of STATIP (0x82) |
| 5   | I2LM   | RW   | 1       | Mask I2L of STATIP (0x82) |
| 6   | P2HM   | RW   | 1       | Mask P2H of STATIP (0x82) |
| 7   | P2LM   | RW   | 1       | Mask P2L of STATIP (0x82) |

When bits from STATCM are set to 0, bits from register STATC(0x83) will stop heartbeat. When a bit of STATCM register is set to 1, heartbeat is unaffected by the corresponding bits of register STATC(0x83).

**Table 45. Charge Threshold Alerts Mask STATCM (0x8B)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                |
|-----|--------|------|---------|--------------------------|
| 0   | C1HM   | RW   | 1       | Mask C1H of STATC (0x83) |
| 1   | C1LM   | RW   | 1       | Mask C1L of STATC (0x83) |
| 2   | C2HM   | RW   | 1       | Mask C2H of STATC (0x83) |
| 3   | C2LM   | RW   | 1       | Mask C2L of STATC (0x83) |
| 4   | C3HM   | RW   | 1       | Mask C3H of STATC (0x83) |
| 5   | C3LM   | RW   | 1       | Mask C3L of STATC (0x83) |

When bits from STATEM are set to 0, bits from register STATE(0x84) will stop heartbeat. When a bit of STATEM register is set to 1, heartbeat is unaffected by the corresponding bits of register STATE(0x84).

**Table 46. Energy Threshold Alerts Mask STATEM (0x8C)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                |
|-----|--------|------|---------|--------------------------|
| 0   | E1HM   | RW   | 1       | Mask E1H of STATE (0x84) |
| 1   | E1LM   | RW   | 1       | Mask E1L of STATE (0x84) |
| 2   | E2HM   | RW   | 1       | Mask E2H of STATE (0x84) |
| 3   | E2LM   | RW   | 1       | Mask E2L of STATE (0x84) |
| 6   | E4HM   | RW   | 1       | Mask E4H of STATE (0x84) |
| 7   | E4LM   | RW   | 1       | Mask E4L of STATE (0x84) |

When bits from STATCEOFM are set to 0, bits from register STATCEOF(0x85) will stop heartbeat. When a bit of STATCEOFM register is set to 1, heartbeat is unaffected by the corresponding bits of register STATCEOF(0x85).

**Table 47. Charge, Energy Overflow Alerts Mask STATCEOFM (0x8D)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                    |
|-----|--------|------|---------|------------------------------|
| 0   | C1OFM  | RW   | 1       | Mask C10VF of STATCEOF(0x85) |
| 1   | C2OFM  | RW   | 1       | Mask C20VF of STATCEOF(0x85) |
| 2   | C3OFM  | RW   | 1       | Mask C30VF of STATCEOF(0x85) |
| 4   | E1OFM  | RW   | 1       | Mask E10VF of STATCEOF(0x85) |
| 5   | E2OFM  | RW   | 1       | Mask E20VF of STATCEOF(0x85) |
| 7   | E4OFM  | RW   | 1       | Mask E40VF of STATCEOF(0x85) |

## REGISTER DESCRIPTION

When bits from STATBIM are set to 0, bits from register STATTB (0x86) will stop heartbeat. When a bit of STATBIM register is set to 1, heartbeat is unaffected by the corresponding bits of register STATTB (0x86).

**Table 48. Time Base Alerts STATBIM (0x8E)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                  |
|-----|--------|------|---------|----------------------------|
| 0   | T1THM  | RW   | 1       | Mask T1TH of STATTB(0x86)  |
| 1   | T2THM  | RW   | 1       | Mask T2TH of STATTB(0x86)  |
| 2   | T3THM  | RW   | 1       | Mask T3TH of STATTB(0x86)  |
| 3   | T4THM  | RW   | 1       | Mask T4TH of STATTB(0x86)  |
| 4   | T1OFM  | RW   | 1       | Mask T1OVF of STATTB(0x86) |
| 5   | T2OFM  | RW   | 1       | Mask T2OVF of STATTB(0x86) |
| 6   | T3OFM  | RW   | 1       | Mask T3OVF of STATTB(0x86) |
| 7   | T4OFM  | RW   | 1       | Mask T4OVF of STATTB(0x86) |

When bits from STATVCCM are set to 0, bits from register STATVCC (0x87) will stop heartbeat. When a bit of STATVCCM register is set to 1, heartbeat is unaffected by the corresponding bits of register STATVCC (0x87).

**Table 49. V<sub>CC</sub> Threshold Alerts STATVCCM (0x8F)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                   |
|-----|--------|------|---------|-----------------------------|
| 0   | VCCH   | RW   | 1       | Mask VCCH of STATVCC (0x87) |
| 1   | VCCL   | RW   | 1       | Mask VCCL of STATVCC (0x87) |

Note that the bits reporting the result of the overcurrent comparators OCC1 and OCC2 in STATVCC (0x87) do not have a corresponding mask bit in STATVCCM. Therefore the impact of OCC1 and OCC2 on heartbeat either on GPIO4 or GPIO5 cannot be masked. If overcurrent comparison is not desired the enable bit in OCCxCTRL has to be cleared (default).

### Control Registers

The control registers select the multiplexer input, control the accumulation of charge, energy and time, configure the GPIO pins, set the overcurrent comparator thresholds, and setup the timebase if an external clock is used.

The Overcurrent Control Registers allow to set the overcurrent comparator thresholds and deglitch filters, see also the Overcurrent Comparators section.

**Table 50. OCC1CTRL (0xDE)**

| BIT   | SYMBOL         | TYPE | DEFAULT | OPERATION                                                            |
|-------|----------------|------|---------|----------------------------------------------------------------------|
| 0     | OCC1EN         | RW   | 0       | OCC1 enable bit. GPIO5 is configured as heartbeat                    |
| [3:1] | OCC1DAC [2:0]  | RW   | 000     | OCC1 threshold setting bits, see Table 6 (OCC Thresholds)            |
| [5:4] | OCC1DGLT [1:0] | RW   | 00      | OCC1 deglitch time setting bits, see Table 7 (OCC Deglitch Time)     |
| [7:6] | OCC1POL [1:0]  | RW   | 00      | OCC1 polarity setting bits, see Table 5 (OCC Polarity Configuration) |

**Table 51. OCC2CTRL (0xDF)**

| BIT   | SYMBOL         | TYPE | DEFAULT | OPERATION                                                            |
|-------|----------------|------|---------|----------------------------------------------------------------------|
| 0     | OCC2EN         | RW   | 0       | OCC2 enable bit. GPIO5 is configured as heartbeat                    |
| [3:1] | OCC2DAC [2:0]  | RW   | 000     | OCC2 threshold setting bits, see Table 6 (OCC Thresholds)            |
| [5:4] | OCC2DGLT [1:0] | RW   | 00      | OCC2 deglitch time setting bits, see Table 7 (OCC Deglitch Time)     |
| [7:6] | OCC2POL [1:0]  | RW   | 00      | OCC2 polarity setting bits, see Table 5 (OCC Polarity Configuration) |

## REGISTER DESCRIPTION

The Accumulator Control and Deadband Registers allow to control the accumulation of Charge1, Energy1, Charge2, Energy2, Charge3 and Energy4 (C1, E1, C2, E2, C3, E4). Accumulation can be enabled, disabled or conditionally enabled based on the sign and absolute value of a measured current. C1 contains accumulated I1, C2 contains accumulated I2, E1 contains accumulated P1 and E2 contains accumulated P2. C3 contains the accumulated sum of I1 and I2 weighted by the gain setting parameters (see Gain Configuration Registers section) and E4 the accumulated weighted sum of P1 and P2.

For example, by setting bit 0 of the ACCCTRL1 and bit 1 of ACCCTRL2, C1 contains the accumulation of positive currents I1 and C3 contains the accumulation of negative currents.

**Table 52. Accumulator Control ACCCTRL1(0xE1)**

| BIT   | SYMBOL      | TYPE | DEFAULT | OPERATION                                                                                                                                                |
|-------|-------------|------|---------|----------------------------------------------------------------------------------------------------------------------------------------------------------|
| [1:0] | ACC1I1[1:0] | RW   | 00      | Accumulation control of Charge1/Charge2 and Energy1/Energy2.                                                                                             |
| [3:2] | ACC2I2[1:0] | RW   | 00      | 00: Accumulation takes place always,<br>01: Only if the current is positive,<br>10: Only if the current is negative,<br>11: No accumulation takes place. |

**Table 53. Accumulator Control ACCCTRL2(0xE2)**

| BIT   | SYMBOL      | TYPE | DEFAULT | OPERATION                                                                                                                                                |
|-------|-------------|------|---------|----------------------------------------------------------------------------------------------------------------------------------------------------------|
| [1:0] | ACC3I1[1:0] | RW   | 00      | Accumulation control of Charge3 and Energy4.                                                                                                             |
| [3:2] | ACC3I2[1:0] | RW   | 00      | 00: Accumulation takes place always,<br>01: Only if the current is positive,<br>10: Only if the current is negative,<br>11: No accumulation takes place. |
| [5:4] | ACC4I1[1:0] | RW   | 00      |                                                                                                                                                          |
| [7:6] | ACC4I2[1:0] | RW   | 00      |                                                                                                                                                          |

Small offset voltages in the current measurement path lead to large charge errors after a long integration time. The accumulator dead band registers allow to set a minimum absolute value of I1 and I2 before being accumulated.

**Table 54. Accumulation Dead Band ACCIDB1(0xE4)**

| BIT   | SYMBOL  | TYPE | DEFAULT | OPERATION                                                                                                                                                                                                                                                                                                                                                                                   |
|-------|---------|------|---------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| [7:0] | ACCIDB1 | RW   | 0x0     | Current 1 deadband for accumulation. If the absolute value of I1 is higher than or equal this value, I1 and P1 are accumulated and C1, E1, C3, E4 are updated. A comparison to the respective thresholds takes place right after an update. If the absolute value of I1 is lower, I1 and P1 are not accumulated and C1 and E1 are not updated. Unit is the same as LSB of current I1(0x90). |

**Table 55. Accumulation Dead Band ACCIDB2(0xE5)**

| BIT   | SYMBOL  | TYPE | DEFAULT | OPERATION                                                                                                                                                                                                                                                                                                                                                                                   |
|-------|---------|------|---------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| [7:0] | ACCIDB2 | RW   | 0x0     | Current 2 deadband for accumulation. If the absolute value of I2 is higher than or equal this value, I2 and P2 are accumulated and C2, E2, C3, E4 are updated. A comparison to the respective thresholds takes place right after an update. If the absolute value of I2 is lower, I2 and P2 are not accumulated and C2 and E2 are not updated. Unit is the same as LSB of current I2(0x96). |

## REGISTER DESCRIPTION

The Time Base Control Register selects between the internal and an external reference clock, and sets the time base parameters when an external reference clock is used. Set PRE[2:0] = 111b or 7d (default) to enable the internal reference clock. To use an external reference clock, set the values of PRE[2:0] and DIV[4:0] according to the external clock frequency; see the Timebase Control section for more information.

**Table 56. Timebase Control TBCTRL (0xE9), DEFAULT VALUE: 0x07**

| BIT   | SYMBOL    | TYPE | DEFAULT | OPERATION                                                                           |
|-------|-----------|------|---------|-------------------------------------------------------------------------------------|
| [2:0] | PRE [2:0] | RW   | 111     | Prescaler value [2:0], binary coded, see Table 2. Parameter PRE with External Clock |
| [7:3] | DIV [4:0] | RW   | 00000   | Divider value [4:0], binary coded, see Table 3                                      |

The multiplexer inputs are selected by the Multiplexer Control Registers. For each of the multiplexer outputs MUXP and MUXN, a 5-bit word selects the connected input.

**Table 57. MUX Settings**

| MUXP/MUXN Setting |       | Selected Input                                         |
|-------------------|-------|--------------------------------------------------------|
| Binary [4:0]      | Dec   |                                                        |
| 11XXX             | 31-24 | Reserved                                               |
| 10111             | 23    | VREF2 via 250k, see Safety Manual for more information |
| 10110             | 22    | VREF2                                                  |
| 10101             | 21    | Reserved                                               |
| 10100             | 20    | CF1P                                                   |
| 10011             | 19    | CF1M                                                   |
| 10010             | 18    | CF2P                                                   |
| 10001             | 17    | CF2M                                                   |
| 10000             | 16    | VBATP                                                  |
| 01111             | 15    | VBATM                                                  |
| 01110             | 14    | IPT, see Safety Manual for more information            |
| 01101             | 13    | IMT, see Safety Manual for more information            |
| 01100             | 12    | V12                                                    |
| 01011             | 11    | V11                                                    |
| 01010             | 10    | V10                                                    |
| 01001             | 9     | V9                                                     |
| 01000             | 8     | V8                                                     |
| 00111             | 7     | V7                                                     |
| 00110             | 6     | V6                                                     |
| 00101             | 5     | V5                                                     |
| 00100             | 4     | V4                                                     |
| 00011             | 3     | V3                                                     |
| 00010             | 2     | V2                                                     |
| 00001             | 1     | V1                                                     |
| 00000             | 0     | AGND                                                   |

## REGISTER DESCRIPTION

In slow, high precision mode the auxiliary channel (CHAUX) converts in Round Robin mode two differential inputs signals. For each of the two slots, the inputs multiplexed to MUXP and MUXN can be chosen by programming the corresponding 5-bit setting in the following four registers.

In fast mode, the auxiliary channel (CHAUX) converts only one differential input signal, which can be chosen by choosing the corresponding 5-bit setting in the Fast MUXP and MUXN Control registers.

During fast continuous measurements it is not possible to change the AUX MUX configuration. See note in chapter 'Fast Measurement Timings'.

**Table 58. Multiplexer Control Registers in Slow Mode**

| ADDR | BIT   | SYMBOL          | TYPE | DEFAULT | OPERATION                                            |
|------|-------|-----------------|------|---------|------------------------------------------------------|
| 0xEB | [4:0] | SLOT1MUXN [4:0] | RW   | 00000   | Slot1 MUXN [4:0] setting, binary coded, see Table 57 |
| 0xEC | [4:0] | SLOT1MUXP [4:0] | RW   | 00000   | Slot1 MUXP [4:0] setting, binary coded, see Table 57 |
| 0xED | [4:0] | SLOT2MUXN [4:0] | RW   | 00000   | Slot2 MUXN [4:0] setting, binary coded, see Table 57 |
| 0xEE | [4:0] | SLOT2MUXP [4:0] | RW   | 00000   | Slot2 MUXP [4:0] setting, binary coded, see Table 57 |

**Table 59. Multiplexer Control Registers for Fast Mode**

| ADDR | BIT   | SYMBOL       | TYPE | DEFAULT | OPERATION                                                |
|------|-------|--------------|------|---------|----------------------------------------------------------|
| 0xF3 | [4:0] | FAMUXN [4:0] | RW   | 00000   | Fast Mode MUXN [4:0] setting, binary coded, see Table 57 |
| 0xF4 | [4:0] | FAMUXP [4:0] | RW   | 00000   | Fast Mode MUXP [4:0] setting, binary coded, see Table 57 |

The Fast Control Register allows to configure and trigger fast conversions.

There is a timing constraint when writing to FGPIOCTRL and FACTRL, see description for FGPIOCTRL.

**Table 60. Fast Control Register FACTRL (0xF5)**

| BIT | SYMBOL | TYPE | DEFAULT | OPERATION                                                                                                                                         |
|-----|--------|------|---------|---------------------------------------------------------------------------------------------------------------------------------------------------|
| 0   | FACONV | RW   | 0       | Continuous fast conversion enable (1) / disable (0). Conversion results are written to a FIFO if at least one of bits FACHA, FACH1, FACH2 is set. |
| 1   | FACHA  | RW   | 0       | Channel AUX fast mode configuration bit. Fast conversion starts within some us after rising edge of FACONV or when issuing the ADCV command.      |
| 2   | FACH1  | RW   | 0       | Channel 1 fast mode configuration bit. Fast conversion starts within some us after rising edge of FACONV or when issuing the ADCV command.        |
| 3   | FACH2  | RW   | 0       | Channel 2 fast mode configuration bit. Fast conversion starts within some us after rising edge of FACONV or when issuing the ADCV command.        |

## REGISTER DESCRIPTION

The GPIO control registers allow to configure the GPIO pins to be either tristate, low, high or toggling at 400kHz by setting the corresponding GPIO CTRL bits in 0xF1 and 0xF2.

GPIO4 and GPIO5 can be used as heartbeat pins toggling with a frequency of 400kHz and become static low upon an alert. While GPIO5 is activated by enabling any of the overcurrent comparators and is dedicated to alerts issued by these comparators, GPIO4 can be configured by the GPIO4 heartbeat control register (0xE8) to respond on any alert not masked by the mask registers. The setting in the GPIO4 heartbeat control register overrules the GPIO4CTRL setting in 0xF2. Similarly GPIO5CTRL setting in 0xF1 is overruled by enabling the overcurrent comparators.

**Table 61. GPIO4 Heartbeat Control GPIO4HBCTRL (0xE8)**

| BIT | SYMBOL    | TYPE | DEFAULT | OPERATION                                                                                                                                                                                    |
|-----|-----------|------|---------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 0   | GPIO4HBEN | RW   | 0       | GPIO4 heartbeat master enable control<br>0: GPIO4 is not configured as heart beat.<br>1: GPIO4 is configured as heart beat and unmasked alerts (see mask registers) stop heart beat of GPIO4 |

**Table 62. Current Source and GPIO5 Control FCURGPIOCTRL (0xF1)**

| BIT   | SYMBOL          | TYPE | DEFAULT | OPERATION                                                                                   |
|-------|-----------------|------|---------|---------------------------------------------------------------------------------------------|
| [1:0] | GPIO5CTRL [1:0] | RW   | 00      | GPIO5 CTRL:<br>[00]=Tristate<br>[01]=LOW(DGND),<br>[10]=Toggle at 400kHz<br>[11]=HIGH(DVCC) |
| 4     | MUXPCURPOL      | RW   | 0       | 0: MUXP sinks 250μA of current<br>1: MUXP sources 250μA of current                          |
| 5     | MUXPCUREN       | RW   | 0       | 0: MUXP current source off<br>1: MUXP current source on                                     |
| 6     | MUXNCURPOL      | RW   | 0       | 0: MUXN sinks 250μA of current<br>1: MUXN sources 250μA of current                          |
| 7     | MUXNCUREN       | RW   | 0       | 0: MUXN current source off<br>1: MUXN current source on                                     |

The 250μA current sources at MUXP and MUXN allow open wire detection at all multiplexer inputs. If enabled, the current sources connect to the inputs during the time the ADC is connected and performs the conversion, no matter if it is the fast or slow channel. Typically, open wire detection is performed using the fast channel by first writing current source, GPIO and MUX control (4-byte write to 0xF1-0xF4), triggering the fast conversion by sending the ADCV, reading the results with RDCV and finally by writing again 4 bytes to 0xF1-0xF4 to set the next MUX input and current source configuration. This way, the time when current sources are enabled on a dedicated pin, is precisely timed. See the safety manual for more information.

Enabled current source on MUXP will alter the internal measurement of VREF (~4V/~0.7V when MUXPCURPOL = 1 / 0) and this change won't be visible on the external VREF pin. If enabled, also the NTC temperature measurement and the compensation of a shunt resistor's temperature drift will be altered, as they depend on the internal VREF measurement. The correct VREF voltage can always be measured via an external connection to one Vx pin, see also section Unused Input Pins V1-V12.

## REGISTER DESCRIPTION

**Table 63. GPIO Control FGPIOTRL (0xF2)**

| BIT   | SYMBOL          | TYPE | DEFAULT | OPERATION                                                                                     |
|-------|-----------------|------|---------|-----------------------------------------------------------------------------------------------|
| [1:0] | GPIO1CTRL [1:0] | RW   | 00      | GPIO1-4 CTRL:<br>[00]=Tristate<br>[01]=LOW(DGND),<br>[10]=Toggle at 400kHz<br>[11]=HIGH(DVCC) |
| [3:2] | GPIO2CTRL [1:0] | RW   | 00      |                                                                                               |
| [5:4] | GPIO3CTRL [1:0] | RW   | 00      |                                                                                               |
| [7:6] | GPIO4CTRL [1:0] | RW   | 00      |                                                                                               |

If set to tristate, the GPIO pins can be used as analog inputs (V8-V12) to the auxiliary channel by choosing the corresponding multiplexer settings according to Table 57.

Write to register FCURGPIOCTRL does not take effect immediately. Instead any changes will only become active once FGPIOTRL is written. Thus it is recommended to always write both registers in a single burst.

Additionally there is a timing constraint when writing to FGPIOTRL and FACTRL. Writing to those registers must always be delayed by a minimum of 1ms. Thus, its not allowed to write FGPIOTRL and FACTRL in a single burst. Usually this can be easily achieved by partitioning code sections properly that control those registers.

**Table 64. RDCV Indirect Address (0xFC)**

| BIT   | SYMBOL    | TYPE | DEFAULT | OPERATION                                                                                                  |
|-------|-----------|------|---------|------------------------------------------------------------------------------------------------------------|
| [7:0] | RDCVIADDR | RW   | 0       | Address pointer for indirect memory access via RDCV command, see section Indirectly Addressed RDCV Command |

The following register is provided for software debug purposes only. It allows synchronization of the host controller to the CORE system tick. DBGCNT is reset by the CORE after the last register of memory page 0 was updated. This happens typically 23ms after the end of a slow mode current/power conversion (EOC of I1, I2, P1, P2).

**Table 65. DBGCNT (0xD5)**

| SYMBOL | SI/UI | OPERATION                                                                                                                                                  |
|--------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------|
| DBGCNT | UI    | Debug counter, counts milliseconds, resets once per core cycle. In MEASURE mode it typically counts 0 to 100; in STANDBY mode it typically counts 0 to 17. |

## REGISTER DESCRIPTION

### REGISTER MAP PAGE1

PAGE1 of the LTC2949 register map contains threshold and configuration registers. The threshold registers allow to set threshold values for each measured quantity. The configuration registers allow to store application and board specific parameters and settings, which usually do not need to be modified during operation.

### Software Reset

The LTC2949 has a software reset feature, described in following table.

**Table 66. RSTUNLCK (p1.0xA9)**

| SYMBOL   | OPERATION                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
|----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| RSTUNLCK | <p>Writing 0x55 to this register will unlock the RESET function within OPCTRL. After putting LTC2949 into SLEEP mode a writing command to OPCTR with the value 0x80 will issue the reset. Detailed steps to reset LTC2949 are:</p> <ol style="list-style-type: none"> <li>1. Write 0 to OPCTRL (0xF0)</li> <li>2. Write 0x55 to RSTUNLCK (0xA9 on page 1)</li> <li>3. Wait 130ms</li> <li>4. Go to SLEEP (set bit SLEEP in OPCTRL)</li> <li>5. Wait 20ms</li> <li>6. Write 0x80 to OPCTRL (0xF0)</li> </ol> |

### Threshold Registers

The threshold registers set threshold values for each measured quantity. When a measured value exceeds its threshold, an alert is triggered and the corresponding bits in the threshold and overflow alert registers (0x81 to 0x87) are set. When GPIO4 heartbeat is enabled in register GPIO4HBCTRL (0xE8), unmasked alerts in registers (0x88 to 0x8F) stop heartbeat on GPIO4. Value scaling is done in the same manner as in the corresponding result register values, using LSB values from Table 26, Table 27 and Table 28. Non-Accumulated Results Register Parameters.

**Table 67. Threshold Registers**

| ADDRESS | NAME        | TYPE | DEFAULT               | PARAMETER                |
|---------|-------------|------|-----------------------|--------------------------|
| p1.0x00 | C1TH[47:0]  | RW   | 0x7FFF FFFF FFFF      | Charge1 threshold high   |
| p1.0x06 | C1TL[47:0]  | RW   | 0x8000 0000 0000      | Charge1 threshold low    |
| p1.0x0C | TB1TH[31:0] | RW   | 0xFFFF FFFF           | Timebase1 threshold high |
| p1.0x10 | E1TH[47:0]  | RW   | 0x7FFF FFFF FFFF      | Energy1 threshold high   |
| p1.0x16 | E1TL[47:0]  | RW   | 0x8000 0000 0000      | Energy1 threshold low    |
| p1.0x20 | C2TH[47:0]  | RW   | 0x7FFF FFFF FFFF      | Charge2 threshold high   |
| p1.0x26 | C2TL[47:0]  | RW   | 0x8000 0000 0000      | Charge2 threshold high   |
| p1.0x2C | TB2TH[31:0] | RW   | 0xFFFF FFFF           | Timebase2 threshold high |
| p1.0x30 | E2TH[47:0]  | RW   | 0x7FFF FFFF FFFF      | Energy2 threshold high   |
| p1.0x36 | E2TL[47:0]  | RW   | 0x8000 0000 0000      | Energy2 threshold low    |
| p1.0x44 | C3TH[63:0]  | RW   | 0x7FFF FFFF FFFF FFFF | Charge3 threshold high   |
| p1.0x4C | TB3TH[31:0] | RW   | 0xFFFF FFFF           | Timebase3 threshold high |
| p1.0x54 | C3TL[63:0]  | RW   | 0x8000 0000 0000 0000 | Charge3 threshold low    |

## REGISTER DESCRIPTION

**Table 67. Threshold Registers (continued)**

| ADDRESS | NAME          | TYPE | DEFAULT               | PARAMETER                      |
|---------|---------------|------|-----------------------|--------------------------------|
| p1.0x64 | E4TH[63:0]    | RW   | 0x7FFF FFFF FFFF FFFF | Energy4 threshold high         |
| p1.0x6C | TB4TH[31:0]   | RW   | 0xFFFF FFFF           | Timebase4 threshold high       |
| p1.0x74 | E4TL[63:0]    | RW   | 0x8000 0000 0000 0000 | Energy4 threshold low          |
| p1.0x80 | I1TH[15:0]    | RW   | 0x7FFF                | Current1 threshold high        |
| p1.0x82 | I1TL[15:0]    | RW   | 0x8000                | Current1 threshold low         |
| p1.0x84 | P1TH[15:0]    | RW   | 0x7FFF                | Power1 threshold high          |
| p1.0x86 | P1TL[15:0]    | RW   | 0x8000                | Power1 threshold low           |
| p1.0x88 | I2TH[15:0]    | RW   | 0x7FFF                | Current2 threshold high        |
| p1.0x8A | I2TL[15:0]    | RW   | 0x8000                | Current2 threshold low         |
| p1.0x8C | P2TH[15:0]    | RW   | 0x7FFF                | Power2 threshold high          |
| p1.0x8E | P2TL[15:0]    | RW   | 0x8000                | Power2 threshold low           |
| p1.0x90 | BATTH[15:0]   | RW   | 0x7FFF                | BAT threshold high             |
| p1.0x92 | BATTL[15:0]   | RW   | 0x8000                | BAT threshold low              |
| p1.0x94 | TEMPTH[15:0]  | RW   | 0x7FFF                | Die temperature threshold high |
| p1.0x96 | TEMPTL[15:0]  | RW   | 0x8000                | Die temperature threshold low  |
| p1.0x98 | VCCTH[15:0]   | RW   | 0x7FFF                | VCC threshold high             |
| p1.0x9A | VCCTL[15:0]   | RW   | 0x8000                | VCC threshold low              |
| p1.0xA0 | SLOT1TH[15:0] | RW   | 0x7FFF                | Slot1 threshold high           |
| p1.0xA2 | SLOT1TL[15:0] | RW   | 0x8000                | Slot1 threshold low            |
| p1.0xA4 | SLOT2TH[15:0] | RW   | 0x7FFF                | Slot2 threshold high           |
| p1.0xA6 | SLOT2TL[15:0] | RW   | 0x8000                | Slot2 threshold low            |

### FLOAT24 Format

The NTC configuration parameters and the gain correction factors described in the following paragraphs are stored as floating point numbers represented by the FLOAT24 format according to IEEE 754 standard. The LTC2949 implementation uses 1-bit for sign, a 7-bit exponent in two's complement format with 63 as bias and 16-bits for the mantissa, with an implicit leading bit of value 1 unless the exponent is stored with all zeros. As an example the value of 0.95 is represented by the 3 bytes number 0x3EE666 as shown below:

**Table 68. FLOAT24 Example**

| 3E   |             |   |   |   |   |   |   | E6           |   |   |   |   |   |   |              | 66 |   |   |   |   |  |  |  |
|------|-------------|---|---|---|---|---|---|--------------|---|---|---|---|---|---|--------------|----|---|---|---|---|--|--|--|
| 0    | 0           | 1 | 1 | 1 | 1 | 1 | 0 | 1            | 1 | 1 | 0 | 0 | 1 | 1 | 0            | 0  | 1 | 1 | 0 | 0 |  |  |  |
| Sign | Exponent    |   |   |   |   |   |   | Mantissa MSB |   |   |   |   |   |   | Mantissa LSB |    |   |   |   |   |  |  |  |
| 1 x  | 2^(62-63) x |   |   |   |   |   |   | (1+0.899994) |   |   |   |   |   |   |              |    |   |   |   |   |  |  |  |

$$= 0.5 \cdot 1.899994 = 0.94999$$

The GUI controlling the LTC2949 demo board supports converting numbers to FLOAT24. The code section of the LTC2949 (<https://www.analog.com/en/products/ltc2949.html#product-tools>) also provides conversion functions written in C/C++ for this purpose.

LTC2949.cpp contains following conversion functions:

```
void LTC2949_FloatToF24Bytes(float f32, byte* bytes)
```

```
void LTC2949_F24BytesToFloat(byte* bytes, float* f32)
```

## REGISTER DESCRIPTION

### Configuration Registers

The following registers allow to configure LTC2949 application specific. Please note that LTC2949 must be in STANDBY and an update of these registers must be requested by setting the ADJUPD bit in the Operation Control Register (OPC-TRL) to make changes effective.

### ADC Configuration Register

The ADC Configuration Register allows to disable power multiplication on P1ADC and P2ADC, and to turn on NTC linearization of Slot1/2 measurements.

**Table 69. ADC Configuration ADCCONF (p1.0xDF)**

| BIT | SYMBOL   | TYPE | DEFAULT | OPERATION                                                                                                                                                                                         |
|-----|----------|------|---------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 0   | P1ASV    | RW   | 0       | 0: P1ADC configured to power mode<br>1: P1ADC configured to voltage mode                                                                                                                          |
| 1   | P2ASV    | RW   | 0       | 0: P2ADC configured to power mode<br>1: P2ADC configured to voltage mode                                                                                                                          |
| 3   | NTC1     | RW   | 0       | 0: SLOT1 voltage measurement.<br>SLOT1 output LSB = 375 $\mu$ V<br>1: SLOT1 NTC temperature measurement.<br>SLOT1 output LSB = 0.2°C                                                              |
| 4   | NTC2     | RW   | 0       | 0: SLOT2 voltage measurement.<br>SLOT2 output LSB = 375 $\mu$ V<br>1: SLOT2 NTC temperature measurement.<br>SLOT2 output LSB = 0.2°C                                                              |
| 6   | NTCSLOT1 | RW   | 0       | 0: TC compensation of shunt for I1 (I2) is linked to temperature measurement via SLOT1 (SLOT2).<br>1: TC compensation of shunt for I1 and I2 is linked to temperature measurement via SLOT1 only. |

See NTC Configuration Registers and section Temperature Measurement for more information regarding NTC temperature measurement.

See Table 28 and Table 31 for effect of P1ASV/P2ASV on LSB sizes or Power-ADC related measurements/settings.

**Table 70. Allowed Combinations of FACTRL and ADCVCONF (PxASV) Configurations.**

| FACONV | FACH1 | FACH2 | P1ASV  | P2ASV  | FAST BAT (b)   | SLOW P1                 | SLOW P2            |
|--------|-------|-------|--------|--------|----------------|-------------------------|--------------------|
| 0 or 1 | 1     | 0     | 0 or 1 | 0 or 1 | Not Supported! |                         |                    |
| 0 or 1 | 0     | 1     | 1      | 1      |                |                         |                    |
| 0 or 1 | 0     | 0     | 0 or 1 | 0 or 1 | N/A            | 18-Bit Power or Voltage |                    |
| 0 or 1 | 0     | 1     | 0      | 0      | N/A            | 18-Bit Power            | N/A                |
| 0 or 1 | 0     | 1     | 0      | 1      | P2             | 18-Bit Power            | N/A                |
| 0 or 1 | 0     | 1     | 1      | 0      | N/A            | 18-Bit Voltage          | N/A                |
| 1      | 1     | 1     | 0      | 0      | N/A            | 11-Bit Power (c)        |                    |
| 1      | 1     | 1     | 0      | 1      | P2             | 11-Bit Power (c)        | 11-Bit Voltage (c) |
| 1      | 1     | 1     | 1      | 0      | P1             | 11-Bit Voltage (c)      | 11-Bit Power (c)   |
| 1      | 1     | 1     | 1      | 1      | P1             | 11-Bit Voltage (c)      |                    |
| 0      | 1     | 1     | 0      | 0      | N/A            | 18-Bit Power (a)        |                    |
| 0      | 1     | 1     | 0      | 1      | P2             | 18-Bit Power (a)        | 18-Bit Voltage (a) |
| 0      | 1     | 1     | 1      | 0      | P1             | 18-Bit Voltage (a)      | 18-Bit Power (a)   |
| 0      | 1     | 1     | 1      | 1      | P1             | 18-Bit Voltage (a)      |                    |

a) Any fast single shot measurement will interrupt the slow channel measurements. Slow channel will only resume to be updated if there was no fast single shot measurement for at least 160ms.

b) 15-bit Fast BAT (VBATP-VBATM) voltage measurement via one power ADC. It is always possible to measure VBATP-VBATM via AUX ADC in fast (FACHA=1) or slow mode.

c) Power ADCs (PxASV=0) of channels configured to fast mode will provide 11-bit conversions at an update rate of 100ms via P1/P2 registers. The LSB size stays the same, but the resolution in this case is only guaranteed to be 11-bit.

## REGISTER DESCRIPTION

### NTC Configuration Registers

When bits NTC1 and NTC2 in the ADC Configuration Register are set, LTC2949 reports the result of the corresponding CHAUX slot in temperature by comparing NTC resistance to reference resistors and solving Steinhart-Hart equations. The NTC Configuration Registers allow to set values of Steinhart-Hart coefficients (A,B,C) and reference resistors.

Furthermore, linear temperature coefficients of up to two external sense resistors can be compensated by thermally closely coupled NTC thermistors. Temperature compensation is enabled by writing the respective temperature coefficient and its reference temperature ( $T_0$ ) in the NTC Configuration Register. See section Temperature Measurement and Sense Resistor Temperature Compensation for more details.

**Table 71. NTC Configuration Registers**

| ADDRESS | NAME         | TYPE | DEFAULT  | PARAMETER                                           | UNIT               | FORMAT  |
|---------|--------------|------|----------|-----------------------------------------------------|--------------------|---------|
| p1.0xAA | RREF1[23:0]  | RW   | 0x000000 | NTC1 reference resistor                             | $\Omega$           | Float24 |
| p1.0xAD | RREF2[23:0]  | RW   | 0x000000 | NTC2 reference resistor                             | $\Omega$           | Float24 |
| p1.0xD0 | NTC1A[23:0]  | RW   | 0x000000 | NTC1 Coefficient A                                  |                    | Float24 |
| p1.0xD3 | NTC1B[23:0]  | RW   | 0x000000 | NTC1 Coefficient B                                  |                    | Float24 |
| p1.0xD6 | NTC1C[23:0]  | RW   | 0x000000 | NTC1 Coefficient C                                  |                    | Float24 |
| p1.0xD9 | RS1TC[23:0]  | RW   | 0x000000 | Sense resistor 1 (RS1) temperature coefficient (TC) | 1/K                | Float24 |
| p1.0xDC | RS1T0[16:0]  | RW   | 0x0000   | Reference temperature for TC compensation of RS1    | $^{\circ}\text{C}$ | Float24 |
| p1.0xE0 | NTC2A[23:0]  | RW   | 0x000000 | NTC2 Coefficient A                                  |                    | Float24 |
| p1.0xE3 | NTC2B[23:0]  | RW   | 0x000000 | NTC2 Coefficient B                                  |                    | Float24 |
| p1.0xE6 | NTC2C[23:0]  | RW   | 0x000000 | NTC2 Coefficient C                                  |                    | Float24 |
| p1.0xE9 | RS2TC[23:0]  | RW   | 0x000000 | Sense resistor 2 (RS2) temperature coefficient (TC) | 1/K                | Float24 |
| p1.0xEC | RS2T0[16:0]  | RW   | 0x0000   | Reference temperature for TC compensation of RS2    | $^{\circ}\text{C}$ | Float24 |
| p1.0x5C | RS1TC2[23:0] | RW   | 0x000000 | 2nd order TC of sense resistor 1                    | $1/\text{K}^2$     | Float24 |
| p1.0x7C | RS2TC2[23:0] | RW   | 0x000000 | 2nd order TC of sense resistor 2                    | $1/\text{K}^2$     | Float24 |

Note that for the two 16-bit registers storing reference temperature RS1T0 and RS2T0 the least significant byte (LSB) of the mantissa is implicitly 0

### Gain Configuration Registers

The LTC2949 can store gain correction factors for two current sense resistor, the battery voltage divider and four multiplexer inputs to compensate tolerances of external components in its Gain Setting Registers located between 0xB0 and 0xCF on measured page 1 of the register map. When these factors are set different than their default value of 1.0, the LTC2949 corrects the computed values of current, voltage, power, charge and energy accordingly. As the LTC2949 accumulators can be configured to compute the sums of charge and energy flown through two sense resistors, also the nominal ratio between the two sense resistors  $\text{RSRATIO} = R_{S1}/R_{S2}$  can be stored. The LTC2949 then multiplies the measurements of CH2 (I2, P2) by RSRATIO before adding them to the sum of charge (C3) or energy (E4). All these factors are stored in the Float24 format according to IEEE 754 standard described earlier.

**Table 72. Gain Configuration Registers**

| ADDRESS | NAME          | TYPE | DEFAULT   | PARAMETER                                            | FORMAT  |
|---------|---------------|------|-----------|------------------------------------------------------|---------|
| p1.0xB0 | RS1GC[23:0]   | RW   | 0x3F00 00 | Sense resistor 1 ( $R_{S1}$ ) gain correction factor | Float24 |
| p1.0xB3 | RS2GC[23:0]   | RW   | 0x3F00 00 | Sense resistor 2 ( $R_{S2}$ ) gain correction factor | Float24 |
| p1.0xB6 | RSRATIO[23:0] | RW   | 0x3F00 00 | Nominal ratio of $R_{S1}$ to $R_{S2}$                | Float24 |
| p1.0xB9 | BATGC[23:0]   | RW   | 0x3F00 00 | BAT gain correction factor                           | Float24 |
| p1.0xC0 | MUX1GC[23:0]  | RW   | 0x3F00 00 | Gain correction factor for MUX setting 1             | Float24 |
| p1.0xC3 | MUX2GC[23:0]  | RW   | 0x3F00 00 | Gain correction factor for MUX setting 2             | Float24 |
| p1.0xC6 | MUX3GC[23:0]  | RW   | 0x3F00 00 | Gain correction factor for MUX setting 3             | Float24 |
| p1.0xC9 | MUX4GC[23:0]  | RW   | 0x3F00 00 | Gain correction factor for MUX setting 4             | Float24 |

Rev A

## REGISTER DESCRIPTION

**Table 72. Gain Configuration Registers (continued)**

| ADDRESS | NAME          | TYPE | DEFAULT | PARAMETER                      | FORMAT                          |
|---------|---------------|------|---------|--------------------------------|---------------------------------|
| p1.0xBC | MUXNSET1[4:0] | RW   | 0x00    | MUXN gain correction setting 1 | MUXN binary coded, see Table 57 |
| p1.0xBD | MUXPSET1[4:0] | RW   | 0x00    | MUXP gain correction setting 1 | MUXP binary coded, see Table 57 |
| p1.0xBE | MUXNSET2[4:0] | RW   | 0x00    | MUXN gain correction setting 2 | MUXN binary coded, see Table 57 |
| p1.0xBF | MUXPSET2[4:0] | RW   | 0x00    | MUXP gain correction setting 2 | MUXP binary coded, see Table 57 |
| p1.0xCC | MUXNSET3[4:0] | RW   | 0x00    | MUXN gain correction setting 3 | MUXN binary coded, see Table 57 |
| p1.0xCD | MUXPSET3[4:0] | RW   | 0x00    | MUXP gain correction setting 3 | MUXP binary coded, see Table 57 |
| p1.0xCE | MUXNSET4[4:0] | RW   | 0x00    | MUXN gain correction setting 4 | MUXN binary coded, see Table 57 |
| p1.0xCF | MUXPSET4[4:0] | RW   | 0x00    | MUXP gain correction setting 4 | MUXP binary coded, see Table 57 |

As an example, if a sense resistor of nominal 100μΩ is used for CH1, but a board calibration reveals the sense resistor value to be 102μΩ, a factor of  $100/102 = 0.9804$  should be written to RS1GC [23:0] = float24(0.9804) = 0x3EF5F5.

Assuming a sense resistor of nominal value 10mΩ but real value of 9.8mΩ is used for CH2 the factor 1.024 should be programmed in RS2GC [23:0] = float24(1.024) = 0x3F0624 and a factor 0.01 should be programmed in RSRATIO[23:0] = float24(0.01) = 0x3847AE.

In many applications the LTC2949 measures high voltages using external resistor dividers which suffer from gain errors due to resistor tolerances. The LTC2949 allows to store gain correction factors for the measurement of battery voltage and four programmable MUX settings. E.g.: The LTC2949 will apply gain correction of 0.9 to differential measurements between V1 and V2 if registers MUX1GC[23:0] = 0x3ECCCC, MUXPSET1[7:0] = 0x01 and MUXNSET1[7:0] = 0x02, see also Table 57.

The assignment between MUX[1-4]GC and MUX[P,N]SET[1-4] is independent of the polarity of the MUX settings. Related to the example above the same gain correction is applied for measurements V1-V2 and V2-V1. Also swapping the register values of MUXPSET1 and MUXNSET1 leads to the same behaviour. The link between gain correction parameters and measurements is summarized in Table 73.

All Gain Configuration Registers can be copied to an external EEPROM, enabling a modular approach to factory calibration of application boards.

**Table 73. Relation Between Gain Correction Parameters and Measurements**

| NAME       | AFFECTED MEASUREMENTS                                                                                                                                                                                                           |
|------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| BATGC      | BAT for slow and fast measurements<br>P1, P2, E1, E2, E4<br>SLOT[1,2] AUX measurements if SLOT[1,2]MUX[P,N] is set to VBATP, VBATM of any polarity<br>Fast AUX conversions if FAMUX[P,N] is set to VBATP, VBATM of any polarity |
| MUX[1-4]GC | Slow and fast AUX measurements if SLOT[1,2]MUX[P,N] or FAMUX[P,N] matches MUX[P,N]SET[1-4] of any polarity                                                                                                                      |
| RS[1,2]GC  | I1, I2, P1, P2, C1, C2, C3, E1, E2, E4                                                                                                                                                                                          |
| RSRATIO    | C3, E4 (Note: The charge that is accumulated to C3 is $(I1 + RSRATIO \cdot I2) \cdot dT$ , the energy that is accumulated to E4 is $(P1 + RSRATIO \cdot P2) \cdot dT$ )                                                         |

## REGISTER DESCRIPTION

### External EEPROM Control Register

To prevent data loss when the LTC2949 is not powered, it can store its entire register content in an external EEPROM via its dedicated I<sup>2</sup>C interface. The communication to an EEPROM is controlled by the EEPROM Control Register (EEPROMCTRL).

**Table 74. EEPROM Control Register EEPROMCTRL (p1.0x50)**

| BIT | SYMBOL     | TYPE | DEFAULT | OPERATION                               | DURATION |
|-----|------------|------|---------|-----------------------------------------|----------|
| 0   | INIT       | SO   | 0       | Write signature to EEPROM               | 40ms     |
| 1   | CHECK      | SO   | 0       | Check the signature in EEPROM           | 25ms     |
| 2   | SAVE       | SO   | 0       | Save MEM (but special row) to EEPROM    | 1100ms   |
| 3   | RESTORE    | SO   | 0       | Restore EEPROM to MEM (but special row) | 1250ms   |
| 4   | INITRSL    | RW   | 0       | Result of INIT                          |          |
| 5   | CHECKRSL   | RW   | 0       | Result of CHECK                         |          |
| 6   | SAVERSL    | RW   | 0       | Result of SAVE                          |          |
| 7   | RESTORERSL | RW   | 0       | Result of RESTORE                       |          |

The lower 4-bits of the EEPROMCTRL are SET ONLY and trigger dedicated communications with the EEPROM, while the higher 4-bits are read/write and are set by the LTC2949 after the typical time given in the column Duration upon a successful termination of a communication and must be reset by a write command from the host before the next communication is requested.

Before any other interaction, the EEPROM must be initialized by setting the INIT bit, which causes LTC2949 to write a defined signature to the EEPROM. Once the signature is written, LTC2949 will reset the INIT bit and set the INITRSL bit if the EEPROM has acknowledged according to the I<sup>2</sup>C protocol. Any other interaction with the EEPROM will be preceded by reading and checking this signature – additionally the signature can be checked by setting bit CHECK and verifying that bit CHECKRSL is set after bit CHECK was reset by LTC2949.

Setting bit SAVE causes the LTC2949 to save its entire memory except the last common row of both register pages to the EEPROM together with a CRC calculated from the entire register content. LTC2949 signals a successful save operation by setting bit SAVERSL, based on the check of the signature and the acknowledge of the EEPROM.

Setting bit RESTORE causes the LTC2949 to copy the content of the EEPROM to its internal RAM, calculate the CRC and set bit RESTORERSL if the CRC was found correct.

Any communication with the external EEPROM requires the LTC2949 to be in STANDBY mode to prevent data loss or data corruption.

Many applications require to store additional custom data, e.g. serial number. The reserved registers p1.0x1C - p1.0x1F (4 bytes) and p1.0x3C - p1.0x3F (4 bytes) can be used for that purpose. Additionally, registers of LTC2949 that do not require a board specific initialization and thus are initialized by the host controller, can be used to store custom data. For example, all accumulators are either just initialized with zero or via some state-of-charge algorithm. All threshold values are typically hard coded or initialized by some higher instance in the system. Mux setting registers are adjusted programmatically. Min/max tracking registers can be initialized by the host controller. The register map shown in Figure 18 gives an overview of those registers. Using all of them allows to increase the number of custom data bytes to 240 bytes.

To access this data the host commands an EEPROM RESTORE, reads all registers with custom data and initializes the registers afterwards to their desired value.

## REGISTER DESCRIPTION

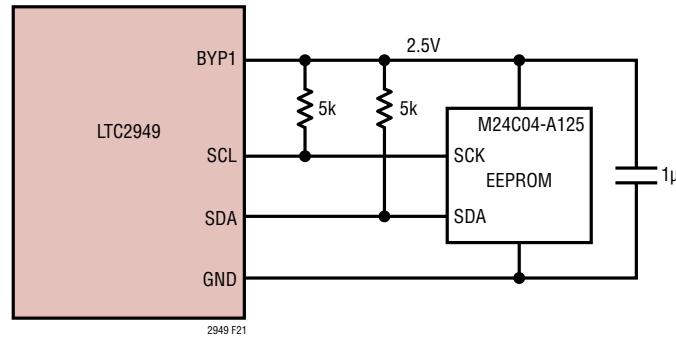


Figure 21. EEPROM Connection. Recommended 4k Bit Automotive Qualified EEPROM with Internal EEC: M24C04-A125 from STMicroelectronics or without Internal EEC: AT24C04C or 24AA04 from Microchip.

## APPLICATION INFORMATION

### TEMPERATURE MEASUREMENT

The LTC2949's high impedance inputs V1-V12 can be used to measure temperature by means of thermistors and a reference resistor as shown below.

When bits NTC1 or NTC2 in the ADC Configuration Register are set, LTC2949 reports the result of the corresponding CHAUX slot in slow high precision mode in temperature by comparing the resistance of a thermistor (NTC)  $R_{NTC}$  to a reference resistor and solving the Steinhart-Hart equation.

$$\frac{1}{T} = A + B \cdot \ln R_{NTC} + C \cdot (\ln R_{NTC})^3$$

The value of the reference resistor  $R_{REF}$  and the Steinhart-Hart coefficients (A, B, C) need to be stored in the NTC Configuration Registers. Steinhart-Hart coefficients are commonly specified parameters provided by thermistor manufacturers or can be deduced from provided resistance tables.

The following table shows the relevant registers from the NTC configuration register for the application shown in Figure 22.

As VREF is measured with the same ADC as V1-V12, imperfections of VREF and gain error of the ADC do not impact the temperature measurement accuracy.

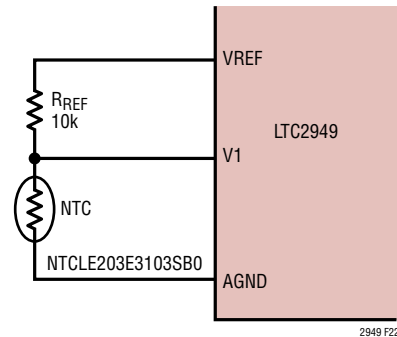


Figure 22. Connecting Thermistors

Table 75. NTC1 Values in NTC Configuration Register

| PARAMETER               | VALUE      | UNIT | ADDRESS | NAME        | VALUE    | FORMAT  |
|-------------------------|------------|------|---------|-------------|----------|---------|
| NTC1 reference resistor | 10k        | Ω    | p1.0xAA | RREF1[23:0] | 0x4C3880 | Float24 |
| NTC1 Coefficient A      | 1.1382e-3  |      | p1.0xD0 | NTC1A[23:0] | 0x352A5F | Float24 |
| NTC1 Coefficient B      | 2.3267e-4  |      | p1.0xD3 | NTC1B[23:0] | 0x32E7F1 | Float24 |
| NTC1 Coefficient C      | 0.93243e-7 |      | p1.0xD6 | NTC1C[23:0] | 0x279079 | Float24 |

## APPLICATION INFORMATION

### SENSE RESISTOR TEMPERATURE COMPENSATION

The LTC2949 can be configured to compensate the temperature dependency of the used current sense resistors up to 2nd order based on temperature measurements with external NTCs. The compensation is enabled by writing the temperature coefficients (TC, TC2) of the sense resistor and the reference temperature ( $T_0$ ) in the NTC configuration register. The LTC2949 will then compensate for the temperature induced deviation of the sense resistor from its nominal value  $R_0$  according to:

$$R_{\text{SENSE}} = R_0 \cdot [1 + TC \cdot (T - T_0) + TC2 \cdot (T - T_0)^2]$$

The temperature coefficient and reference temperature can be set for each sense resistor individually in the NTC configuration register. Table 76 shows the programmed coefficients for a copper sense resistor with a temperature coefficient of 3900ppm/K whose nominal value  $R_0$  was measured at 20°C.

If temperature compensation is enabled for one or both channels, the sense resistor connected to CH1 is compensated with the temperature of NTC1 measured during the first slot of CHAUX, while the sense resistor connected to CH2 is compensated with the temperature of NTC2 measured during the second slot of CHAUX. The multiplexer settings must be set such that the input pin connected to the corresponding NTC is selected during the respective slot. If CHAUX is changed to fast mode, the last NTC temperature measurements taken in Round Robin mode are used for temperature compensation.

The following linear equation system has to be solved to calculate A, B, C using three values,  $R_1(T_1)$ ,  $R_2(T_2)$ ,  $R_3(T_3)$  from a R versus T (in K) resistor table:

$$\begin{pmatrix} T_1^{-1} \\ T_2^{-1} \\ T_3^{-1} \end{pmatrix} = \begin{pmatrix} 1 & \ln R_1 & \ln^3 R_1 \\ 1 & \ln R_2 & \ln^3 R_2 \\ 1 & \ln R_3 & \ln^3 R_3 \end{pmatrix} \begin{pmatrix} A \\ B \\ C \end{pmatrix}$$

After solving the linear equation system, A, B, C can be expressed as:

$$l_1 = \ln R_1$$

$$l_2 = \ln R_2$$

$$l_3 = \ln R_3$$

$$m_2 = \frac{T_2^{-1} - T_1^{-1}}{l_2 - l_1}$$

$$m_3 = \frac{T_3^{-1} - T_1^{-1}}{l_3 - l_1}$$

$$C = \frac{m_3 - m_2}{l_3 + l_2 + l_1}$$

$$B = m_2 - C \cdot (l_1^2 + l_1 \cdot l_2 + l_2^2)$$

$$A = T_1^{-1} - (B + l_1^2 \cdot C) \cdot l_1$$

APPLICATION INFORMATION

For single shunt scenarios the temperature measured by one NTC with SLOT1 can be used to compensate both channels. See ADCCONF, bit NTCSLOT1.

isoSPI Setup

The LTC2949 allows the isoSPI link in each application to be optimized for power consumption or for noise immunity. The power and noise immunity of an isoSPI system is determined by the programmed  $I_B$  current. The  $I_B$  current can range from 100 $\mu$ A to 1mA. A low  $I_B$  reduces the isoSPI power consumption in the READY and ACTIVE states, while a high  $I_B$  increases the amplitude of the differential signal voltage  $V_A$  across the matching termination resistor,  $R_M$ .  $I_B$  is programmed by the sum of the  $R_{B1}$  and  $R_{B2}$  resistors connected between the  $I_{BIAS}$  pin and GND as shown in Figure 23. For most applications

setting  $I_B$  to 0.5mA is a good compromise between power consumption and noise immunity. Using this  $I_B$  setting with a 1:1 transformer and  $R_M = 100\Omega$ ,  $R_{B1}$  should be set to 2.8k and  $R_{B2}$  set to 1.2k. In a typical CAT5 twisted pair these settings will allow for communication up to 50m. For applications that require cables longer than 50m it is recommended to increase the  $I_B$  to 1mA. This compensates for the increased insertion loss in the cable and maintains high noise immunity. So when using cables over 50m and, again, using a transformer with a 1:1 turns ratio and  $R_M = 100\Omega$ ,  $R_{B1}$  would be 1.4k and  $R_{B2}$  would be 600 $\Omega$ . Other  $I_B$  settings can be used to reduce power consumption or increase the noise immunity as required by the application. In these cases when setting threshold voltage  $V_{ICMP}$  and choosing  $R_{B1}$  and  $R_{B2}$  resistor values the following rules should be used:

Table 76. Sense Resistor Temperature Coefficients

| PARAMETER                                           | VALUE  | UNIT | ADDRESS | NAME        | VALUE    | FORMAT           |
|-----------------------------------------------------|--------|------|---------|-------------|----------|------------------|
| Sense resistor 1 (RS1) temperature coefficient (TC) | 0.0039 | 1/K  | p1.0xD9 | RS1TC[23:0] | 0x36FF2E | Float24          |
| Reference temperature for TC compensation of RS1    | 20     | °C   | p1.0xDC | RS1T0[16:0] | 0x4340   | Float24, 2 bytes |

Note: For copper only the first order temperature coefficient is relevant and thus TC2=0.0 (default).

Table 77. Procedure to Enable Temperature Compensation of Sense Resistor

|        | WHAT                                        | HOW AND WHERE                          | ADDRESS       |
|--------|---------------------------------------------|----------------------------------------|---------------|
| Step 1 | Set LTC2949 to Standby Mode                 | CONT= 0 in OPCTRL                      | 0xF0          |
| Step 2 | Write NTC and $R_{SENSE}$ DATA              | NTC configuration Registers            | See Table 71. |
| Step 3 | Set AUX Slot to Temperature Mode            | NTCx = 1 in ADC Configuration Register | p1.0xDF       |
| Step 4 | Select MUX input channel with connected NTC | Mux Setting Registers                  | 0xEB-0xEE     |
| Step 5 | Update Configuration Registers              | ADJUP = 1 in OPCTRL                    | 0xF0          |
| Step 6 | Set LTC2949 to Continuous Mode              | CONT = 1 in OPCTRL                     | 0xF0          |

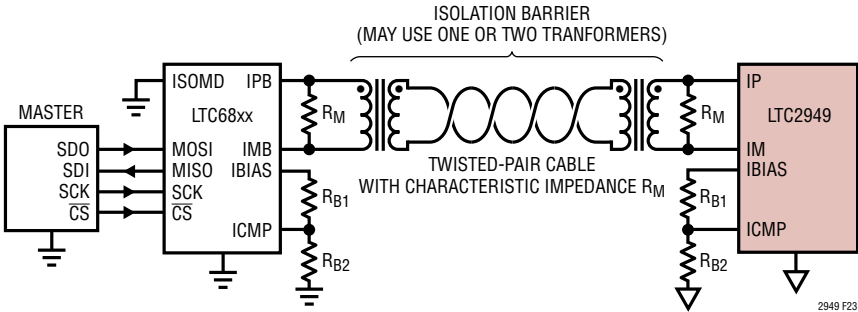


Figure 23. isoSPI Circuit

## APPLICATION INFORMATION

For cables under 50m:

$$I_B = 0.5\text{mA}$$

$$V_A = (20 \cdot I_B) \cdot (R_M/2)$$

$$V_{TCMP} = \frac{1}{2} \cdot V_A$$

$$V_{ICMP} = 2 \cdot V_{TCMP}$$

$$R_{B2} = V_{ICMP}/I_B$$

$$R_{B1} = (2/I_B) - R_{B2}$$

For cables over 50m:

$$I_B = 1\text{mA}$$

$$V_A = (20 \cdot I_B) \cdot (R_M/2)$$

$$V_{TCMP} = 1/4 \cdot V_A$$

$$V_{ICMP} = 2 \cdot V_{TCMP}$$

$$R_{B2} = V_{ICMP}/I_B$$

$$R_{B1} = (2/I_B) - R_{B2}$$

The maximum data rate of an isoSPI link is determined by the length of the cable used. For cables 10 meters or less the maximum 1MHz SPI clock frequency is possible. As the length of the cable increases the maximum possible SPI clock rate decreases. This is a result of the increased propagation delays through the cable creating possible timing violations. Figure 24 shows how the maximum data rate is reduced as the cable length increases when using a CAT 5 twisted pair. Cable delay affects three timing specifications,  $t_{CLK}$ ,  $t_6$  and  $t_7$ . In the Electrical Characteristics table, each is derated by 100ns to allow for 50ns of cable delay. For longer cables, the minimum timing parameters may be calculated as shown below:

$$t_{CLK}, t_6 \text{ and } t_7 > 0.9\mu\text{s} + 2 \cdot t_{CABLE}$$

### Transformer Selection Guide

As shown in Figure 23, a transformer or pair of transformers isolates the isoSPI signals between two isoSPI ports. The isoSPI signals have programmable pulse amplitudes up to  $1.6V_{P-P}$  and pulse widths of 50ns and 150ns. To be able to transmit these pulses with the necessary fidelity the system requires that the transformers have primary

inductances above 60 $\mu\text{H}$  and a 1:1 turns ratio. It is also necessary to use a transformer with less than 2.5 $\mu\text{H}$  of leakage inductance. In terms of pulse shape the primary inductance will mostly effect the pulse droop of the 50ns and 150ns pulses. If the primary inductance is too low, the pulse amplitude will begin to droop and decay over the pulse period. When the pulse droop is severe enough, the effective pulse width seen by the receiver will drop substantially, reducing noise margin. Some droop is acceptable as long as it is a relatively small percentage of the total pulse amplitude. The leakage inductance primarily affects the rise and fall times of the pulses. Slower rise and fall times will effectively reduce the pulse width. Pulse width is determined by the receiver as the time the signal is above the threshold set at the ICMP pin. Slow rise and fall times cut into the timing margins. Generally it is best to keep pulse edges as fast as possible. When evaluating transformers, it is also worth noting the parallel winding capacitance. While transformers have very good CMRR at low frequency, this rejection will degrade at higher frequencies, largely due to the winding to winding capacitance. When choosing a transformer, it is best to pick one with less parallel winding capacitance when possible.

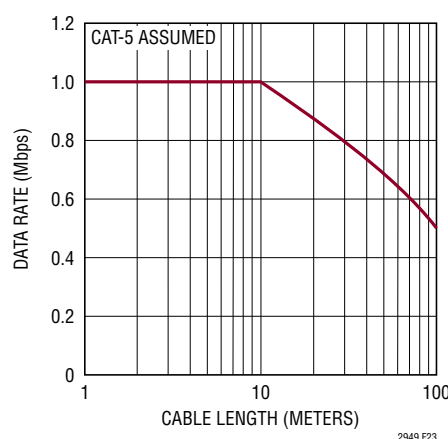


Figure 24. Data Rate vs Cable Length

## APPLICATION INFORMATION

When choosing a transformer, it is equally important to pick a part that has an adequate isolation rating for the application. The working voltage rating of a transformer is a key spec when selecting a part for an application. Interconnecting daisy-chain links, devices see <60V stress in typical applications and ordinary pulse and LAN type transformers will suffice. Multi-drop connections and connections to the LTC6820, in general, may need much higher working voltage ratings for good long-term reliability. Usually, matching the working voltage to the voltage of the entire battery stack is conservative. Unfortunately, transformer vendors will often only specify one-second HV testing, and this is not equal to the long-term (permanent) rating of the part. For example, according to most safety standards a 1.5kV rated transformer is expected to handle 230V continuously, and a 3kV device is capable of 1100V long-term, though manufacturers may not always certify to those levels (refer to actual vendor data for specifics). Usually, the higher voltage transformers are called high isolation or reinforced insulation types by the suppliers. Table 78 shows a list of transformers that have been evaluated in isoSPI links.

### EMC

For the best electromagnetic compatibility (EMC) performance, it is recommended to use one of the circuits in Figure 25 and Figure 26. The center tap of the transformer should be bypassed with a 10nF capacitor. The center tap capacitor will help attenuate common mode signals. Large center tap capacitors greater than 10nF should be avoided as they will prevent the isoSPI transmitters common mode voltage from settling. If a transformer without a center tap is used, the termination resistor should be split into two equal halves and connected in series across the IP and IM lines. The center of the two resistors should be bypassed with a capacitor as shown. To improve common mode

current rejection a common mode choke should also be placed in series with the IP and IM lines of the LTC2949. The common mode choke will both increase EMI immunity and reduce EMI emission. When choosing a common mode choke, the differential mode impedance should be 20Ω or less for signals 50MHz and below. Common mode chokes similar to what is used in Ethernet applications are recommended.

Layout of the isoSPI signal lines also plays a significant role in maximizing the immunity of a circuit. The following layout guidelines should be followed:

1. The transformer should be placed as close to the isoSPI cable connector as possible. The distance should be kept less than 2cm. The LTC2949 should be placed at least 1cm to 2cm away from the transformer to help isolate the IC from magnetic field coupling.
2. On the top component layer, no ground plane should be placed under the transformer, the isoSPI connector, or in between the transformer and the connector.
3. The isoSPI signal traces should be isolated from surrounding circuits and traces by ground metal or space. No traces should cross the isoSPI signal lines, unless separated by a ground plane on an inner layer.

The isoSPI drive currents are programmable and allow for a trade-off between power consumption and noise immunity. The noise immunity of the LTC2949 has been evaluated using a bulk current injection (BCI) test. The BCI test injects current into the twisted-pair lines at set levels over a frequency range of 1MHz to 400MHz. With the minimum  $I_B$  current, 100μA, the isoSPI serial link was capable of passing a 40mA BCI test with no bit errors. A 40mA BCI test level is sufficient for industrial applications. Automotive applications have a much higher BCI requirement so the LTC2949  $I_B$  is set to 1mA, the maximum power level. The isoSPI system is capable of passing a 200mA BCI test with no transmitted bit errors. The 200mA test level is typical for automotive requirements.

## APPLICATION INFORMATION

Table 78. Recommended Transformers

| SUPPLIER                               | PART NUMBER          | TEMP RANGE        | V <sub>WORKING</sub> | V <sub>HIPOT/60S</sub> | CT | CMC | H      | L      | W<br>(W/ LEADS) | PINS  | AEC-<br>Q200 |
|----------------------------------------|----------------------|-------------------|----------------------|------------------------|----|-----|--------|--------|-----------------|-------|--------------|
| <b>Recommended Dual Transformers</b>   |                      |                   |                      |                        |    |     |        |        |                 |       |              |
| Pulse                                  | HX1188FNL            | –40°C to 85°C     | 60V (est)            | 1.5kV <sub>RMS</sub>   | ●  | ●   | 6.0mm  | 12.7mm | 9.7mm           | 16SMT | –            |
| Pulse                                  | HX0068ANL            | –40°C to 85°C     | 60V (est)            | 1.5kV <sub>RMS</sub>   | ●  | ●   | 2.1mm  | 12.7mm | 9.7mm           | 16SMT | –            |
| Pulse                                  | HM2100NL             | –40°C to 105°C    | 1000V                | 4.3kVDC                | –  | ●   | 3.4mm  | 14.7mm | 14.9mm          | 10SMT | ●            |
| Pulse                                  | HM2112ZNL            | –40°C to 125°C    | 1000V                | 4.3kVDC                | ●  | ●   | 4.9mm  | 14.8mm | 14.7mm          | 12SMT | ●            |
| Sumida                                 | CLP178-C20114        | –40°C to 125°C    | 1000V (est)          | 3.75kV <sub>RMS</sub>  | ●  | ●   | 9mm    | 17.5mm | 15.1mm          | 12SMT | –            |
| Sumida                                 | CLP0612-C20115       |                   | 600V <sub>RMS</sub>  | 3.75kV <sub>RMS</sub>  | ●  | –   | 5.7mm  | 12.7mm | 9.4mm           | 16SMT | –            |
| Würth                                  | 7490140110           | –40°C to 85°C     | 250V <sub>RMS</sub>  | 4kV <sub>RMS</sub>     | ●  | ●   | 10.9mm | 24.6mm | 17.0mm          | 16SMT | –            |
| Würth                                  | 7490140111           | 0°C to 70°C       | 1000V (est)          | 4.5kV <sub>RMS</sub>   | ●  | –   | 8.4mm  | 17.1mm | 15.2mm          | 12SMT | –            |
| Würth                                  | 749014018            | 0°C to 70°C       | 250V <sub>RMS</sub>  | 4kV <sub>RMS</sub>     | ●  | ●   | 8.4mm  | 17.1mm | 15.2mm          | 12SMT | –            |
| Halo                                   | TG110-AE050N5LF      | –40°C to 85/125°C | 60V (est)            | 1.5kV <sub>RMS</sub>   | ●  | ●   | 6.4mm  | 12.7mm | 9.5mm           | 16SMT | ●            |
| <b>Recommended Single Transformers</b> |                      |                   |                      |                        |    |     |        |        |                 |       |              |
| Pulse                                  | PE-68386NL           | –40°C to 130°C    | 60V (est)            | 1.5kVDC                | –  | –   | 2.5mm  | 6.7mm  | 8.6mm           | 6SMT  | –            |
| Pulse                                  | HM2101NL             | –40°C to 105°C    | 1000V                | 4.3kVDC                | –  | ●   | 5.7mm  | 7.6mm  | 9.3mm           | 6SMT  | ●            |
| Pulse                                  | HM2113ZNL            | –40°C to 125°C    | 1600V                | 4.3kVDC                | ●  | ●   | 3.5mm  | 9mm    | 15.5mm          | 6SMT  | ●            |
| Würth                                  | 750340848            | –40°C to 105°C    | 250V                 | 3kV <sub>RMS</sub>     | –  | –   | 2.2mm  | 4.4mm  | 9.1mm           | 4SMT  | –            |
| Würth                                  | 750317011            | –40°C to 125°C    | 800V                 | 3kV <sub>RMS</sub>     | ●  | –   | 7.62mm | 9.14mm | 12.95mm         | 6SMT  | –            |
| Halo                                   | TGR04-6506V6LF       | –40°C to 125°C    | 300V                 | 3kV <sub>RMS</sub>     | ●  | –   | 10mm   | 9.5mm  | 12.1mm          | 6SMT  | –            |
| Halo                                   | TGR04-A6506NA6NL     | –40°C to 125°C    | 300V                 | 3kV <sub>RMS</sub>     | ●  | –   | 9.4mm  | 8.9mm  | 12.1mm          | 6SMT  | ●            |
| Halo                                   | TDR04-A550ALLF       | –40°C to 105°C    | 1000V                | 5kV <sub>RMS</sub>     | ●  | –   | 6.4mm  | 8.9mm  | 16.6mm          | 6TH   | ●            |
| TDK                                    | ALT4532V-201-T001    | –40°C to 105°C    | 60V (est)            | ~1kV                   | ●  | –   | 2.9mm  | 3.2mm  | 4.5mm           | 6SMT  | ●            |
| Sumida                                 | CEEH96BNP-LTC6804/11 | –40°C to 125°C    | 600V                 | 2.5kV <sub>RMS</sub>   | –  | –   | 7mm    | 9.2mm  | 12.0mm          | 4SMT  | –            |
| Sumida                                 | CEP99NP-LTC6804      | –40°C to 125°C    | 600V                 | 2.5kV <sub>RMS</sub>   | ●  | –   | 10mm   | 9.2mm  | 12.0mm          | 8SMT  | –            |
| Sumida                                 | ESMIT-4180/A         | –40°C to 105°C    | 250V <sub>RMS</sub>  | 3kV <sub>RMS</sub>     | –  | –   | 3.5mm  | 5.2mm  | 9.1mm           | 4SMT  | ●            |
| TDK                                    | VGT10/9EE-204S2P4    | –40°C to 125°C    | 250V (est)           | 2.8kV <sub>RMS</sub>   | ●  | –   | 10.6mm | 10.4mm | 12.7mm          | 8SMT  | –            |

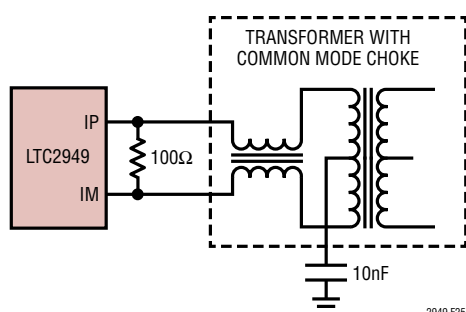


Figure 25. Recommended isoSPI Circuit for EMC

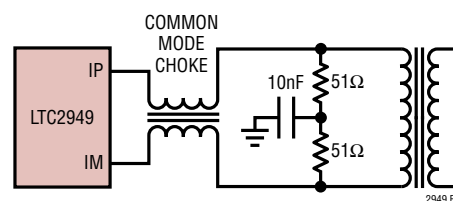


Figure 26. Recommended isoSPI Circuit for Best EMC Performance when Using a Transformer without Center Tap

Table 79. Recommended Common Mode Chokes

| MANUFACTURER | PART NUMBER   |
|--------------|---------------|
| TDK          | ACT45B-220-2P |
| Murata       | DLW43SH510XK2 |
| Würth        | 744232102     |

## APPLICATION INFORMATION

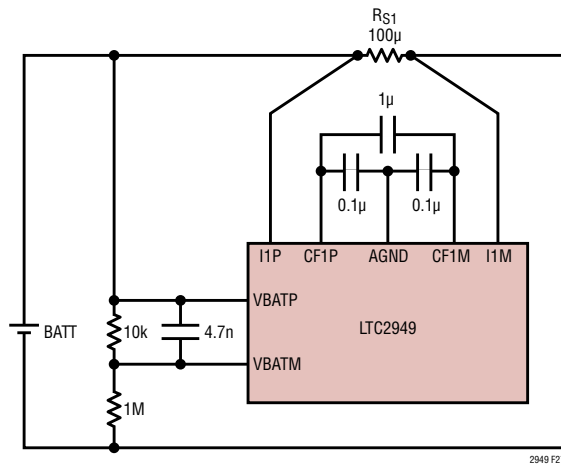


Figure 27. Input Filtering

## CURRENT AND VOLTAGE INPUT FILTERING

To ensure the full electrical performance of the ADCs for current, power and voltage, apply the input filtering circuitry as depicted in Figure 27 to pins CFP, CFM, VBATP and VBATM. These components ensure an optimized input filtering for noise reduction. Equal time constants at current and voltage inputs minimize errors in power measurement of transient signals due to different delays in both paths.

## Unused Input Pins V1-V12

Input pins V1-V12 can be left floating or connected to GND if not used. Still, it is not recommended to connect V8-V12 to GND as those pins can be driven high optionally when used as digital outputs.

Depending on the application and the configuration of LTC2949, it might be beneficial or sometimes even necessary to apply following external connections to inputs, which were unused.

1. Connect pin VREF to one of V1-V12
  - a. See last paragraph of section Fast Mode Configurations for effect of fast AUX measurement on internal slow AUX Round-Robin. Register VREF is not updated while performing fast AUX conversions.
  - b. The internal VREF measurement is altered while the current sources (see register FCURGPIOCTRL) are enabled. Connecting VREF to one Vx pin always measurement of the correct VREF pin voltage at any time.

- c. VREF can be used to bias resistive dividers to allow measurement of voltages below GND. In those scenarios the differential voltage between Vx and VREF must be measured which is only possible if VREF is connected to one of V1-V12 pins.
2. Connect divided supply voltage AVCC/DVCC (e.g. 10k between GND/Vx and 20k between Vx and AVCC/DVCC) to one of V1-V12
    - a. Same as 1.a. Register VCC is not updated while performing fast AUX conversions.
  3. Connect NTC to one of V1-V12
    - a. See section Temperature Measurement
  4. Connect pin VREF via an external 4k resistor to one of V1-V12
    - a. Allows to diagnose the internal current sources.
  5. Connect pins BVP1 and BVP2 to separate unused pins of V1-V12.
    - a. Allows to diagnose internal generated supply voltages additionally to built-in self-tests.

## High-Ohmic Resistive Dividers

Any high voltage to be measured by LTC2949 must be divided down and optionally biased via VREF to move it into the LTC2949's supply voltage rails  $\pm 100\text{mV}$  and into the ADC's differential input voltage range ( $\pm 4.8\text{V}$ ). Typically, several resistors are connected in series, to minimize the voltage drop and power dissipation of individual resistors (Figure 28). LTC2949 Operation State Diagram shows a typical schematic, as an example the signal is measured via V1 by the AUX ADC. The measurement is performed similarly via the BAT inputs (VBATP, VBATM) by the AUX or the Power ADCs (P1/P2 as voltage).

All voltage inputs of LTC2949 are buffered. The differential input impedance during measurements is guaranteed to be  $>50\text{Meg}$ . For typical resistive dividers, like those shown in the typical application, the effect of this equivalent  $>50\text{Meg}$  resistor is negligible. The error can be calculated as following:

$$\text{Nominal gain factor: } g = R_{\text{low}} / (R_{\text{low}} + R_{\text{high}})$$

## APPLICATION INFORMATION

Effective low side resistor:  $R_{lowd} = R_{low} \cdot R_d / (R_{low} + R_d)$ ,  $R_d = 50e5$

Effective gain factor:  $g_d = R_{lowd} / (R_{lowd} + R_{high})$

Example values:  $R_{low} = 30^3$ ,  $R_{high} = 5 \cdot 1.3e6$

Gain factor error:  $err = g_d/g - 1 = -0.06\%$

The differential input impedance during measurements is nonlinear, it increases with decreasing input signal and it may also change over temperature. For this reason, it can be calibrated only partially during a post-production board test procedure. Still, it's guaranteed to be >50Meg over the full-scale input range and the whole operating temperature range and thus the error calculated above gives the worst-case error.

The high voltage is calculated from the ADC measurement the following way:

Divider connected to GND:  $V_{HVa} = V_{ADC}/g$

Divider connected to VREF:  $V_{HVb} = V_{ADC}/g + VREF$

As any resistive divider is affected by static tolerances, it can be calibrated by applying a known input signal and calculating  $g_{real}$  from the ADC measurement. LTC2949 can compensate for this error by writing the gain correction factor  $GC = g_{nominal}/g_{real}$  to one of the related gain correction registers (BATGC, MUX1GC-MUX4GC). The

optional external EEPROM can be used as a nonvolatile storage for those calibration factors.

LTC2949's gain correction registers are not limited to values around 1.0, for example it is possible to write a value of 10.0 and this factor would be applied just as any other. Still, there is a limitation by the size of the result registers which is 16-bit (including sign) for any AUX-ADC measurement like BAT, SLOT1/2 and the fast AUX measurement results. This leads to an absolute maximum register value of roughly 12.3V ( $375\mu V \cdot [2^{15}-1]$ ). To avoid clipping or overflowing of the results, it is always recommended to use gain correction factors that correct the deviation from nominal factors (e.g. deviation from nominal resistor divider ratio) like in the example above. The host controller software then holds the hard-coded nominal factor (e.g. 6.53Meg/30k) and LTC2949 is applying the fine-trim based on the values that were stored into the external EEPROM during board calibration.

## POWERING THE LTC2949

The LTC2949 requires a single supply voltage of 4.5 to 14V. The maximum supply current is 20mA when active and 120μA when sleeping. If isoSPI is selected up to 7mA are required additionally during communication. Any current that is necessary to drive circuits connected to the GPIO pins must also be considered when selecting and designing a suitable power supply.

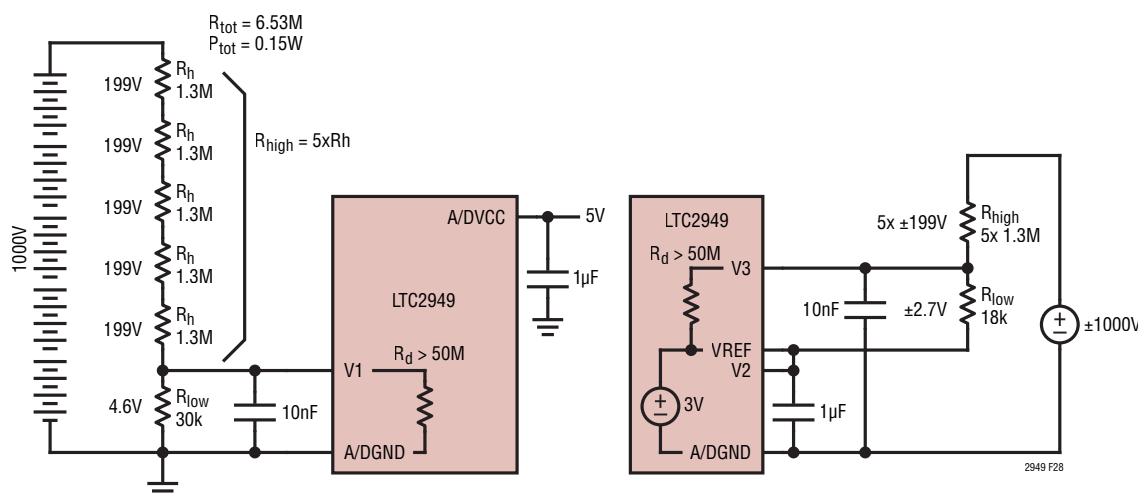


**Figure 28. Left: High-Ohmic Resistive Divider for Measuring 1000V Battery Voltage Via the AUX ADC Input V1. Right: Resistive Divider Connected to VREF Allows to Measure ±1000V.**

## APPLICATION INFORMATION

### Non-Isolated Supply

LTC provides a broad spectrum of non-isolated power supply solutions including LDOs, switched mode power supplies and  $\mu$ Moduleregulators. As the LTC2949 is mainly targeting high voltage battery applications the LT8315 can be considered. Using the LT8315 it is possible to supply the LTC2949 directly out of a high voltage battery of up to 560V as shown in Figure 29.

### Isolated supply

Most high voltage battery applications where the LTC2949 cannot be supplied directly out of the battery require an isolated power supply. A simple DC/DC converter is shown in Figure 30 using Linear Technology's LT3999 DC/DC converter and a high isolation-rated transformer.

The LT830X family of flyback converters with a suitable transformer is also a possible choice.

| PART NUMBER | V <sub>IN</sub> RANGE | POWER SWITCH | MAX. P <sub>OUT</sub> | PACKAGE |
|-------------|-----------------------|--------------|-----------------------|---------|
| LT8300      | 6V to 100V            | 0.26A/150V   | 2W                    | SOT23-5 |
| LT8303      | 5.5V to 100V          | 0.45A/150V   | 5W                    | SOT23-5 |
| LT8301      | 2.7V to 42V           | 1.2A/65V     | 6W                    | SOT23-5 |
| LT8302      | 2.8V to 42V           | 3.6A/65V     | 18W                   | SO-8E   |
| LT8304/-1   | 3V to 100V            | 2A/150V      | 24W                   | SO-8E   |

Minimum load requirement of the flyback converters must be considered which is typically much higher than the sleep current of the LTC2949. To prevent the output voltage from rising above LTC2949's operating ratings a 12V Zener diode (e.g. NXP: BZX384-B12,115) should be placed.

Transformer specification and design is possibly the most critical part of successfully applying the above mentioned DC/DC converters. Data sheets of the suggested parts give detailed information about critical parameters like saturation current, inductance, isolation voltage rating and creepage distance.

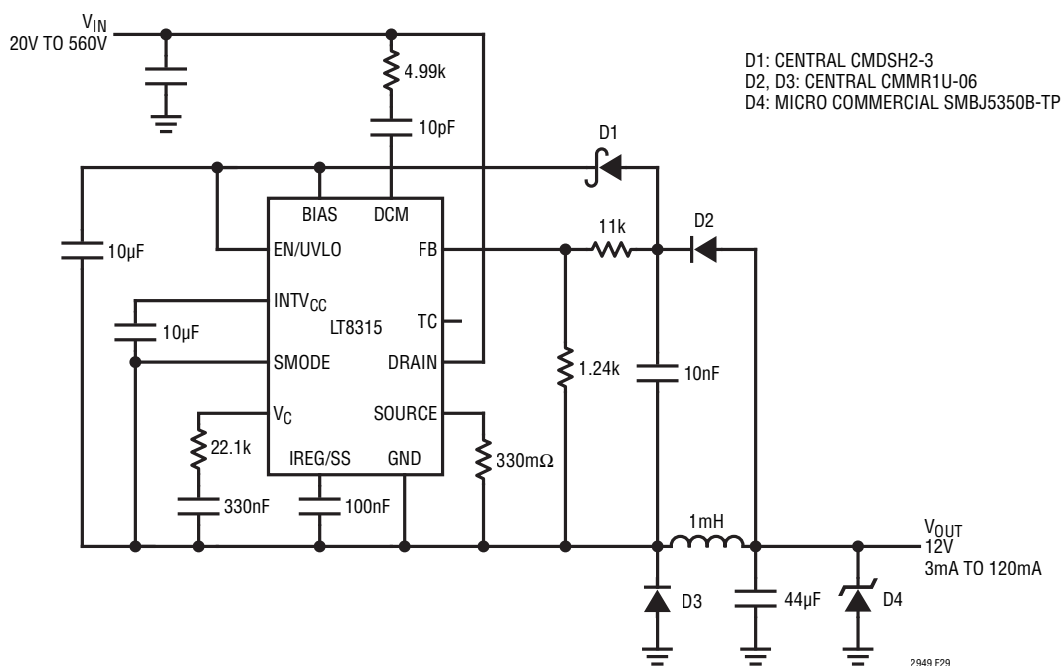


Figure 29. Nonisolated Supply Generation

## APPLICATION INFORMATION

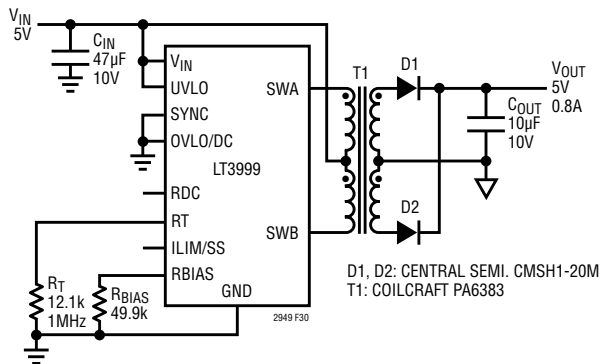


Figure 30. Isolated Supply Generation with Push-Pull Transformer

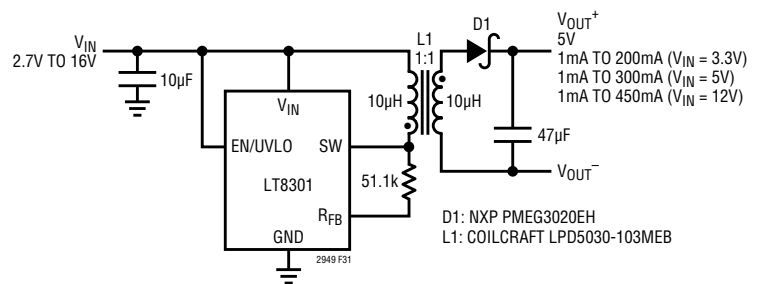


Figure 31. Isolated Supply Generation with Flyback Converter

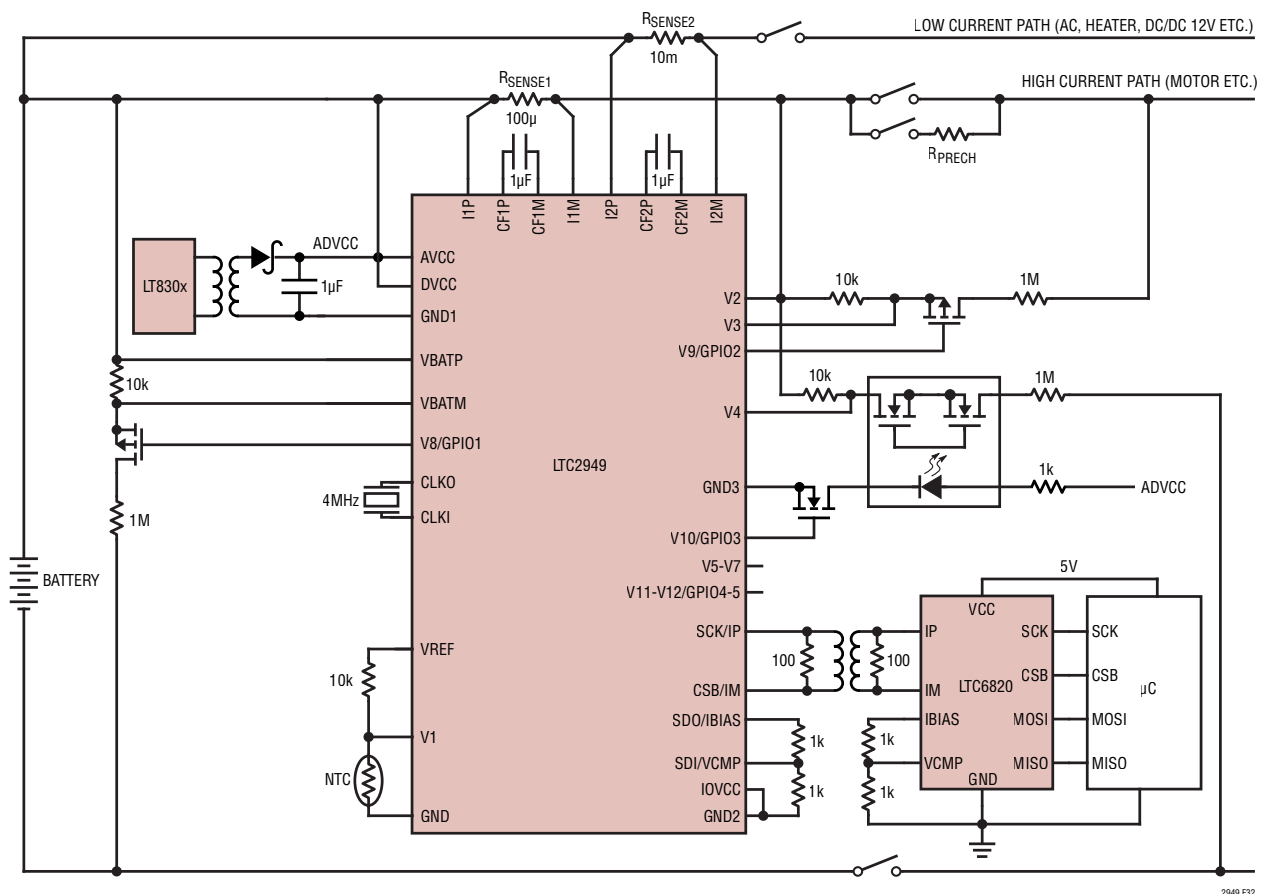
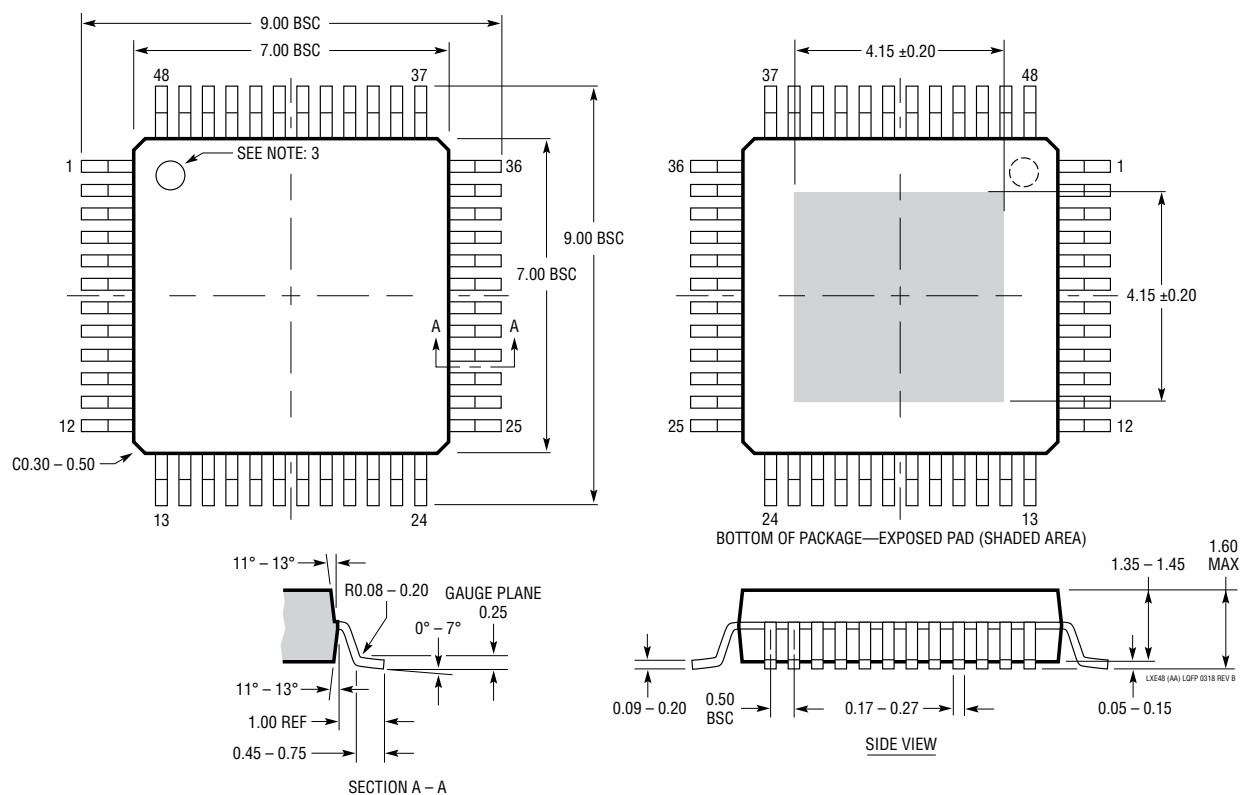


Figure 32. Battery Monitoring with High Side Current Sensing Over Two Sense Resistors, Battery Voltage Measurement, Temperature Measurement and Pre-Charge Voltage Measurement Using Isolated Supply and Isolated NMOS Gate Drive as Well as PhotoMos Relay.

# PACKAGE DESCRIPTION

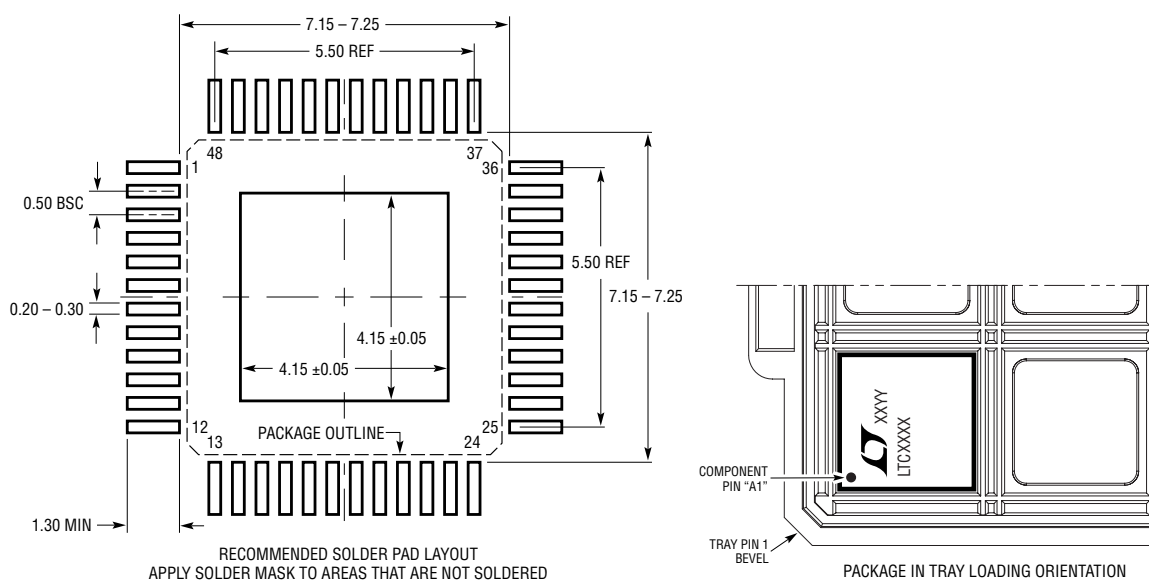
## LXE Package 48-Lead Plastic Exposed Pad LQFP (7mm × 7mm) (Reference LTC DWG #05-08-1927 Rev B) Exposed Pad Variation AA



### NOTE:

1. DIMENSIONS ARE IN MILLIMETERS
2. DIMENSIONS OF PACKAGE DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.25mm (10 MILS) BETWEEN THE LEADS AND ON ANY SIDE OF EXPOSED PAD, MAX 0.50mm (20 MILS) AT CORNER OF EXPOSED PAD, IF PRESENT

3. PIN-1 INDENTIFIER IS A MOLDED INDENTATION
4. DRAWING IS NOT TO SCALE



## REVISION HISTORY

| REV | DATE  | DESCRIPTION                                                                               | PAGE NUMBER |
|-----|-------|-------------------------------------------------------------------------------------------|-------------|
| A   | 11/20 | Changed GPOx to GPIOx.                                                                    | Throughout  |
|     |       | Moved Temperature Measurement into sub-section Application Information.                   | 2           |
|     |       | Adapted Abs Max of SDO.                                                                   | 3           |
|     |       | Changed TYP value of $V_{BYP2}$ in EC-table.                                              | 4           |
|     |       | Changed Input Leakage current for CFPx from 40nA to 60nA.                                 | 4           |
|     |       | Adapted $I_{CC}$ Average Supply Current in EC table and in text Modes of Operation.       | 4,15        |
|     |       | Changed Input Leakage current for Voltage Measurement by Power ADC from 10nA to 60nA.     | 5           |
|     |       | Symbol names corrections in EC table.                                                     | 6           |
|     |       | Changed Input Leakage current for Voltage Measurement by AUXILIARY ADC from 10nA to 60nA. | 6           |
|     |       | EC-Table External Clock Frequency adapted MIN value.                                      | 7           |
|     |       | Adapted $t_{IDLE}$ MAX value.                                                             | 8           |
|     |       | Adapted $V_A$ Transmitter Pulse Amplitude MAX value.                                      | 8           |
|     |       | Corrected symbol $A_{TCMP}$ in $V_{ICMP}$ .                                               | 8           |
|     |       | Corrected symbol $V_{ICM}$ in $A_{TCMP}$ wrong.                                           | 8           |
|     |       | Corrected Pin 6 missing in list of DNC-pins.                                              | 12          |
|     |       | Core states vs fast conversions: Update of Figure 1.                                      | 15          |
|     |       | Corrected wrong Figure 29.                                                                | 16          |
|     |       | Corrected wrong minimum frequency of 200kHz.                                              | 20          |
|     |       | Corrected missing unit at first column of Table 3.                                        | 21          |
|     |       | ISORPT still in register map table: Removed.                                              | 41          |
|     |       | Register name typos: Corrected Register Map.                                              | 41          |
|     |       | ADC limit behavior: Added sentence after Table 28.                                        | 48          |
|     |       | Register name typos: Corrected Tables 71 and 72.                                          | 65, 66      |
|     |       | Adapted Description of MUX[1-4]GC in Table 73.                                            | 66          |
|     |       | Corrected Wrong Figure 1.                                                                 | 74          |
|     |       | MOSFET polarities: Update of several transistor symbols.                                  | 77, 80      |



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